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The selective low cost gas sensor based on functionalized graphene

Heechul Woo

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THESE DE DOCTORAT
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L'UNIVERSITE PARIS-SACLAY
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"ÉCOLE POLYTECHNIQUE"

ÉCOLE DOCTORALE N°573

Interfaces : approches interdisciplinaires, fondements, applications et innovation

Spécialité de doctorat : Physique

Par

M Heechul Woo

Un capteur de gaz sélectif et bas coût par l'emploi de graphène fonctionnalisé

Thèse présentée et soutenue à Palaiseau, le 29 septembre 2016 :

Composition du Jury :

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List of Abbreviation

Acronym	
VOCs	volatile organic compounds
CG	chromatography
MS	mass spectrometry
CNTs	carbon nanotubes
ITO	indium tin oxide
UV	ultraviolet
LED	light emitting diode
TFT	thin film transistor
FET	field-effect transistor
SWIR	short-wave infrared
NIR	near-infrared
MIR	mid-infrared
FIR	far-infrared
THz	terahertz
SWF	surface work function
SAW	surface acoustic wave
QCM	quartz crystal microbalance
MEMS	micro electromechanical systems
BAW	bulk acoustic wave
CVD	chemical vapor deposition
GO	graphene oxide
RGO	reduced graphene oxide
PBSA	pyrene butanoic acid succidymidyl ester
SEM	scanning electron microscopy
TEM	transmission electron microscopy
AFM	atomic force microscopy
PES	photoemission spectroscopy

Acronym	
HOPG	Highly Oriented Pyrolytic Graphite
GICs	graphite intercalate compounds
SiC	silicon carbide
FETs	field effect transistors
CVD	chemical vapor deposition
SLG	single layer graphene
PECVD	plasma enhanced CVD
DI	deionized
UPS	ultraviolet photoemission
ARUPS	angle-resolved investigation of valence band states
XPS	X-ray photoemission spectroscopy
PMMA	polymethyl methacrylate
UHV	ultra high vacuum
IPA	isopropyl alcohol
MLG	multi-layer graphene
SDG	single and double layer graphene
MLG	multi-layer graphene
PR	photo-resist
I_d	drain current
RH	relative humidity
AES	Auger electron spectroscopy
EELS	electron energy loss spectrum
ECL	electrogenerated chemiluminescence
GO	graphene oxide
ICMMO	Institut de Chimie Moléculaire et des Matériaux d'Orsay
MLCT	Metal to Ligand Charge Transfer

Résumé en Français

Les progrès récents dans les nanomatériaux présentent un fort potentiel pour la réalisation de capteurs de gaz avec de nombreux avantages tels que: la grande sensibilité de détection de molécule unique, le faible coût et la faible consommation d'énergie. Le graphène, isolé en 2004, est l'un des meilleurs candidats prometteurs pour le développement de futurs nanocapteurs en raison de sa structure à deux dimensions, sa conductivité élevée et sa grande surface spécifique. Chaque atome de la monocouche de graphène peut être considéré comme un atome de surface, capable d'interagir même avec une seule molécule de l'espèce gazeuse ou de vapeur cible, ce qui conduit finalement à un capteur ultrasensible.

Dans cette thèse, un capteur résistif à base de graphène fonctionnalisés a été fabriqué. Le dispositif est basé sur le graphène monocouche sur substrat SiO_2 fonctionnalisé avec Ru complexes(II). Pour comprendre la réponse intrinsèque du film de graphène, un dispositif non fonctionnalisé est d'abord étudié. La réponse du dispositif est sensible à l'environnement de mesure telles que la pression, l'humidité relative et la lumière. Une fois la réponse intrinsèque de l'appareil a été étudié, les dispositifs basés sur le graphène fonctionnalisés ont été fabriqués pour mieux comprendre l'effet de la fonctionnalisation. Deux configurations différentes ont été utilisées; le dispositif fonctionnalisé avec des complexes après le dépôt des électrodes et le dispositif fabriqué en utilisant la surface pré-fonctionnalisé graphène. La réponse de dispositif sous la lumière a été amélioré ou inversé en fonction de sa configuration. Pour élucider ces réponses, les mécanismes du transfert de charge entre les complexes et le dispositif ont été proposées.

Plusieurs types de films de graphène ont été préparés et caractérisés. En LPICM, le graphène est directement synthétisé sur les substrats isolants en utilisant le système de PECVD. Graphène synthétisés par CVD et transférées à SiO_2 sont fournis par Thales R & T tandis que le graphène épitaxiale sur SiC est fourni par LPN. Graphène commercial synthétisé par CVD est également acheté. La plupart des performances des dispositifs à base de graphène dépendent fortement de ses conditions de surface. Afin de minimiser les caractéristiques inattendues provenant de différentes conditions de surface, le graphène monocouche sur substrat SiO_2 est finalement choisi en tant que matériau principal utilisé dans la fabrication du dispositif.

La deuxième étape de la fabrication du dispositif est le dépôt des électrodes sur la surface de graphène. Trois approches différentes ont été explorées; jet d'encre d'impression, photo-lithographie et évaporation. En raison de sa complexité et de contaminations possibles à travers le processus, photo-lithographie est exclue. L'impression par jet d'encre promet un processus simple à faible coût, mais le choix limité dans les métaux ne sont pas favorables pour la fabrication de dispositif. L'évaporation de métal est principalement utilisé comme une méthode de dépôt des électrodes dans ce travail. Avec un masque perforé simple, Ni, Co, Cr / Au, Ni / Au et du Ti / Au électrodes ont été déposés avec succès sur la surface de graphène préparée. L'optimisation des électrodes de dépôt peut être une question intéressante en termes de fabrication du dispositif. Par exemple, la forme et la taille des électrodes et le choix du métal sont des options possibles pour optimiser. Bien que CVD graphène promet la grande surface pour la production de masse de dispositifs, il est polycristallin dans la nature et donc des joints de grains perturbent le transport de charge. En outre, des contaminations de surface à travers le processus sont également préjudiciables au transport de charge du film de graphène. Dans le présent travail, pour faire une moyenne sur ce type de transport limitée défavorable de charge, les électrodes avec 100 μm qui dépasse la taille du grain général de quelques micromètres sont réalisées.

La réponse du dispositif est caractérisé en mesurant la résistance du dispositif. Le concept de la mesure à quatre points est développé pour tenir compte de la forme des électrodes de dispositif et de caractériser le dispositif de façon plus précise. La résistance du dispositif est contrôlée en fonction du temps pour que les changements d'état externes peuvent être directement détectés et interprétés. La réponse du dispositif est simplement exprimé sous la forme des variations de la résistance du dispositif, $\Delta R/R_0$.

La réponse intrinsèque du dispositif est étudié. La réponse du dispositif change lors de l'adsorption / désorption de molécules d'eau et d'oxygène. Désorption de ces molécules sous vide (10^{-5} mbar) a causé augmentation de plus de 6% en réponse. Ceci est dû à la dé-dopage du film de graphène résultant de l'augmentation de la résistance du dispositif. Désorption des molécules d'eau et d'oxygène peut être en outre accélérée sous l'illumination de la lumière bleue 455 nm avec une intensité de 4 mW/cm^2 . Dans ce cas, la réponse du dispositif augmente jusqu'à 40%. Étant donné que les résultats montrent que

l'adsorption/désorption de molécules d'eau et d'oxygène provoquent des variations sensibles de réponse du dispositif, on peut facilement penser que les changements de réponse de l'appareil lors de la variation relative du niveau d'humidité. A cause du renforcement du dopage par adsorption des molécules d'eau, la réponse du dispositif diminue à mesure que le niveau d'humidité augmente. Cependant, la réponse d'humidité inversée après le recuit sous vide du dispositif à 150 °C pendant 90 minutes. Sur la base des résultats des diverses techniques de PES les mécanismes responsables de deux réponses d'humidité différentes sont proposées. L'adsorption des molécules d'eau sur la surface de graphène et les liaisons hydrogène entre les molécules d'eau et les groupes fonctionnels restants sur le film de graphène sont deux facteurs en compétition responsables de l'élucidation du mécanisme. Les études sur la réponse intrinsèque du dispositif fournissent une compréhension préliminaire pour un capteur de gaz par l'emploi de graphène. Il convient de noter que les effets de l'air ambiant doivent être pris en compte avant de caractériser le comportement de détection de gaz.

Le capteur résistif sur la base du film de graphène fonctionnalisés avec des $[\text{Ru}^{\text{II}}\text{-Pyr}]^{2+}$ complexe de manière non covalente a été fabriquée. La fonctionnalisation non covalente est appliquée afin d'éviter de modifier les structures électroniques indigènes et de préserver les propriétés intrinsèques du graphène. La réponse du dispositif à la lumière (455 nm) améliorée et rapide a été obtenue qui n'est pas observables avec un dispositif non-fonctionnalisé. Les électrons transférés des Ru(II) complexes excités aux film de graphène sous la lumière ont amélioré la réponse du dispositif tandis que la photo-désorption de molécules d'eau et d'oxygène adsorbé sur la surface est responsable d'une augmentation lente et globale de la réponse.

L'inversion de la photoréponse a été observée avec un dispositif à double interface qui est fabriqué en déposant quatre électrodes identiques à la surface de graphène pré-fonctionnalisée. La première interface est entre la couche d'adhérence de l'électrode métallique et le Ru(II) complexe tandis que la seconde interface est entre le Ru(II) complexe et le graphène. Le mécanisme proposé responsable de l'inversion de la réponse est basée sur les variations de l'orientation des flux de transfert de charges. Au début, les électrons sont transférés de Ru(II) complexes excités à graphène alors qu'ils se sont rendus à vers la couche

oxydée d'adhérence après la mesure continue et répété sous la lumière.

Pour conclure, les approches théoriques et expérimentales et les résultats obtenus au cours de cette thèse ouvrent un moyen de comprendre et de fabriquer le futur captuer de gaz par l'emploi de graphène fonctionnalisé de façon non covalente.

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Chapter I.Introduction

1.1 Overview

The modern advanced technology and the global development of industrial activities has been accompanied by a variety of serious environmental problems. One example is the release of various chemical pollutants such as NO_x , SO_x , CO_x and volatile organic compounds (VOCs) into the atmosphere caused from various manufacturing industries and fossil fuel consumption of private sectors resulting in global environmental air pollution.

Air pollution can cause severe problems related to human health and environment. It can simply cause, for example, a disease like asthma. Asthma is a disease affecting the airways that carry air to and from the lungs. It is estimated that the total cost of asthma in Europe is 19.3 billion euros per annum [1]. Another example of the consequence of air pollution is acid rain. Any industrial and private activities resulting in the emissions of nitric and (NO_x) sulfuric acids (SO_x) are responsible for acid rain. It usually erodes buildings and affects human health through the contamination of water and harmed vegetation [2].

In addition to air pollution, the release of combustible gases such as methane, ethane, butane, hydrogen and acetylene can also constitute significant risks in terms of possible explosions of plants [3,4]. This sort of industrial accident not only leaves industrial damages but also threatens civil security.

To minimize the above stated damages, the development of new sensing platforms and technologies to be used in real world for detecting and quantifying environmental pollution, especially toxic and combustible gases are required [5]. Optical spectroscopy and gas chromatography/mass spectrometry (CG/MS) are well-known analytic instruments that have been widely used for air pollutant measurements. Although these instruments can give a precise analysis, they are time-consuming, expensive, and can seldom be used in real-time in the field. Gas sensors that are compact, robust, with versatile applications and a low cost are needed. To meet this demand, considerable research into new sensors is underway, including efforts to enhance the performance of traditional devices, such as gas sensors based on semiconductor (Si) structures [6,7]. Numerous materials have been reported to be usable as semiconductor sensors including both single- (e.g., ZnO , SnO_2 , WO_3 , TiO_2 and Fe_2O_3) and

multi-component oxides (BiFeO_3 , MgAl_2O_4 , SrTiO_3 , and $\text{Sr}_{1-y}\text{Ca}_y\text{FeO}_{3-x}$) [8]. Such devices were applied to detect hydrogen [6,7], oxygen [9,10], carbon monoxide [9,10], hydrogen sulfide [11], or as active element of smoke detectors [12]. However, this type of sensors are generally limited by their high operating temperature (150-600 °C).

Recent advances in nanomaterials provided a strong potential to create a gas sensor with many advantages including a very high sensitivity down to single molecule detection, low cost, and low power consumption. This is well reflected by the fact that nanosensor arrays are already under development by giant firms such as Dow Corning, Samsung, Boeing, Lockheed Martin, IBM, and Agilent. Among nanomaterials, graphene that was first isolated in 2004 [13], is one of the best promising candidate for the future development of nanosensors applications because of its atom-thick, two-dimensional structures, high conductivity, and large specific surface areas [14-18]. Every atom of a monolayer graphene can be considered as a surface atom, capable of interacting even with a single molecule of the target gas or vapor species, which eventually results in an ultrasensitive sensor response. The potential advantages of graphene based sensor, in short, are that it can be ultra-compact, effective at room temperature, characterized by low-power consumption, low cost, high sensitivity, selectivity and with a very low response and recovery time.

However, despite its great potential abilities as a sensing material, graphene still face some difficulties to be overcome for development of its practical use in sensing applications such as large area homogeneous production, contacting and devices integration, selective sensing mechanisms and so on. Since its discovery, there have been many efforts to improve its quality and to synthesize large area homogeneous layer [77,81,90] and more, recently, there are also many trials to functionalize graphene with various elements to improve its sensitivity, specificity, solubility, loading capacity, etc [97-104]. Keeping step with this tendency, this thesis tries to further develop the graphene based gas sensor by non-covalent functionalization of its surface. The main purpose of functionalizing the surface of graphene is to improve its specificity for selective sensing of the device. We have tried to reach this objective by exploring functionalization of graphene via an organometallic complex. Such approach can allow (via appropriate choice of the functionalizing complex) to each type of gas to interact in a specific way with each metal, changing in a specific way the graphene

resistivity thus acting as fingerprinting for identifying the targeted gases.

The following chapters will describe the development of our graphene based gas sensor. In Chapter 1, after this overview, we review the fundamental properties and various applications of graphene. The preparation methods of graphene are then stated in Chapter 2 followed by the introduction of various graphene layer characterization techniques. In Chapter 3, graphene layers used in our experiments are introduced with their preparation and characterization. Chapter 4 explains the theoretical backgrounds of the electrical characterization of our device in details with obtained experimental results. Chapter 5 describes the functionalization methods utilized in our experiment and the experimental results obtained from functionalized graphene based device. The conclusion summarizes this thesis and give an outlook for graphene based sensor.

1.2 Graphene: Carbon allotropes, Properties and Applications

1.2.1 Carbon Allotropes

Graphite, whose name stems from the Greek word “graphein” meaning to draw or write, is now losing his authority in regard of writing and documentation. Times have changed and the manner of writing and keeping documents has been changed as well. Today, it seems even more natural to type a letter looking at the computer monitor rather than to write it traditionally on the paper holding a pencil. On the other hand, given their exceptional physical and electrical properties, graphene and carbon nanotubes (CNTs) have been trying to take back so-called carbon allotropes’ authority in various scientific fields in recent years.

Carbon exists in several forms called allotropes and diamond is one of them with a very strong crystal lattice. Graphite is another well-known carbon allotrope in which the graphene layers are stacked to form 3D structure. In 1985, another allotrope called fullerenes(C_{60}) was discovered by Kroto et al [19]. Its structural closed ball shape guides us to the 0-dimensional electronics. In 1991, CNTs were observed by Iijima’s group [20]. As its name suggests, CNTs are made of rolled up graphene layers forming 1-dimensional tube structure. The individual graphene layer, a 2-dimensional flat layer of carbon atoms highly packed into honeycomb lattice and is a building block of the other allotropes as shown in the (Figure 1.1.), was first isolated by Manchester group [13] in 2004.

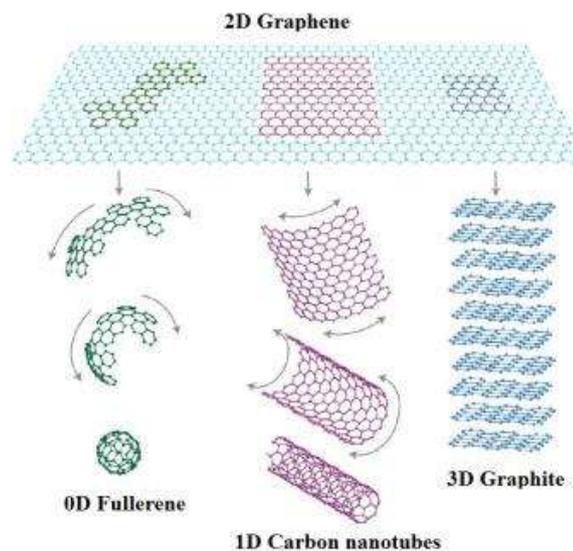


Figure 1.1. Graphene as a building blocks for graphitic materials.

1.2.2 Graphene properties

Since its discovery, graphene has been an appealing and attractive material for many researchers due to its exceptional properties. It is optically transparent (~97.7% transparency for visible light) [21], mechanically robust (Young's modulus of 1.0TPa and stiffness of 130 GPa) [22] and it has high thermal conductivity (~6,000 W/mK) [22] as well. The attractiveness becomes even amplified when it comes to its excellent electrical properties. Theoretically, it has extremely high charge mobility (~200,000 cm²/Vs) at room temperature which is about 200 times higher than that of Si. A very low resistivity (10⁻⁶ Ωcm), even less than that of silver, was observed for the suspended graphene as well [23]. It can also carry high current density up to 3x10⁸ A/cm² [24]. The origin of such unique properties of graphene will be explained by understanding its electronic band structure.

1.2.2.1 Electronic band structure of graphene

As its atomic number on the periodic table implies, carbon has 6 electrons. Then the ground-state electron configuration of carbon atom can be represented as $1s^2 2s^2 2p^2$ where 2 electrons are filling the inner shell while the other 4 are occupying outer shell. The combination of one $2s$ atomic orbital and two $2p$ atomic orbitals forms three equivalent sp^2 hybrid orbitals and carbon atoms use this sp^2 hybrid orbitals to form covalent bonds with each other when they are constructing graphitic materials like graphite, graphene and CNTs (Figure 1.2.). Three sp^2 hybrid orbitals lie in a plane and the angle between them is 120° while the third $2p$ atomic orbital consists of two lobes lying perpendicular to that plane.

In graphene, the overlap of these sp^2 hybrid orbitals in plane forms the sigma(σ) bond between the carbons atoms leading to the honeycomb lattice formation while remaining $2p$ orbitals on adjacent carbon atoms perpendicular to the plane overlap to form delocalized pi(π) bond. Since they are much closer to the Fermi surface than σ electrons, π electrons are responsible for charge carrier transport of graphene and determine the electronic properties of graphene at low energy.

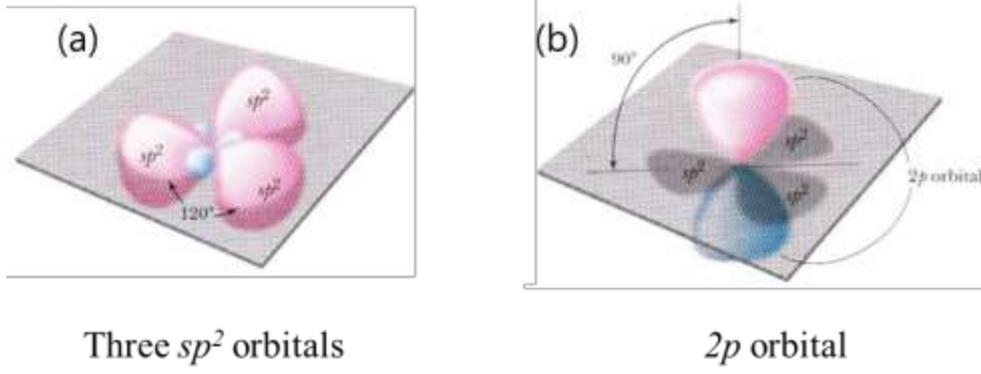


Figure 1.2. (a) Hybridized three sp^2 orbitals for a carbon atom and (b) an unhybridized $2p$ orbital

Figure 1.3. shows the typical honeycomb lattice of graphene with unit vectors in real space and the reciprocal lattice space. The distance between two nearest carbon atoms a_{cc} is estimated to be 0.142 nm [25]. As shown in the Figure 1.3.(a), the honeycomb lattice in real space can be expressed with two sub lattices A and B of the triangular Bravais lattices [26]. Based on the Figure 1.3.(a), the unit cell vectors \mathbf{a}_1 and \mathbf{a}_2 can be expressed as

$$\mathbf{a}_1 = \left(\frac{3}{2}a_{cc}, \frac{\sqrt{3}}{2}a_{cc} \right), \quad \mathbf{a}_2 = \left(\frac{3}{2}a_{cc}, -\frac{\sqrt{3}}{2}a_{cc} \right) \quad (1)$$

where $a_{cc} = 0.142$ nm is the distance between two nearest carbon atoms [25].

Corresponding reciprocal lattice vectors \mathbf{b}_1 and \mathbf{b}_2 can then be express as

$$\mathbf{b}_1 = \left(\frac{2\pi}{3a_{cc}}, \frac{2\pi\sqrt{3}}{3a_{cc}} \right), \quad \mathbf{b}_2 = \left(\frac{2\pi}{3a_{cc}}, -\frac{2\pi\sqrt{3}}{3a_{cc}} \right) \quad (2)$$

For deriving electronic band structure of graphene can be we account the reciprocal lattice of the triangular lattice. The shaded region in the Figure 1.3.(b) is the first Brillouin zone (BZ) of graphene where Gamma point (Γ) corresponds to its center while K points on its corners represent Dirac points.

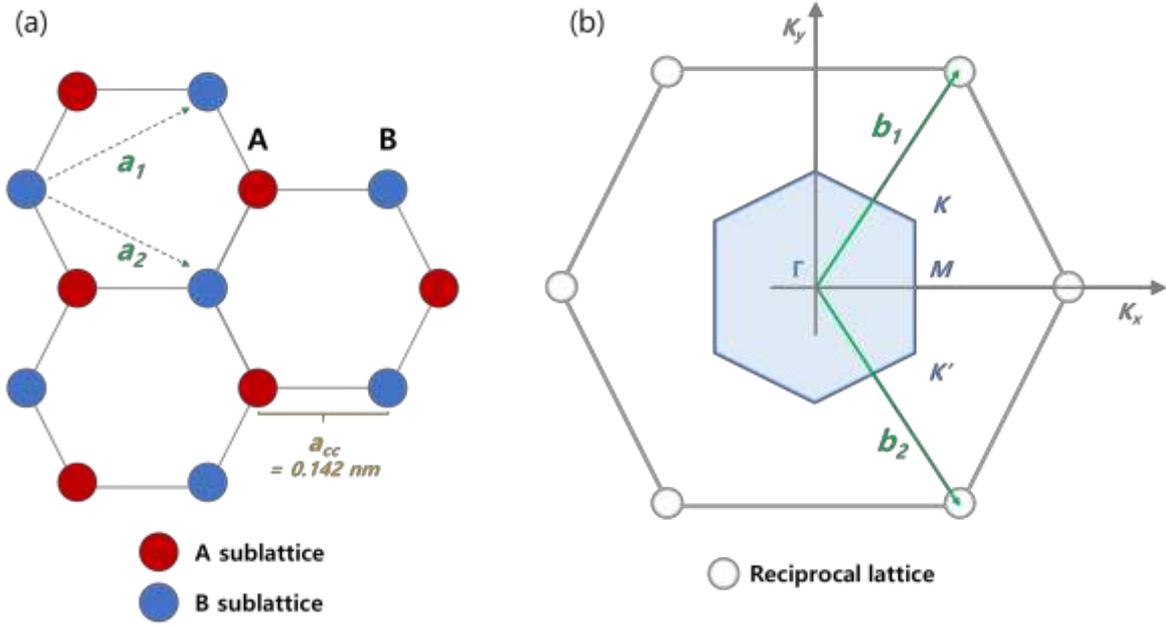


Figure 1.3. (a) Schematic of honeycomb lattice of graphene with the unit vectors \mathbf{a}_1 and \mathbf{a}_2 . (b) Reciprocal lattice with Brillouin zone (BZ) where \mathbf{b}_1 and \mathbf{b}_2 are the reciprocal vectors.

In 1947, the first tight-binding model of graphene was reported by Wallace [27] concerning the nearest and next-nearest neighbor interactions for $2p$ orbitals. Saito et al. in 1998 reported advanced tight binding approximation by expanding conventional model with the wave function overlap of different atoms [28]. Based on their calculation that takes only the nearest neighbor interactions into account, the energy dispersion relation in graphene can be obtained

$$E(k_x, k_y) = \pm\gamma_0 \sqrt{1 + 4\cos\frac{\sqrt{3}k_x\alpha}{2}\cos\frac{k_y\alpha}{2} + 4\cos^2\frac{k_y\alpha}{2}} \quad (3)$$

where γ_0 denotes the transfer integral between nearest neighbor so that the energy has the values of $\pm 3\gamma_0$, $\pm\gamma_0$ and 0 at the high symmetry points, Γ , M and K in the BZ respectively.

Energy dispersion of graphene can be visualized by plotting above equation. Figure 1.4.(a) represents the energy as a function of wave vectors produced by MATLAB with

$\gamma_0=2.8$ eV and the lattice constant, $a = \sqrt{3}a$. As we can see, conduction band and valence band are touching at Dirac points which is well consistent with the zero energy value calculated at K points. At these Dirac points, intrinsic graphene can be considered as a zero band gap semiconductor with the linear energy dispersion relation (Figure 1.4.(b)). Such linear dispersion relation near these Dirac points provides most of interesting electronic properties of graphene and it can be described as

$$E(k) = \pm\hbar v_F |k| \tag{4}$$

where k is the wave vector and v_F ($\sim 10^6$ ms⁻¹) is the Fermi velocity. The effective mass depends on the second derivative of the energy with respect to the wave vector k . It becomes zero for this linear dispersion relation. Hence, electrons in graphene have zero effective mass. They behave like massless Dirac fermions with the speed of v_F , at the K and K' points in BZ. This explains why they are called the Dirac points.

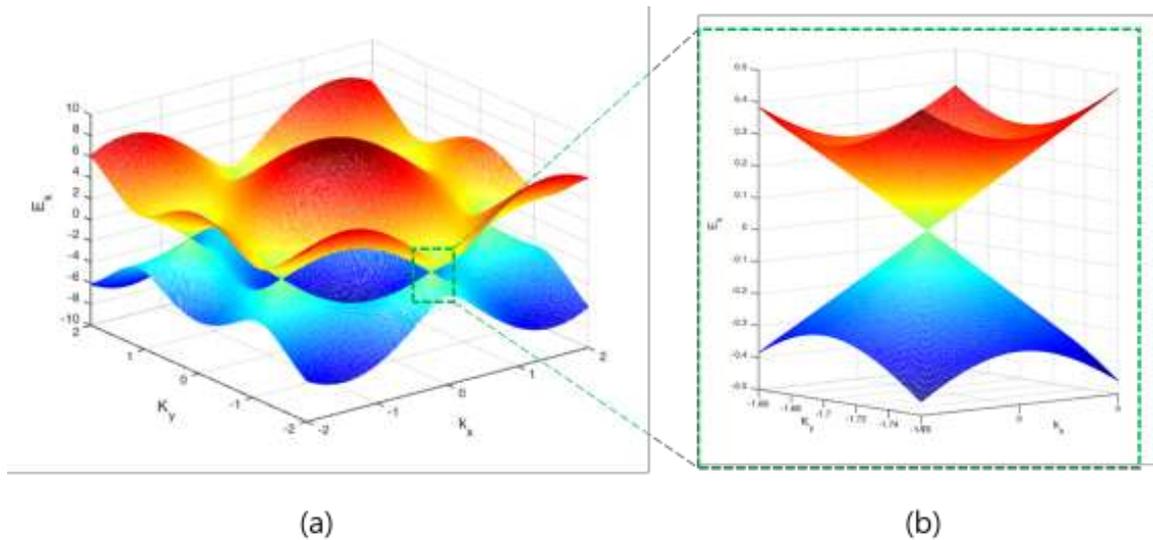


Figure 1.4. Energy band structure for the first Brillouin zone of graphene

1.2.2.2 Electrical Properties

As the Fermi level in the intrinsic graphene is located at the Dirac point where the density of states becomes zero, theoretically the electrical conductivity of intrinsic graphene has to be very low. On the other hand, depending on the Fermi level changes, graphene can easily be either n-doped or p-doped having quite high electrical conductivity. It can be doped by several ways among which applying an electric field. Figure 1.5. is showing the ambipolar electric field effect in monolayer graphene [29] which is the clear evidence of alternating doping state of graphene by the Fermi level changes.

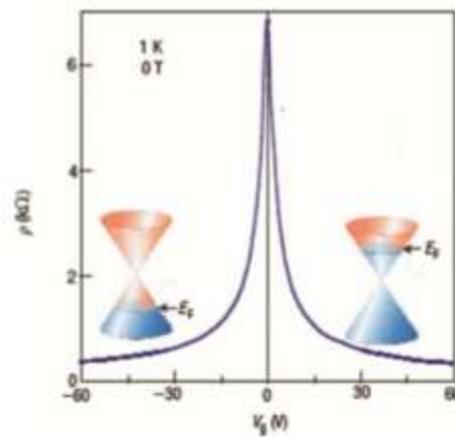


Figure 1.5. Ambipolar electric field effect in monolayer graphene [29]

Adsorption of water or other gas molecules on its surface can also induce graphene doping. This is one of the most important features of graphene for sensing applications and it will be discussed in details in the following chapter. It is also reported that the structural defects like vacancy in graphene increases the material conductivity, while the remaining functional groups through the synthesis process might work as carrier scattering centers and effectively reduce charge mobility.

Researchers working on graphene have extensively studied and reported its electrical properties. It has extremely high charge mobility ($\sim 200,000 \text{ cm}^2/\text{Vs}$) at room temperature which is about 200 times higher than that of Si. This high charge mobility value is observed for the suspended graphene with the carrier density of about $10^{12}/\text{cm}^2$ and a corresponding

resistivity of about $10^{-6} \Omega\text{cm}$ [23] which is even less than that of silver.

However, when graphene sits on a SiO_2 substrate, for example, for the device fabrication applications, its mobility can be strongly limited via the substrate optical phonon scattering and the typical reported values are about $40,000 \text{ cm}^2/\text{Vs}$ at room temperature [30,31] that is 5 times less than that of suspended graphene.

1.2.3 Graphene for device applications

Thanks to its excellent electrical properties combined with optical ($\sim 97.7\%$ transparency for visible light) [21], mechanical (Young's modulus of 1.0 TPa and stiffness of 130 GPa) [22] and thermal properties ($6,000 \text{ W/mk}$) [22], graphene has received great attention as one of the most promising candidates for the future development of various nanodevices. In the following, we introduce several graphene based devices that are being studied by many researchers.

1.2.3.1 Graphene based electrode

Since it has high surface to mass ratio and excellent conductivity with relatively low sheet resistance ($\sim 300 \Omega/\text{sq}$) [32,33] (Figure 1.6.(a)), graphene becomes a promising candidate for use as an electrode. Due to its transparency ($\sim 97.7\%$ for single layer graphene) [21], it is further predicted to be a good candidate for a next transparent conducting film (TCF) replacing indium tin oxide (ITO). ITO has been most actively used as a transparent electrode, mainly in display and solar cell industry. However, because of the limited supply of indium, the cost of ITO is continuously increasing [34]. Furthermore, the transmittance of ITO rapidly drops above visible light wavelength which might limit its use for ultraviolet (UV) sensors and light emitting diode (LED); for this spectral region, graphene transmittance stays stable at around 97.7% for single layer graphene [35] (Figure 1.6.(b)).

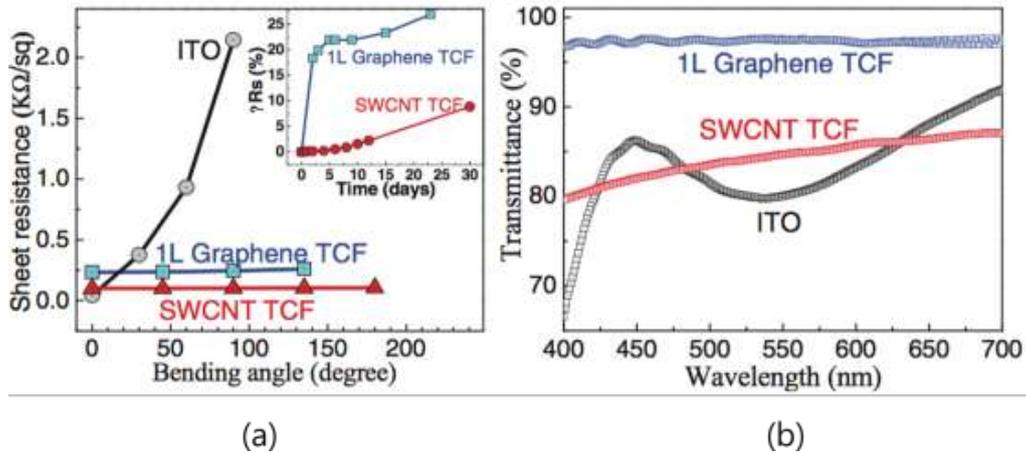


Figure 1.6 (a) Sheet resistance and (b) transmittance of transparent conducting films: ITO, single layer graphene and single wall carbon nanotube [35]

1.2.3.2 Graphene based transistor

Due to the excellent electrical properties detailed above, graphene is considered to be the future material which may replace conventional Si based electronics. One example is the graphene based thin film transistor (TFT). Even though the zero band-gap features of graphene limits its use in digital applications, the high carrier mobility enables graphene to be used for high frequency devices [33,36,37]. Graphene based TFT also features high current density ($\sim 2 \times 10^8 \text{ A/cm}^2$) [38] and high saturation velocity ($\sim 5 \times 10^7 \text{ cm/s}$) [39] which become more important measure of the transport properties [40] for miniaturized micro/nano devices. However, the quality control and the scalability of synthesized graphene still remain as an obstacle to overcome.

1.2.3.3 Graphene for Battery

There have been huge improvements of portable electronic devices in recent few years and thereby equivalent improvements in rechargeable solid-state batteries are being demanded. Today, the battery industry is dominated by lithium-ion technology which enable flexible and light weight design with high energy density. Currently carbon materials such as disordered carbon [41,42] and acid treated graphite [43] are widely used in lithium batteries

while carbon nanotube (CNT) is being most actively studied as an electrode due to its unique structural property that enables rapid insertion/removal of lithium ions [44,45]. Meanwhile, the major interests of the advanced battery research deal with the fabrication of flexible batteries that could be compatible with wearable electronic devices. CNTs are often considered as a good candidate for such flexible electronics. However, practical application as battery electrodes are limited by the relatively high production cost and the difficulties in producing homogeneous and stable CNT sheets [46,47]. On the contrary, graphene may assure a lower production cost with appropriate synthesis and processing methods. Furthermore, taking account of a number of graphene sheets, the specific storage capacity of graphene may correspond either to 780 mAh/g or to 1,116 mAh/g [48,49,50] depending on different interaction descriptions between graphene and lithium; these values exceed the capacity of graphite (372 mAh/g) [51] and are comparable to that of CNT (1,100 mAh/g) [52].

1.2.3.4 Graphene for photonic devices

Graphene is also an appealing material for photonic devices mainly due to its previously stated exceptional optical and electrical properties. Among many photonic devices, graphene based photodetector is most actively investigated for several reasons. First of all, graphene is a zero band gap material. Hence, photoelectrons can be generated by light absorption over a wide range of optical energy spectrum which is not probable with conventional semiconductors such as Si and InGaAs. The maximum detectable light wavelength for Si and InGaAs ends at ~1,100 nm and 2,600 nm respectively [53] while graphene covers wider ranges of practical light wavelength including ultraviolet, visible, short-wave infrared (SWIR), near-infrared (NIR), mid-infrared (MIR), far-infrared (FIR) and terahertz (THz) spectral regimes as well [54]. Besides, we might also benefit from its ultrafast carrier dynamics [55,56], wavelength-independent absorption [57-59], tunable optical properties by electrostatic doping [60,61] and high carrier mobility that enables ultrafast operation of graphene based photodetectors [62-65]. In addition to the photodetector, many efforts have been devoted to employing graphene for the development on an optical modulator [61,66,67], optical polarization controller [68,69] or mode-locked laser/THz generator [70,71].

1.2.3.5 Graphene for gas sensing applications

To the best of our knowledge, it is known that the very first reported gas sensor based on graphene was fabricated by F.Schedin et al[72] in 2007. Mechanically exfoliated graphene was used as an active layer of field-effect transistor (FET) and the device was fabricated on the silicon wafer with 300 nm SiO₂ layer. The device was made as a hall bar geometry so as to measure both longitudinal and transverse resistivity under applied magnetic field where one can directly calculate the charge carrier concentration changes. Various gases such as NH₃, CO, H₂O and NO₂ were diluted to 1 ppm and tested. Figure 1.7.(a) shows the result where NH₃ and CO were found to act as electron donors while H₂O and NO₂ acted as acceptors. The authors also reported that carrier concentration depends linearly on the relative gas concentration (Figure 1.7.(b)). The quantized sensor response represented by the step-like changes in Hall resistivity near the neutrality point ($|n| < 10^{11} \text{ cm}^{-2}$) during adsorption and desorption of strongly diluted NO₂ (Figure 1.7.(c)) clearly suggests evidence for individual adsorption and desorption phenomena as well.

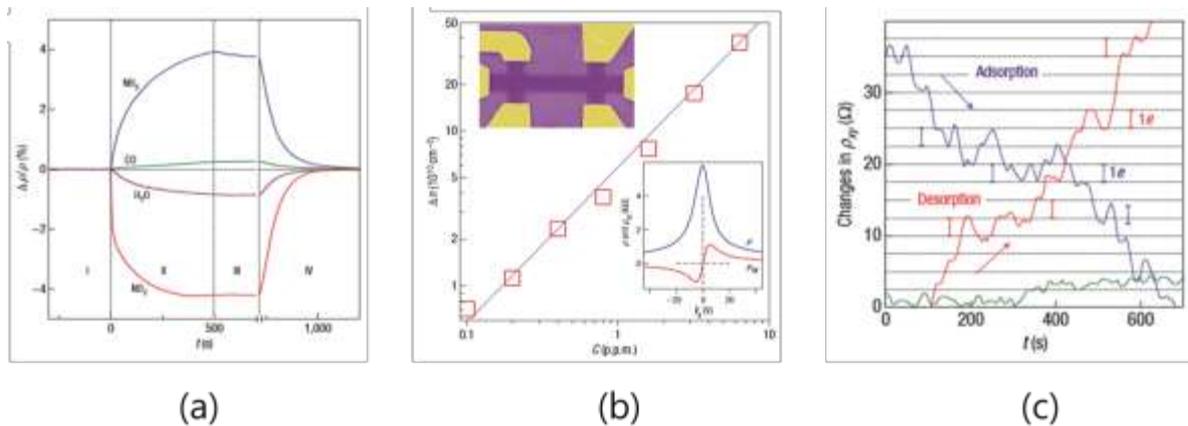


Figure 1.7. Sensitivity of graphene to chemical doping (a) changes in resistivity at zero B upon exposure to various gases. (b) linear dependence between carrier concentration and gas concentration. (c) Single-molecule detection of strongly diluted NO₂.

The detection mechanism of most of graphene based gas sensors, as demonstrated by above introduced device, is mainly based on the changes in electrical conductivity of the graphene layer. Adsorption and desorption of target gas molecules can act either as donors or

acceptors thus modifying the carrier density or the mobility and resulting in the conductance changes. In addition to this simple and direct measurable detection mechanism, graphene has many other advantages in regards of potential gas sensing applications:

- ✓ Large theoretical specific surface area ($\sim 2600 \text{ m}^2/\text{g}$) [22] that provides high surface-to-volume ratio where every atom can be considered as surface atom interacting with a single target gas molecule
- ✓ Exceptional electronic properties of graphene make it possible to have fast response. Besides, being a zero gap semiconductor, graphene can detect even a small change in charge carriers caused by subtle adsorption and desorption process.
- ✓ Inherently low flicker [73] and Johnson noise [72] that enable graphene based sensors to have very large signal-to-noise ratio at room temperatures.
- ✓ Conventional thin film electronic engineering and processing techniques are compatible with graphene. Hence, graphene based devices such as four-terminal resistor and FET are relatively easy to fabricate.
- ✓ By avoiding expensive lithography process, low-cost graphene based gas sensor can be fabricated for certain device configurations such as four-terminal graphene resistor.
- ✓ Further progress on a synthesis of large-area graphene by chemical vapor deposition (CVD) process may enable mass production of graphene based gas sensor which may be an important issue from industrial and practical point of view [74,75].
- ✓ Graphene is 2-D material but it shares most of the CNTs technology advantages; most of surface chemical treatments which are already verified with CNTs are applicable to graphene as well.

With all these great advantages for gas sensing applications development, many researchers have already reported various types of graphene based gas sensors in different device configurations including resistive, FET, surface work function (SWF) transistors, surface acoustic wave (SAW) sensor, quartz crystal microbalance (QCM) sensor, micro electromechanical systems (MEMS) and metal oxide hybrid gas sensors and so on. Most of

reported solid state gas sensors so far adopt resistor/FET configurations because of its maturity in technological understanding.

For the resistive graphene based gas sensors, device resistance changes induced by adsorbed gas molecules are measured. Simple fabrication and direct measurements are the great advantages [76-78] of this type of sensors. On the other hand, for the graphene based FETs, the measured drain current upon exposure to the target gases can either be affected by the applied gate bias or by the adsorption of gas molecules. In this case, the performances of sensors strongly depend on the on/off ratio where a higher sensitivity requires a higher on/off ratio [79,80]. SWF transistor sensor is another type of transistor based graphene gas sensor. The adsorption of target gas molecules changes its surface dipole moment and its electron affinity and thereby increase the surface work function of graphene [81]. The detection mechanism of SAW sensors is based on the frequency response of graphene layers caused by either mass changes or conductance changes resulting from the adsorption/desorption of target gases [82]. QCM is one of the most popular bulk acoustic wave (BAW) sensors where the frequency response is interpreted mass changes depending on adsorption/desorption of target gas molecules [83]. Recently, advanced MEMS technology are employed in order to make the best use of graphene films as sensing material on micro/nano devices [84] as well. This miniaturization of sensors benefits from many advantages such as high sensitivity with fast response, low temperature operation, low power consumption, and low cost mass production [85]. Meanwhile, there were even some efforts to fabricate hybrid gas sensors that combine the advantages of graphene based gas sensors with those of conventional semiconducting metal oxides [86-89].

For sensing applications, the sensitivity of the device is one of the most important device characteristics. Like all other materials used as active layer for solid state sensors, for graphene based gas sensors, the sensitivity relies very much on the nature of graphene layer. The ideal graphene is a perfect crystalline structure with infinite surface area which has no dangling bonds on its surface that are required for the adsorption of gas molecules. Such a perfect graphene can be obtained via mechanical exfoliation but its size is limited to a few micrometers and the method has low throughput. On the other hand, graphene synthesized by chemical vapor deposition (CVD) process can produce large surface area films which

promises high throughput for device applications. However, because of the imperfection of synthesis process, CVD graphene is generally produced with some defects which are considered to be important for gas sensing applications [90,91]. Masel et al [92] in 2012 has reported that the type and geometry of graphene defects affect the sensitivity of a graphene based gas sensor. For example, the Figure 1.8. clearly shows that the device based on defective graphene has higher sensitivity compared to the pristine graphene based device. The gas sensor with pristine graphene has shown almost negligible response while that with intentionally introduced line defects on the graphene surface has shown up to 6% conductance increase. As the line defects extended to finally cut the graphene sheet into ribbons with width in the range of several micrometers, the device response further increases by two times over that of line defects device, or up to 12% conductance increase.

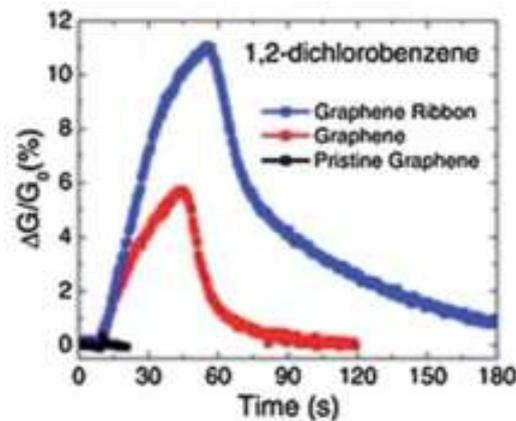


Figure 1.8. Response of the pristine and defective CVD-graphene to 1,2-dichlorobenzene. [92]

In addition to this study, many researchers reported that the sensitivity of graphene can also be effectively enhanced by functionalizing it with polymers, metals or other surface modifiers [93-96]. Likewise, the device sensitivity might change significantly depending on the nature of the graphene layer. However, unexpected and poorly known defects can be produced at any process steps including synthesis, transfer, electrode deposition and so on. Hence, graphene should be carefully characterized from the first synthesis process step to the final device fabrication in order to understand and manage fabricated devices behavior in terms of its sensitivity.

The second important device characteristics for sensing applications would be the specificity. The sensitivity of graphene based gas sensor for a certain gas molecule might be comparable to that obtained for a range of different gas species and mixtures. Hence, definitive identification of detected gas molecules is not easy. For example, when the graphene based sensor is exposed to the mixture of NO_2 and NH_3 gas molecules, the former increases device conductance while the latter reduces it. Then the combination of these two opposite effects may result in almost zero device response misleadingly representing zero gas molecule detection which is not the case. Moreover, it is also possible to mix different gases in various relative concentrations in order to yield the same net device response. Therefore, it is necessary to develop approaches allowing graphene based devices to detect only the target gas molecules. Probably one of the most effective way to realize this specificity in graphene based gas sensor is to functionalize graphene layer with certain elements that react only with certain gas molecules.

1.3 Functionalized graphene

Despite its great potentialities in device applications, as a zero gap and inert material, ideal graphene sometimes loses its competitiveness in the field of semiconductors and sensors. To this respect, graphene is often functionalized with various elements for many purposes such as improvement of sensitivity, specificity, solubility, loading capacity, etc [97-104]. For gas sensing applications, improved sensitivity and specificity may be the main purposes of functionalization. Fortunately, various strategies have already been devised for functionalizing CNTs based devices and these approaches are compatible with graphene as well [105]. Following sections will briefly introduce the two main functionalization ways: covalent and non-covalent functionalization.

1.3.1 Covalent functionalization

The covalent functionalization of pristine graphene surface with organic functional groups has been developed for several purposes. The main purpose is to improve graphene dispersion in common organic solvents [106]. For example, oxygen containing functional groups such as carboxylic(-COOH), hydroxyl(-OH), usually found in graphene oxide (GO) or reduced graphene oxide (RGO), can be covalently bound on the surface of graphene by using strong acids [106]. Graphene can easily be fluorinated and several chemical functional groups such as amino, hydroxyl or alkyl groups can also form covalent bond with carbon atoms by replacing those fluorine atoms [107-109]. Sometimes, covalent functionalization can also be used to serve as an amplification mechanism for further functionalization of sensing probes or as a spacing between graphene and sensing probes [110]. For the covalent functionalization, functional groups are firmly bound by forming covalent bonds and ensure their proper functions on the graphene surface. However, it is well known that the covalent bonds convert sp^2 carbon bonds to sp^3 carbon bonds. This will then create electron scattering centers that will limit the performances of the devices by altering native electronic structure and physical properties of graphene.

1.3.2 Non-covalent functionalization

Non-covalent functionalization is often employed to avoid altering the pristine electronic structures of graphene and thus preserve its intrinsic properties. Functional molecules can be grafted onto graphene by the aid of linkers. One of the most frequently used linkers is the pyrene moiety. It has been reported to have a strong affinity toward graphene surface via strong π - π interaction [111,112]. For example, Xu et al. prepared stable aqueous dispersions of graphene flakes by functionalizing graphene oxide with pyrenebutyric acid [113]. Wang et al., on the other hand, has employed non-covalently functionalized graphene with pyrene butanoic acid succidymidyl ester (PBSA) rather than pristine graphene to improve the power conversion efficiency of organic solar cell devices. The π - π interaction between graphene and PBSA has negligible effect on the optical absorption of visible light of graphene layer. They have reported functionalized graphene improvement up to 1.5 % of the power conversion efficiency compared to that with pristine graphene [114] (Figure 1.9.).

An et al. have also reported versatile hybrid film based on the non-covalently functionalized graphene films with 1-pyrenecarboxylic acid (PCA) [115]. They laminated PCA functionalized graphene film onto flexible and transparent polydimethylsiloxane (PDMS) layer. This hybrid film shows differentiated optical and molecular sensing properties compared with pristine graphene film while its conducting nature remains the same. It blocks 70 to 95 % of UV light and passes more than 65 % of visible light. Besides, the electrical resistance was found to be also changing upon the visible light illumination, the pressure changes, and the exposure to different types of gas molecules. This multi-functionality of the film promises its future applications in various fields. Other bifunctional complexes having a reactive end and an aromatic tail such as thionine, perylene tetracarboxylic acid and porphyrin derivatives are used as linkers for non-covalent functionalization as well [116].

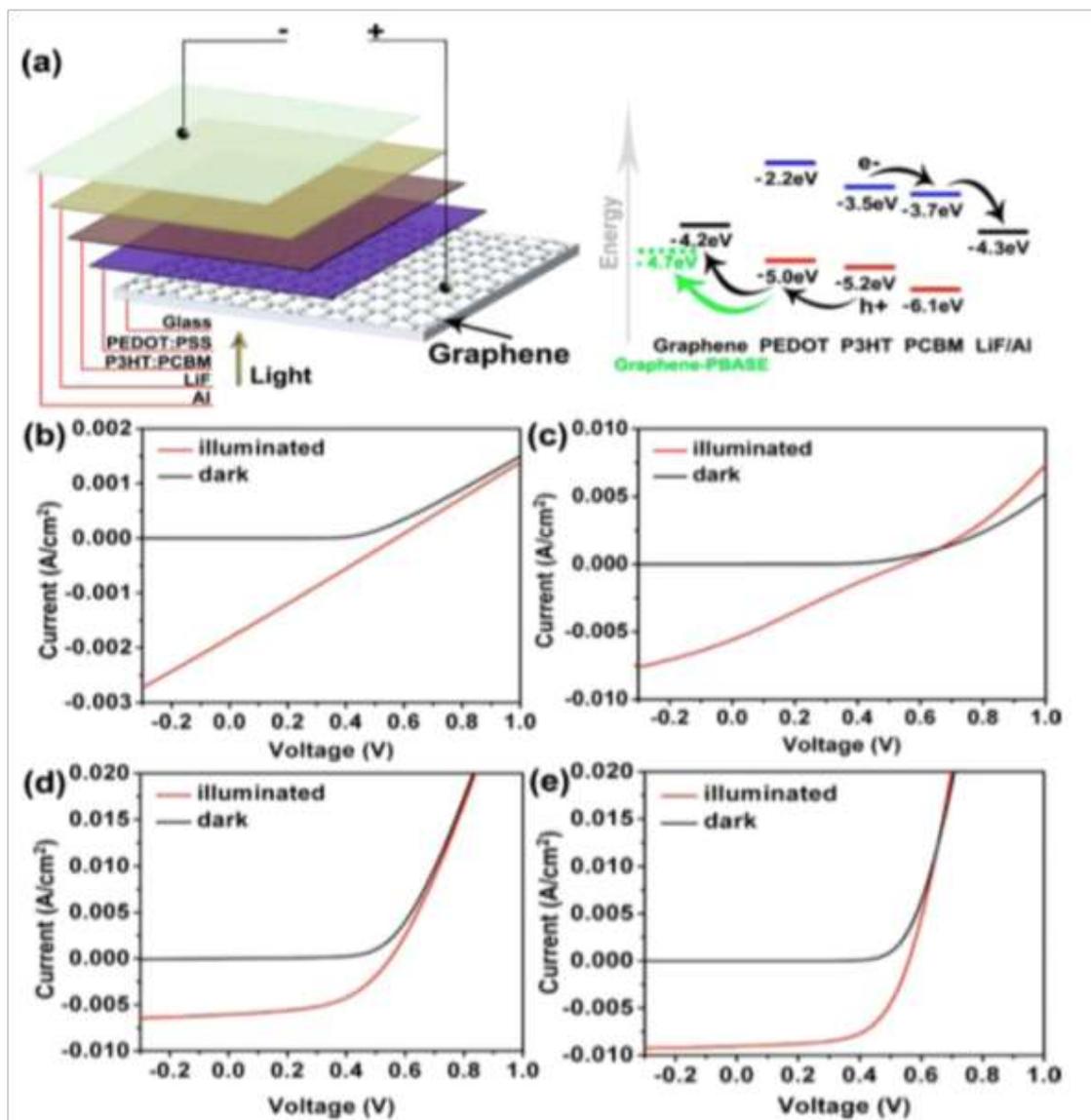


Figure 1.9. (a) Schematic view and energy diagram of the organic solar cell fabricated with graphene. (b-e) I-V characteristics of the solar cell devices based on graphene films in the dark and under illumination: (b) pristine graphene, (c) UV treated graphene, (d) graphene functionalized with PBSA and (e) ITO for the comparison. [114]

On the other hand, graphene can be considered as an ideal substrate for the dispersion of nanoparticles due to its large specific surface area ($\sim 2600 \text{ m}^2/\text{g}$) [22] compared to that of CNTs, amorphous carbon or graphite. Furthermore, graphene is free of metallic or carbon impurities which is not the case for CNTs. Many researchers have already reported

graphene films decorated with metal nanoparticles (e.g., Au, Ag, Pt, Rh, Pd) in a variety of applications such as fuel cells, sensors, supercapacitors, and batteries [117-122]. In addition, due to the fact that GO and RGO surface contains oxygen containing functional groups, they are often employed for the nanoparticle decoration as well. This decoration is done in non-covalent way such as reduction process [123,124], electrospray [125] or electrochemical deposition [126].

1.4 Conclusions

Since its discovery, graphene has been an appealing and attractive material for many researchers due to its exceptional properties originating from its unique linear energy-momentum dispersion. For example, it is optically transparent (~97.7 % transparency for visible light), mechanically robust (Young's modulus of 1.0 TPa and stiffness of 130 GPa) and has high thermal conductivity (6,000 W/mK), high theoretical charge mobility (~200,000 cm²/Vs) at room temperature and low resistivity (10⁻⁶ Ωcm).

Thanks to its excellent physical properties, graphene has received great attention as one of the most promising candidates for the future development of various nanodevices. It is a promising alternative as a next TCF replacing ITO. Graphene based TFT is another promising device, but the quality control and the scalability of synthesized graphene still remain as an obstacle to overcome. It is also used in the advanced battery research dealing with flexible electronic devices. Many efforts have been devoted to employing graphene for the development of photonic devices, such as optical modulator, optical polarization controller, mode-locked laser/THz generator and photodetector. Graphene based gas sensor

Despite its great potentialities in device applications, as a zero gap and inert material, ideal graphene sometimes loses its competitiveness in the field of semiconductors and sensors. To this respect, graphene is often functionalized with various elements for many purposes such as improvement of sensitivity, specificity, solubility, loading capacity, etc. Graphene can be either covalently or non-covalently functionalized. However, covalent bonds convert *sp*² carbon bonds to *sp*³ carbon bonds thus limit the performances of the device by altering electronic structure and physical properties of graphene. On the other hand, non-covalent functionalization is often employed to preserve intrinsic graphene properties while keeping advantages resulting from the functionalization.

Current environmental problems including air pollution via the release of chemical pollutants originating from the modern advanced technology and the global development of industrial activities are threatening human health. To prevent such problems, the development of new sensors that are compact, robust, with versatile applications and a low cost is needed. In this regard, graphene based sensor is one of the best promising candidate that provides

various potential advantages: ultra-compact, effective at room temperature, low-power consumption, low cost, high sensitivity, selectivity, low response and recovery time. Furthermore, graphene can be non-covalently functionalized to improve its specificity for selective sensing of the device.

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Chapter II

Graphene Preparation and Characterization

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Chapter II. Graphene Preparation and Characterization

2.1 Generalities

Most of the performances of graphene based devices rely on its surface characteristics. However, required physical properties and the overall quality of the graphene films differ depending on the various applications. For example, graphene with a highly crystallized grain and minimized structural defects are favorable for graphene transistor while some surface defects are usually preferable for gas sensing applications. Hence preparing appropriate material is of great importance for a certain device application. In this chapter several commonly used synthesis methods are introduced among which, one method which was originally developed in LPICM [1].

Once synthesized, it is necessary that graphene films are characterized to understand its electrical and physical properties for further device applications. There are several well-known common techniques to characterize physical properties of 2D materials such as scanning electron microscopy (SEM), transmission electron microscopy (TEM), atomic force microscopy (AFM), Raman spectroscopy, photoemission spectroscopy (PES), optical microscopy, optical transmittance and so on.

SEM and AFM are choice techniques for investigating the surface of materials at nanoscale. They can reveal the morphology and the thickness of the material but it becomes not clear when the graphene sheet is homogeneous and continuous as we merely find structural deformations. TEM provides useful information about material crystallinity by investigating its cross-section. But it requires destructive pre-treatment of the sample and the measurement is expensive and time consuming. Raman spectroscopy is the most powerful technique for non-destructively characterizing graphene and a simple measurement brings fruitful information about graphene, especially about its quality. ARPES is commonly used for studying material's energy dispersion respect to its momentum. Optical microscopy can be simply used to locate graphene layers by comparing the image contrast and optical transmittance measurement. It is utilized, for example, for counting the number of layers. In this chapter we will closely look at some of characterization techniques used for investigating the properties of graphene used in the experiments.

2.2 Preparation

2.2.1 Exfoliated graphene

Structurally graphite allotrope is formed by stacking many layers of graphene sheets. In principle, each layer of graphite is stacked by weak Van-der-Waals force and therefore graphene can be detached by breaking these bonds. Hence the exfoliation of graphite to produce graphene has been investigated by various experimental approaches including mechanical and chemical methods.

Mechanical exfoliation is the process where the best quality graphene, in terms of structural integrity and electronic performance, can be obtained. In this process, graphene is separated by peeling off a layer from commercially available Highly Oriented Pyrolytic Graphite (HOPG) sheet by using scotch tape then transferred onto the substrate. The schematic diagram of the mechanical exfoliation procedure by using scotch tape is represented in the Figure 2.1.. Thanks to its excellent quality with simple and easy process, many fundamental studies have been carried out on mechanically exfoliated graphene since its first isolation by Manchester group [2]. However, graphene produced in this way has a limitation in sheet size (~micrometers) and low production yield which are sometimes crucial drawbacks for device applications.

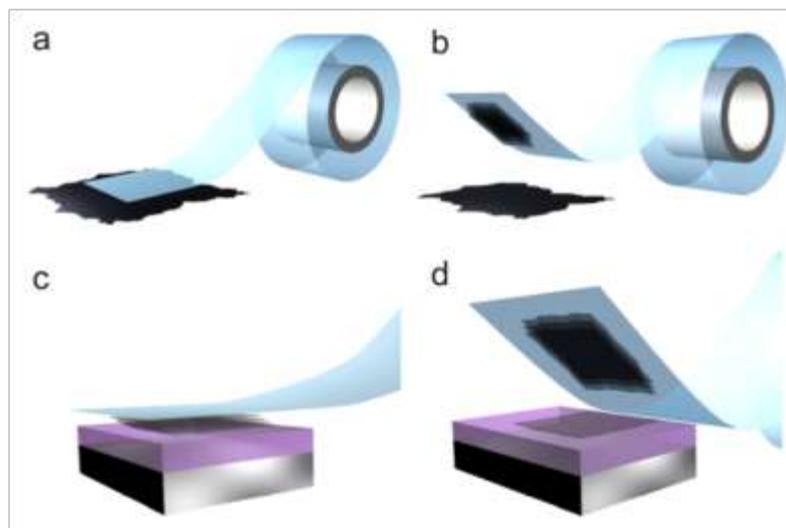


Figure 2.1. Micromechanical exfoliation of 2D crystals. (a) Adhesive tape is pressed against a 2D crystal so that the top few layers are attached to the tape (b). (c) The tape with crystals

of layered material is pressed against a surface of choice. (d) Upon peeling off, the bottom layer is left on the substrate [3].

On the other hand, high production yield can be achieved by chemical exfoliation method (Figure 2.2.). In this process [8], graphite is first soaked in mixtures of sulfuric and nitric acid. Then the acid molecules penetrate into the graphite to form alternating layers called graphite intercalate compounds (GICs) that expands the interlayer spacing between graphene sheets. Rapid evaporation of these GICs at high temperature eventually produces exfoliated graphene sheets [4-6]. Although chemically exfoliated graphene promises high production rate, chemical treatment during the process generates structural defects [7] that may affect the intrinsic electronic properties of graphene as well.

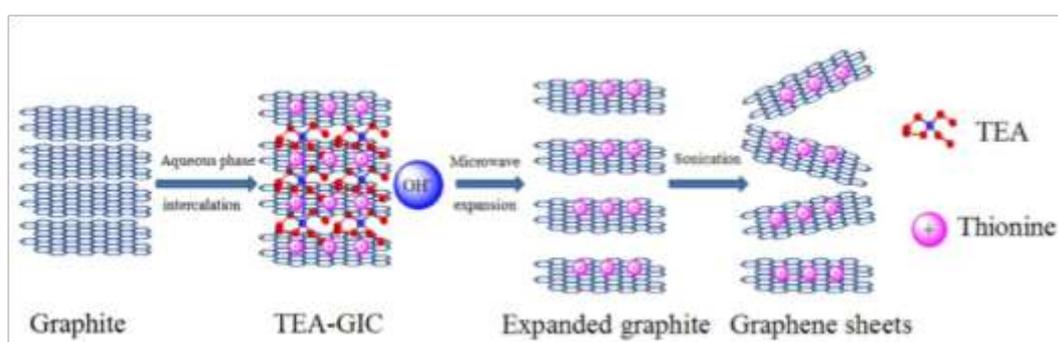


Figure 2.2. Experimental procedure for preparation of graphene by liquid phase intercalation and exfoliation of graphite [8].

2.2.2 Epitaxial graphene

Graphene can also be epitaxially grown. In this case, the graphene layer is obtained by decomposing the hexagonal single crystal silicon carbide (SiC) surface layers to graphene at high temperature [9] as illustrated in the Figure 2.3.. On the $\{0001\}$ surfaces of the hexagonal SiC single crystal, there are both Si-terminated (0001) and C-terminated ($000\bar{1}$) faces. Si-terminated face is usually preferable for obtaining better homogeneous graphene growth. Furthermore, a carbon buffer layer is produced through the epitaxial graphene growth on the Si-face which is electrically inert [10,11].

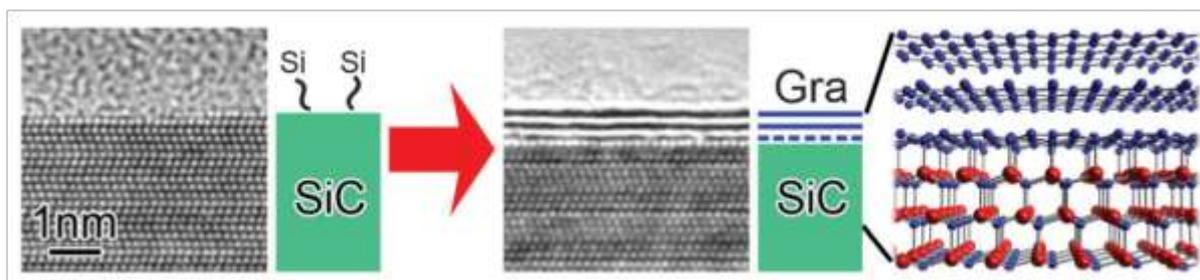


Figure 2.3. Basics of graphene growth by thermal decomposition of SiC, together with the structural model of bilayer graphene on SiC. Shown as the blue broken line is the buffer layer [12].

The epitaxial grown graphene on SiC has the primary advantage that it does not require transfer process since SiC itself serves as a good insulator. Graphene directly grown on insulating substrate becomes compatible with the Si-based standard microelectronic technologies for large integrated circuits with dense transistors [13].

In 2007, Zhou et al. reported an interesting characteristic of graphene epitaxially grown on SiC substrate. In that case, the graphene-substrate interaction caused a band gap opening of up to $\sim 0.26\text{eV}$ with less than 4 layers [14]. This band gap enables graphene to be useful as an electronic material especially for field effect transistors (FETs). However, because of the process complexity difficulties such as determining the face and edge-termination (silicon or carbon) of the substrate and controlling the decomposition rate, precise control of growth conditions for graphene on SiC substrate remain up to day a very important challenges.

2.2.3 CVD graphene

Single or few layer graphene can also be synthesized on the surface of transition metal (*e.g.*, nickel, copper, cobalt, palladium) substrates by chemical vapor deposition (CVD) process. In this process, carbon-containing gases, usually methane (CH_4), are used as precursors. At high temperature (*e.g.*, at $\sim 1000\text{ }^\circ\text{C}$ for Ni), compared with room temperature, relatively large amount of carbon atoms can be dissolved into catalyst metal. Then during the cooling step, excessive dissolved carbon atoms will diffuse out to the surface of metal

substrate which results in graphene layers by surface segregation of carbon [15]. On the other hand, generally, higher quality of single layer graphene is expected to be grown on the Cu substrate rather than Ni substrate because of its larger grain size with low carbon solubility compared with Ni substrate [16]. Low carbon solubility of Cu (0.001~0.008 wt.% at 1,084 °C [17]) allows only the surface reaction with gases thus a single graphene (SLG) layer is formed by self-limiting mechanism on the substrate. Brief illustration of the CVD process with Cu substrate [17] is represented in Figure 2.4..

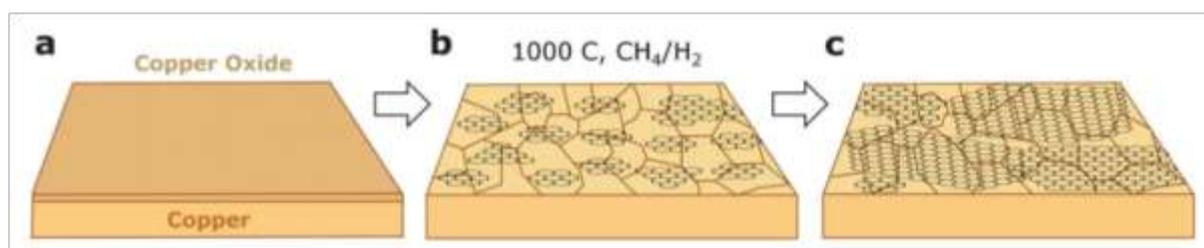


Figure 2.4. Schematic illustration of three main stages of CVD process for graphene growth: (a) copper foil with native oxide; (b) the exposure of the copper foil to CH₄/H₂ atmosphere at 1000 °C leading to the nucleation of graphene islands; (c) enlargement of the graphene flakes with different lattice orientations [17].

Depending on various process conditions such as temperature, gas flow rate, metal substrate and cooling rate, the quality and the properties of synthesized graphene vary significantly. For example, SLG is usually synthesized on Cu substrate because of its self-limiting characteristic where the growth stops after one graphene layer is formed at the surface [16]. The Figure 2.5. shows the Raman spectra of graphene synthesized on Ni substrate with different cooling rates studied by Qungkai Yu et al. [18]. They investigated three different cooling rates corresponding to fast (20 °C/s), medium (10 °C/s) and slow (0.1 °C/s). The result shows that the optimized cooling rate exists for obtaining better quality graphene by CVD process where the medium cooling rate is the case for their study.

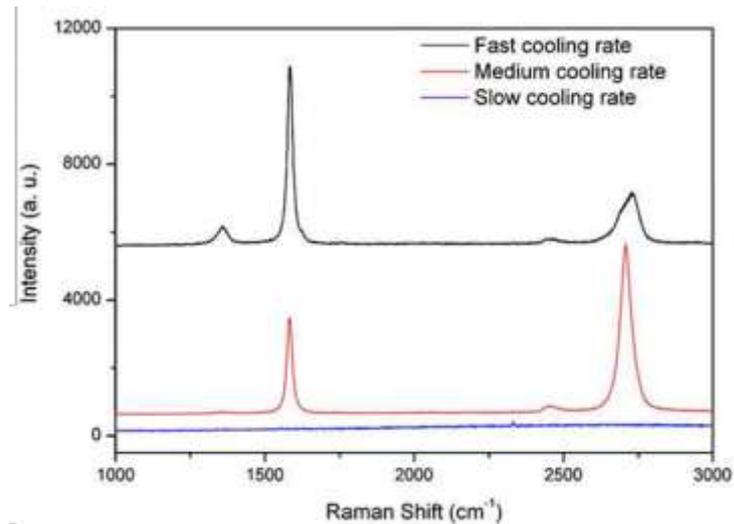


Figure 2.5. Raman spectra of CVD graphene on Ni substrate depending on different cooling rate [18].

2.2.3.1 PECVD

Thanks to its process advantages, especially possible large area and low-cost production, CVD process for graphene synthesis is actively studied by many researchers. However, high process temperature near 1,000 °C is a critical issue in terms of industrial aspects. Hence, like for CNTs, there have been many efforts to lower the process temperature by employing plasma enhanced CVD (PECVD) process. The process temperature has been lowered to around 500 °C. Many groups are still working on it to optimize and simplify the process conditions and steps with the improvement of graphene quality [19-21].

2.2.3.2 Transfer of Graphene

Even though large area graphene layers can be grown by CVD process, they are still on the catalytic metal substrate surface. Once graphene is synthesized on this metal substrate, it is supposed to be transferred onto the final insulating substrate required for most of electronic device applications. The Figure 2.6. [22] shows the typical procedures of this transfer technique. Graphene synthesized by CVD process on Cu metal layer is covered by a

sacrificial polymethyl methacrylate (PMMA) and annealed at first. Cu layer is subsequently removed by wet etching and the remaining graphene attached to the PMMA is rinsed by deionized (DI) water. Then it is put together onto the target insulating substrate and subsequently annealed. Finally, PMMA is selectively removed by acetone and only graphene remains on the insulating substrate [22-24].

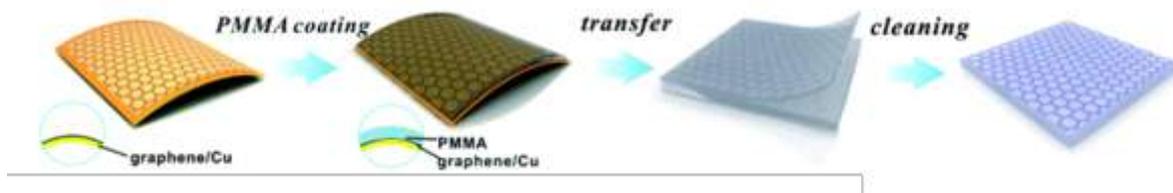


Figure 2.6. Transfer of graphene [22]

However, this transfer process has many drawbacks such as surface contamination originating from PMMA [23,24], morphological and structural deformation (*e.g.*, wrinkles, cracks, defects) of graphene layer [25] and it is even quite sophisticated process that requires appreciable time and cost [26]. For these reasons, direct growth of graphene on insulating substrate is desirable in terms of device applications for many researchers. LPICM, by using home-made triode type PECVD system, could directly grow graphene on the insulating substrates. This will be explained in detail in Chapter 3.

2.3 Characterization techniques

2.3.1 Scanning Electron Microscopy (SEM)

Scanning electron microscopy is one of simple and fast techniques to verifying the quality of the graphene on the substrate. It is a non-destructive technique so that the characterized graphene can later be used for device applications. The image taken by SEM provides useful information especially for polycrystalline graphene such as its location on the substrate, grain boundaries and structural deformations including wrinkles, vacancies, cracks, and so on.

The principle of this technique lies on the interpretation of secondary electrons generated by the interaction between incident electrons and the target sample. Incident electrons are significantly scattered and therefore, SEM operates in two different modes depending on the scattering type: elastic or inelastic.

First mode, based on the electron inelastic scattering, is the most commonly used way to investigate the surface morphology. SEM collects low-energy secondary electrons coming from the k-orbitals of only few atomic layers [27-29]. Second mode employs the electron elastic scattering where the electrons undergo no energy loss which is called back scattered electron imaging. SEM collects high-energy secondary electrons coming from the nuclei of bulk atoms. This enables us to have an image contrast as a function of elemental composition which is for investigating the existing elements but not for surface morphology. The Figure 2.7. is an example of SEM image for graphene-supported Pt nanoparticles taken as both modes [30]. A typical low-energy secondary electron image is represented in the Figure 2.7.(a) and a corresponding back scattered electron image on the same spot is demonstrated in the Figure 2.7.(b). In the Figure 2.7.(b), Pt nanoparticles are highlighted by brighter regions which are not clearly observable in the low-energy secondary electron image (Figure 2.7.(a)).

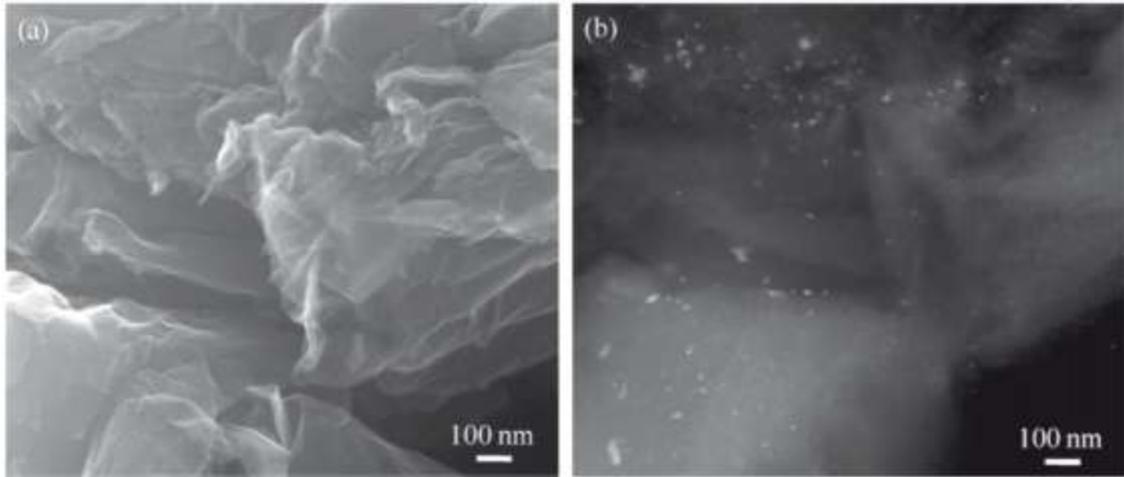


Figure 2.7. SEM image for graphene-supported Pt nanoparticles: (a) Low-energy secondary electron image, (b) corresponding height contrast back scattered electron image showing Pt nano particles with a dimension less than 10 nm synthesized on graphene sheets [30].

2.3.2 Atomic Force Microscopy (AFM)

Atomic force microscopy is widely used for the surface morphology study. However, like SEM, homogeneous materials with no structural defects are not favorable for the measurements, since it records the height differences. Besides, unlike SEM, AFM requires even longer time on the limited spot of the sample for obtaining one decent image (more than 30 minutes for few micro-meter scales). Therefore, for graphene characterization, AFM is usually employed for certain cases such as graphene flakes deposited on the substrate or superposition of several graphene layers.

The Figure 2.8.(a) shows AFM image of the CVD graphene grown on a Si substrate with SiO₂ layer on it [31]. Brightness difference directly represents the height difference and the height analysis trace along the white line is shown in the Figure 2.8.(b). Likewise, the step difference between layers can be easily detected by AFM. The height analysis trace indicates that the height of measured layers is about 3~4 nm which may correspond to several graphene layers [32].

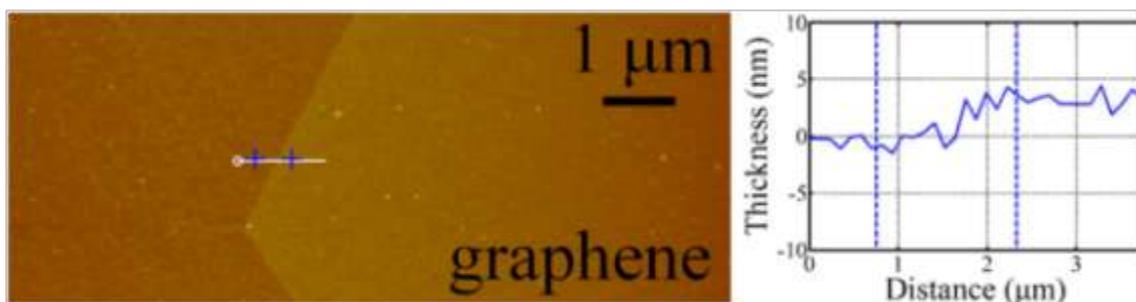


Figure 2.8. (a) Image of the graphene measured by AFM tapping mode and (b) height analysis trace along the white line [31]

2.3.3 Raman spectroscopy

Raman spectroscopy is the most powerful and popular technique especially for investigating the structural and electronic characteristics of carbon nanomaterials because it is simple and non-destructive [33,34]. The measured data provides useful information with several characteristic peaks: D peak at $\sim 1,350 \text{ cm}^{-1}$, G peak at $\sim 1,580 \text{ cm}^{-1}$, and 2D peak at $\sim 2,700 \text{ cm}^{-1}$ which is also known as G' peak since it is the second recognizable peak observed in graphite [35]. The D peak represents the defects [36] while G peak represents the degree of graphitization by in-plane vibration of sp^2 carbon bonds. The intensity ratio of D peak to G peak is widely used as an index for the quality of the graphene. 2D peak corresponds to the second order of zone-boundary phonons which is the clear evidence for the graphene layer [37]. In addition to this, 2D peak is sometimes used for the comparison of the number of graphene layers [38] or for identifying the graphene stacking order [39]. Furthermore, Raman spectroscopy is even an effective technique for studying the doping of graphene layers via the shift of G and 2D peaks [40,41].

Figure 2.9.(a) compares the Raman spectra of graphene and graphite with the 514 nm excitation laser [38]. As expected, two most intense features are the G and 2D peaks and no D peak is observed which proves the absence of a significant number of defects. (Figure 2.9.(b)) demonstrates the evolution of the 2D peak with the number of graphene layers. As the number of layers increases from single to as many as graphite we observe a significant decrease of the 2D peak intensity.

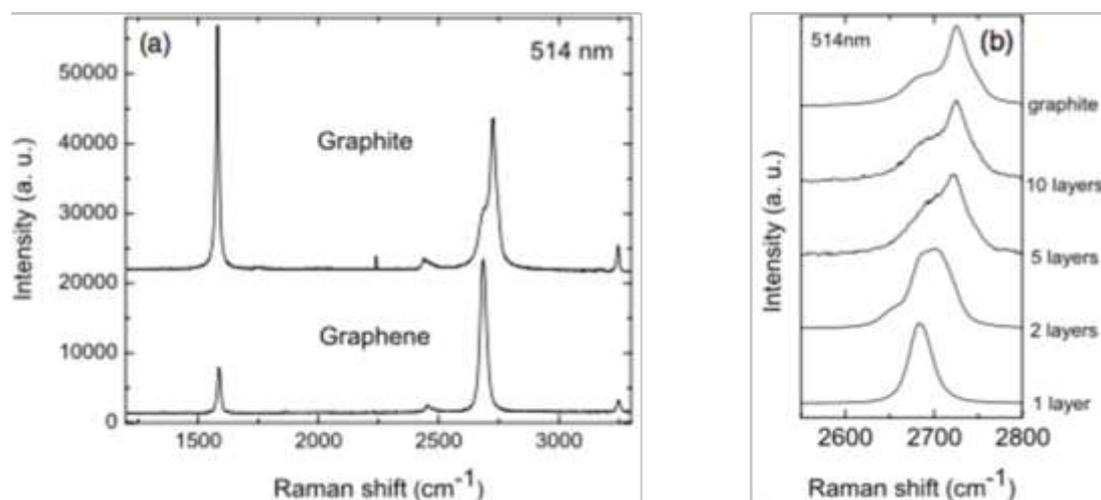


Figure 2.9. Raman spectra with the 514 nm excitation laser: (a) Comparison of graphite and graphene, (b) Evolution of the spectra with the number of layers [38].

2.3.4 Photoemission spectroscopy (PES)

2.3.4.1 Generalities

Photoemission spectroscopy (PES), in general, refers to energy measurement of electrons emitted by the photoelectric effect, in order to determine the binding energies of electrons in a substance. It has been established as one of the most important techniques to study the electronic structure of molecules, solids and surfaces [42,43]. Quasi-monochromatic light sources are used for PES and depending on its energy the inspection region in terms of energy varies. For example, ultraviolet photoemission (UPS) which is mainly for the angle-resolved investigation of valence band states (ARUPS), uses the light source that has photon energy of about 10-50 eV often produced by discharge lamps with rare gases like helium (HeI_{α} : 21.23 eV, HeII_{α} : 40.82 eV). On the other hand, aluminum ($\text{Al-K}_{\alpha 1,2}$: 1486.6 eV) and magnesium ($\text{Mg-K}_{\alpha 1,2}$: 1253.6 eV) anodes are often used for X-ray photoemission spectroscopy (XPS) to investigate the core-level states at higher binding energies [44-47].

The principle of a modern photoemission spectrometer is represented in the Figure

2.10.(a). Monochromatic photons with energy $h\nu$ produced by a light source are directed on the sample surface. Then the kinetic energy E_{kin} of the photoelectrons and the acceptance angle θ and other parameters are recorded by electrostatic analysers. Figure 2.10.(b) describes the photoemission process in the single-particle picture. We see that the electrons with binding energy E_B are excited above the vacuum level E_{vac} with the incident photon energy higher than the sum of binding energy and work function. The photoelectron distribution $I(E_{kin})$ can be measured by counting emitted electrons and can be reproduced as an image of occupied density of electronic states $N(E_B)$ [48].

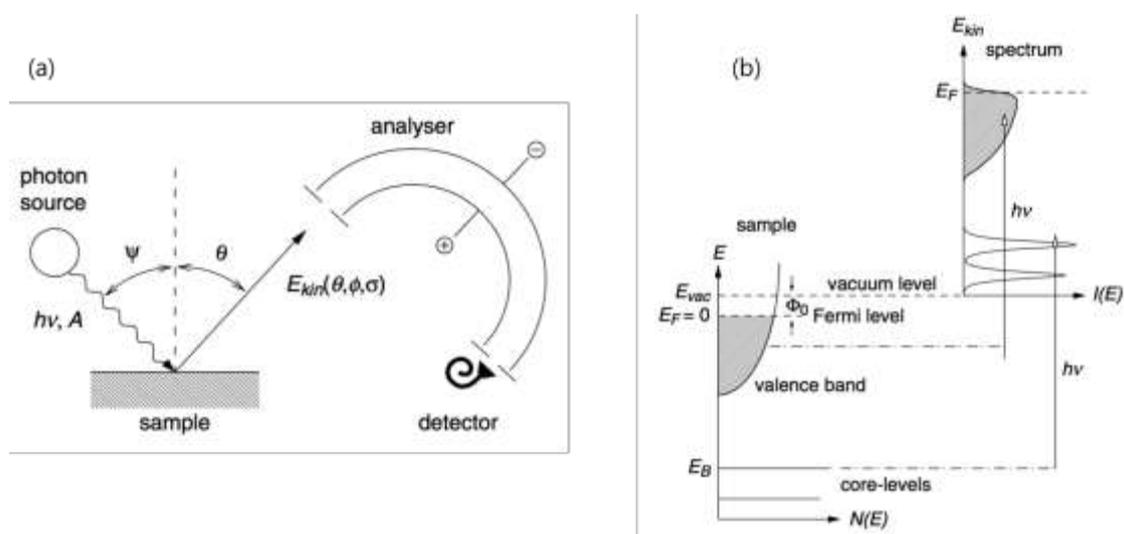


Figure 2.10. (a) Principle of a modern photoemission spectrometer. (b) Schematic view of the photoemission process in the single-particle picture [36].

2.3.4.2 X-ray Photoelectron Spectroscopy (XPS)

XPS is the most widely used surface analysis technique because of its simplicity in use and data interpretation. It is also known as Electron Spectroscopy for Chemical Analysis (ESCA) since the elements composition on the sample surface can be analyzed by this technique. XPS uses soft x-rays with a photon energy of 200~2,000 eV as a source of exciting radiation while aluminum (Al- $K_{\alpha 1,2}$: 1486.6 eV) and magnesium (Mg- $K_{\alpha 1,2}$: 1253.6 eV) anodes are the most commonly used sources [44-47]. There is a characteristic binding energy for every element associated with each core atomic orbital. Thus the presence of peaks at

particular energies indicates the presence of a specific element. The intensity of the peaks is related to the concentration of the element such that the quantitative analysis of the elements composition on the sample surface can also be carried out.

2.3.4.3 Ultraviolet Photoelectron Spectroscopy (UPS)

UPS generally uses the light source that has photon energy of about 10-50 eV. The helium (HeI_α : 21.23 eV, HeII :40.82 eV) gas discharge lamp is the most commonly used source [44-47]. Unlike XPS, such low energy source is only capable of ionizing electrons from the outermost levels of atoms correspond to the valence levels, but it measures them with better accurately [48]. With HeI_α (21.23 eV) source Turner's group obtained an energy resolution of up to 0.02 eV. In addition, angle-resolved measurement of UPS enables understanding of the complete band structure in k-space.

2.3.4.4 Angle-resolved photoemission spectroscopy (ARPES)

Figure 2.11. shows a typical experimental photoemission process for the ARPES measurement system. Monochromatic laser having energy $h\nu$ is incident on the sample and the detector detects electrons coming from the sample by the photoemission process. The kinetic energy and the emission angle of the electrons are then recorded at the same time.

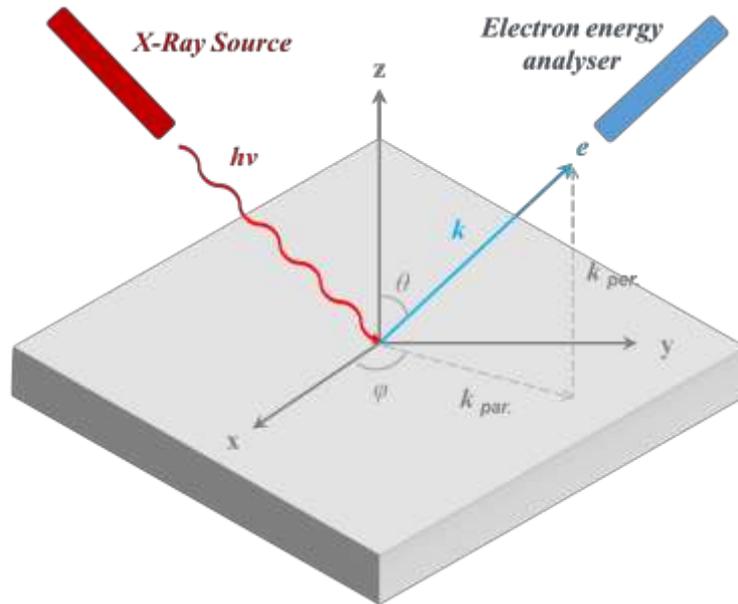


Figure 2.11. Schematic diagram of photoemission process on the sample surface

This photoemission process is commonly explained by the three-step model [49] :

- (i) Optical excitation of the bulk electron
- (ii) Travel of the excited electron to the surface
- (iii) Emission of the photoelectron under vacuum

For the first step, the monochromatic laser with energy $h\nu$, excites the electron from an occupied state to an unoccupied state. On the second step, this excited electron travels to the surface with the probability concerning its mean free path. Electrons undergoes inelastic scattering during this travel would finally be recorded as a continuous background of the photoemission spectra. Once the electron reaches the surface having enough energy to overcome the work function of the material, for the last step, it is emitted to the vacuum so that the corresponding photoemission spectra are recorded.

Experimentally, the kinetic energy of the photoelectrons with their polar (θ) and azimuthal (φ) emission angles represented in the Figure 2.11. are the three main quantities measured in a photoemission experiment.

Figure 2.12. shows a simplified image for explaining the energy conservation law in the photoemission process where the measured kinetic energy of the emitted electrons can be simply related to incident light energy by

$$E_{kin} = h\nu - \varphi - |E_B| \quad (5)$$

E_{kin} denotes the electron kinetic energy and $h\nu$ is the energy of the incident light. φ stands for the work function of the material that is the minimum energy required for electrons to escape from Fermi level to the vacuum while E_B corresponds to the binding energy of the electron.

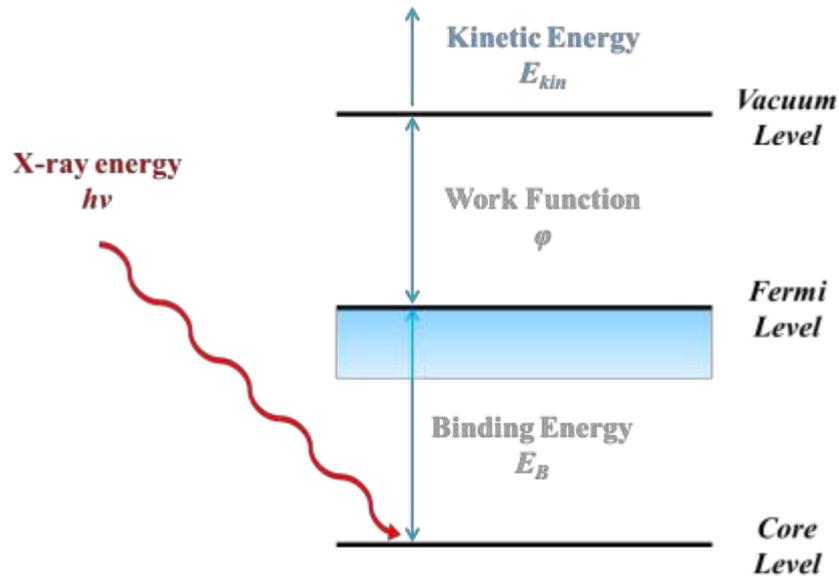


Figure 2.12. Incident X-ray energy and kinetic energy of emitted electrons

Through the photoemission process explained by the three-step model with such energy conservation, the momentum parallel to the surface is also conserved. The emitted electron momentum can be described as:

$$P_{\parallel} = \hbar k_{\parallel} = \sqrt{2mE_{kin}} \cdot \sin\theta \cdot \sin\varphi \quad (6)$$

where P_{\parallel} and k_{\parallel} are the momentum and the wave vector parallel to the surface respectively. The lattice constant of graphene, or 2.45 \AA , gives the first Brillouin zone boundary of 2.56 \AA^{-1} while the wave vector of the photon corresponding to 50 eV is about 0.025 \AA^{-1} . This value is less than 1% of the first BZ, hence the photon momentum with its energy lower than 50 eV is almost negligible.

In our measurement, the kinetic energy of photo electrons and corresponding intensity were recorded with varying analyser acceptance angle, θ . φ was fixed for the whole measurement and therefore parallel wave vector k_{\parallel} could have been directly deduced from $\hbar k_{\parallel} = \sqrt{2mE_{kin}} \cdot \sin\theta$. Binding energy, E_B could also be simply calculated from $E_{kin} = h\nu - \varphi - |E_B|$. Finally, the result of our measurement is expressed by a two-variable photocurrent function $I(E_B, k_{\parallel})$.

2.3.4.5 Auger electron spectroscopy (AES)

Auger electron spectroscopy (AES) is another PES technique based on Auger effect. The Auger effect is an electronic process resulting from the electron transitions in an excited atom. In an atom, excited by the light source with energies in the range of several eV to 50 keV, a core level electron can be removed leaving behind a hole resulting in an unstable state. As an outer shell electron fills the core hole, it loses an amount of energy equal to the orbital energy difference. The transition energy can be coupled to a second outer shell electron, which will be emitted from the atom if the transferred energy is greater than the orbital binding energy. [50-55] An emitted electron has a kinetic energy of:

$$E_{kin} = E_{Core} - E_{1OS} - E_{2OS} \quad (7)$$

where E_{Core} , E_{1OS} , E_{2OS} are the core level, first outer shell, and second outer shell electron binding energies respectively.

2.3.4.6 Electron energy loss spectroscopy (EELS)

Like above stated other PES techniques, in electron energy loss spectroscopy (EELS) a sample is exposed to a beam of electrons with a known, narrow range of kinetic energies.

Most of the incident electrons undergo elastic scattering while some of them will undergo inelastic scattering. Inelastic interactions can happen via various way including phonon excitations, inter and intra band transitions, plasmon excitations, inner shell ionizations, and so on. Electrons undergone such inelastic scattering are slightly and randomly deflected from the incident direction and lose that much of energy. The amount of such energy loss can be measured by an electron spectrometer. EELS analysis is based on the interpretation of this measured energy loss

2.4 Conclusions

Since the required physical properties and the overall quality of the graphene films differ depending on the various applications, preparing appropriate material is of great importance for a certain device application. Hence, understanding various synthesizing methods and characterization techniques are indispensable as a preliminary step for preparing appropriate graphene for the device applications.

The best quality graphene in terms of structural integrity and electronic performance can be mechanically exfoliated from HOPG sheet, but the micrometer-scale sheet size limit and the low production yield are crucial drawbacks for device applications. High production yield can be achieved by chemical exfoliation method, but the structural defects and the chemical contaminations generated during the process are inevitable. Graphene can also be epitaxially grown on SiC substrate that does not require subsequent transfer process for the device applications. Large area and low-cost single or few layer graphene can be synthesized on the surface of transition metal (*e.g.*, nickel, copper, cobalt, palladium) substrates by CVD process. On the other hand, high process temperature near 1,000 °C is a critical issue in terms of industrial aspects. Many efforts on the optimization of the PECVD process conditions result in lowered process temperature around 500 °C. Since the graphene films synthesized by CVD process are on the transition metal substrate, subsequent transfer process onto the final insulating substrate is required for the most of electronic device applications.

Once synthesized, it is necessary that graphene films are characterized to understand its electrical and physical properties for further device applications. Optical microscopy can be simply used to locate graphene layers by comparing the image contrast and optical transmittance measurement. SEM visualize the secondary electrons generated by the interaction between incident electrons and the target sample. The image taken by SEM provides useful information especially for polycrystalline graphene such as its location on the substrate, grain boundaries and structural deformations. AFM is widely used for the surface morphology study, but compared with SEM, it requires relatively longer time on the limited spot of the sample for obtaining one decent image. TEM provides useful information about material crystallinity but requires destructive pre-treatment of the sample. Raman spectroscopy is the most powerful and popular technique for investigating the structural and

electronic characteristics of carbon nanomaterials because it is simple and non-destructive. Generally, three major peaks are employed for characterizing graphene quality: D peak at $\sim 1,350\text{ cm}^{-1}$, G peak at $\sim 1,580\text{ cm}^{-1}$, and 2D peak at $\sim 2,700\text{ cm}^{-1}$. PES techniques including XPS, UPS, ARPES, AES and EELS are extensively used as the important techniques to study the electronic structure and chemical compositions of molecules, solids and surfaces.

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Chapter III

Prepared Graphene

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Chapter III. Prepared Graphene

3.1 Prepared graphene

In this chapter, we briefly describe the preparation of the graphene samples that were further investigated in thesis and give some of the characterization results. The different types of graphene samples are summarized in the Figure 3.1.. The LPICM graphene is synthesized by interfacial PECVD technique [1]. We used two of the samples from other labs: one is from Laboratoire de Photonique et Nanostructures (LPN) prepared by epitaxial growth [2] and the other is from Thales R&T synthesized by CVD and transferred to Si wafer. At the same time, commercial graphene samples are also used where all the graphene layers are synthesized by conventional CVD process and transferred either to glass or Si wafer substrates with 285 nm of SiO₂ layer on it [3-5]. In what follows, since the conventional CVD process can explain well the growth process of commercial graphene and the graphene from Thales [3-5], we simply describe the process of the PECVD interfacial graphene from LPICM and that of the epitaxial graphene from LPN.

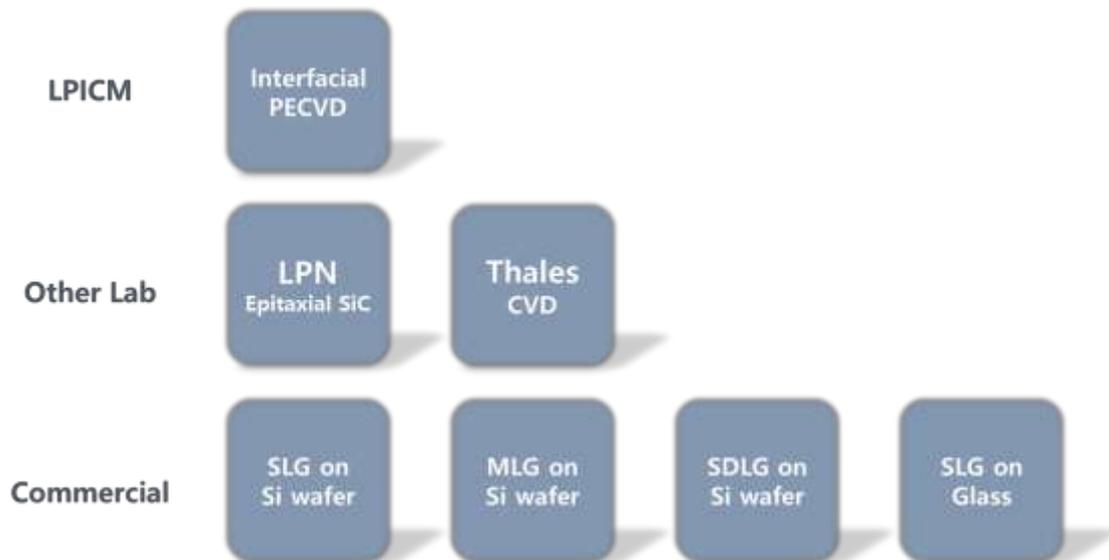


Figure 3.1. Graphene samples prepared in various ways for this thesis

3.1.1 PECVD interfacial graphene growth (LPICM)

Except epitaxially synthesized graphene on SiC substrate, most of growth techniques essentially require metal substrate to decompose hydrocarbon gas and to conduct low temperature crystallization of carbon atoms. Once graphene is synthesized on such metal substrate, it is supposed to be transferred onto another insulating substrate for most of electronic device applications. For example, for CVD graphene, usually the synthesized layer is covered by polymethyl methacrylate (PMMA) and detached together from metal substrate to be transferred onto insulating substrate (see < 2.2.3.2 Transfer of Graphene > for further details).

However, this transfer process has many drawbacks such as surface contamination originating from PMMA [6,7], structural deformation (*e.g.*, wrinkles, cracks, defects) of graphene layer [8] and it is even quite sophisticated process that requires appreciable time and cost [9]. For these reasons, direct growth of graphene on insulating substrate is desirable in terms of device applications for many researchers.

In LPICM, by using home-made triode type PECVD system we could directly grow graphene on the insulating substrates such as silicon wafer covered with SiO₂, and glass. Figure 3.2. shows a schematic diagram of the PECVD system.

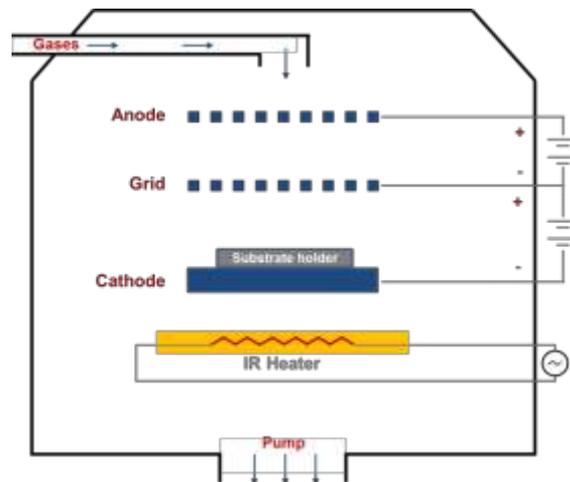


Figure 3.2. Schematic diagram of triode type PECVD system at LPICM

Firstly, the substrate is chemically cleaned by piranha solution ($\text{H}_2\text{SO}_4:\text{H}_2\text{O}_2 = 3:1$), a mixture of sulfuric acid (Sigma Aldrich, 339741, 99.9%) and hydrogen peroxide for 30 minutes at 150 °C. After being rinsed by deionized (DI) water, it was dried by nitrogen and placed in the home-made evaporator chamber. Before the metal evaporation, substrate was again cleaned by Ar plasma. Then 200 nm of Ni thin film is directly deposited on the substrate under ultra high vacuum (UHV) conditions by e-beam evaporation. Prepared metal substrate is subsequently transferred to the PECVD system and is placed on the cathode substrate holder made of graphite. The system is then pumped out to its base pressure of $\sim 2 \times 10^{-6}$ mbar and the substrate temperature is raised up to 450 °C. Then 10 sccm of H_2O and 3 sccm of isopropyl alcohol (IPA) are introduced into the chamber and the plasma is ignited when the pressure reaches around 2 mbar by launching the DC generator connecting the anode and the grid. To extract the plasma another DC generator connecting the grid and the cathode is also activated with an extraction current fixed at 54 mA. The plasma is turned off after 20 minutes and during the last cooling step of the process, carbon atoms dissolved in metal layer diffuse out both to the metal surface and the interface between metal layer and the glass or silicon wafer. Finally, the nickel layer is wet etched by commercial Ni etchant (Nickel Etchant TBF-Transene) and the as-grown graphene films remain on the substrate. Figure 3.3. represents simplified steps of growth process.

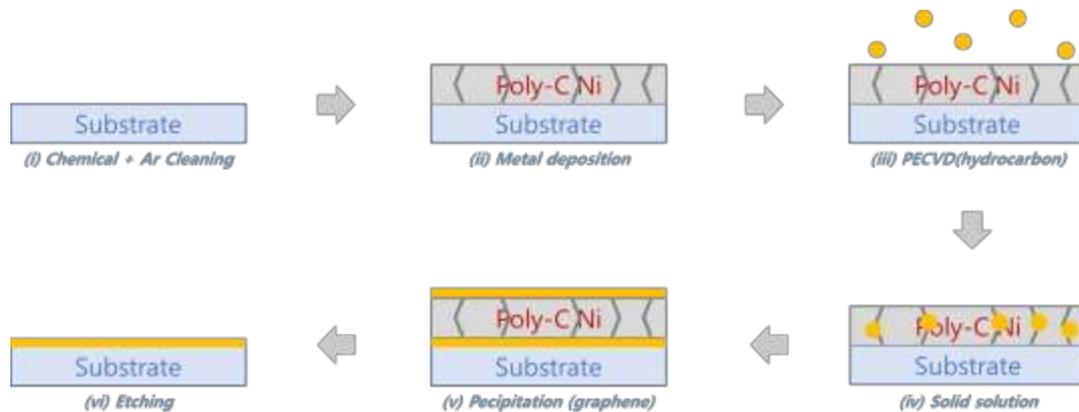


Figure 3.3. Interfacial graphene growth process: (i) substrate cleaning, (ii) metal evaporation on the substrate, (iii) PECVD at 450 °C, (iv) carbon dissolved in the metal layer, (v) precipitation of carbon atoms, (vi) wet etching of Ni layer

3.1.2 Epitaxial graphene (LPN)

Epitaxial graphene is grown by solid state graphitization on the off-axis 4H-SiC (0001) wafer. The substrate is etched by 100% H₂ at 1,550 °C to produce well-ordered atomic terraces of SiC. In order to avoid any effects from the native oxide and possible surface contamination, the Si-face SiC (0001) surfaces are deoxidized at 820 °C under semi-vacuum conditions. After this surface treatment, the sublimation of Si atoms is carried out by radio frequency (RF) heating of the SiC substrate that results in carbon enriched surface[10,11]. Then the sample was cooled down to room temperature (RT) for the graphitization [2].

3.2 Graphene Characterization

Prepared graphene samples are characterized with previously stated characterization techniques. Firstly, Hitachi S-4800 FE-SEM and Veeco, Dimension™ 3100 AFM systems are used for the SEM surface investigation. However, since our graphene layers are all continuous and have large area ($> 1 \text{ cm}^2$), unlike mechanically exfoliated graphene flakes, surface characterization is not very useful in terms of detecting graphene location for our samples. Nevertheless, some wrinkles, contaminations or height differences for different number of layers could be characterized. Figure 3.4. shows SEM images of commercial multi-layer graphene (MLG) and single and double layer graphene (SDG) samples taken at our lab. The wrinkles and the contaminations formed during synthesis and transfer process of MLG are highlighted in the Figure 3.4.(a). SDG is basically single layer graphene with 10 to 30 % coverage of bilayer graphene islands and those are marked in the Figure 3.4.(b) as darker area.

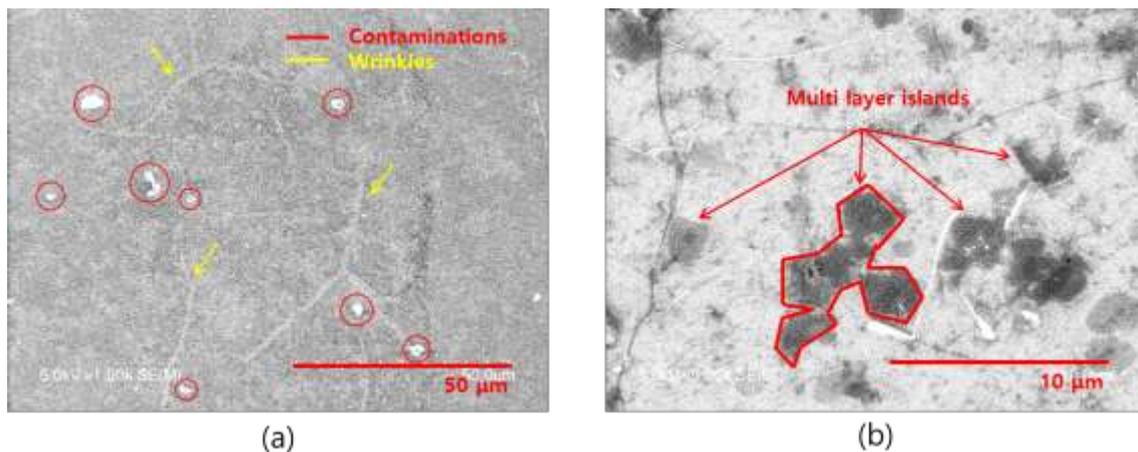


Figure 3.4. SEM image of (a) multi-layer graphene with wrinkles and contaminations and (b) single and double layer graphene

Figure 3.5. is an AFM image of the epitaxially grown graphene SiC substrate that is synthesized and provided by CNRS-LPN (Laboratoire de Photonique et de Nanostructures). The measured height difference shown on the image is around 0.35 nm which is consistent with the theoretical interlayer spacing between graphene layers, 0.335 nm [6,13].

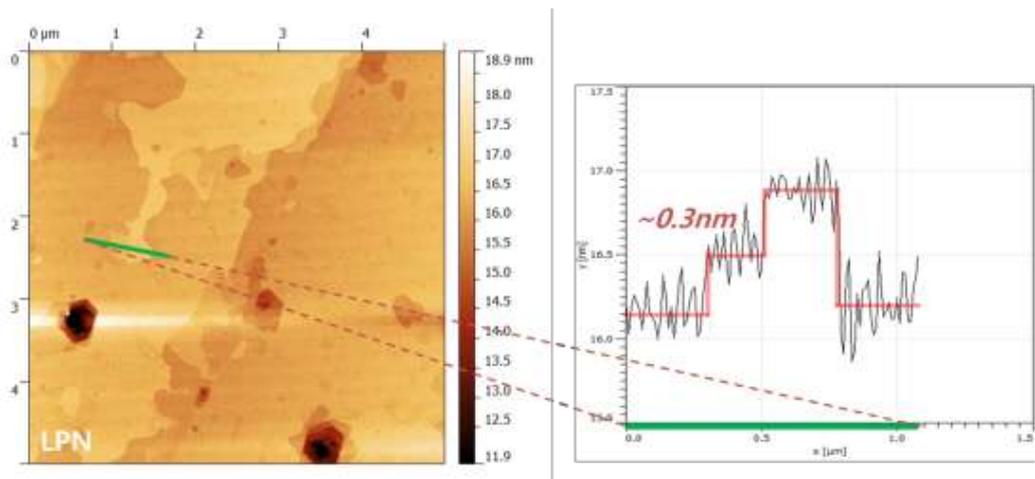


Figure 3.5. AFM image of the epitaxially grown graphene on SiC substrate

Raman spectra of commercial single/multi-layer graphene (SLG/MLG) on SiO₂ layer measured by Labram HR800 in LPICM is shown in the Figure 3.6.. Measurement is carried out with the 532 nm excitation laser. Both two spectra have weak D peak at $\sim 1350\text{ cm}^{-1}$ indicating small defect density and have clear G peak at $\sim 1580\text{ cm}^{-1}$ representing sp^2 carbon bonds. On the other hand, 2D peak around $\sim 2700\text{ cm}^{-1}$ for SLG is sharp and high intensity comparable to that of G peak, while MLG has broad and less intense 2D peak. At the same time, the slightly red shifted G peak [14] and the blue shifted 2D peak [15] of MLG compared to SLG is well consistent with the results we could easily find on the literature.

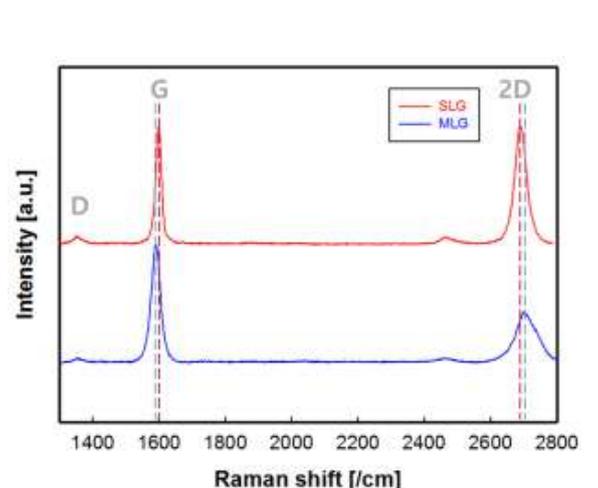


Figure 3.6. Raman spectra of SLG and MLG with the excitation laser wavelength of 532 nm.

3.3 Conclusions

Most of graphene growth techniques essentially require metal substrate to decompose hydrocarbon gas and to conduct low temperature crystallization of carbon atoms. This generally requires subsequent transfer process onto another insulating substrate for most of electronic device applications. The transfer process has many drawbacks such as surface contamination, structural deformation of graphene layer and it is even quite sophisticated process that requires appreciable time and cost. Using home-made triode type PECVD system, graphene is directly grown on the insulating substrates such as silicon wafer covered with SiO₂, and glass so that it can be employed to various electronic device applications.

Prepared graphene films are characterized with previously stated characterization techniques to understand their quality before employed for the device fabrication. Depending on the synthesis method and the type of graphene, characterized films

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Chapter IV

Electrical Characterization

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Chapter IV. Electrical Characterization

4.1 Device fabrication

4.1.1 Generalities

For the realization of a gas sensing device based on graphene as an active material, two main device configurations are widely used. First one is the resistive graphene type sensor that transduces device resistance changes induced by adsorbing gas molecules. The other type is the transistor type sensor that transduces the drain current changes upon exposure to the target gas molecules. Both types of devices have specific advantages which were previously stated in chapter 1. In our study, we focused on the resistive type sensor rather than transistor type because :

- Firstly, resistive type sensor has very simple device fabrication process. Once the graphene layer is ready, metal electrodes can be directly deposited on its surface by various means (evaporation, ink-jet printing, etc.) in various sizes whilst for transistor type device realization, much more sophisticated photo-lithography process is necessary.
- Secondly, unlike for transistor type fabrication, relatively lower quality graphene can be successfully employed for the resistive type device. Also if for the transistor type devices, mechanically exfoliated graphene is commonly used which implies that generally the size of the graphene layer is limited to few (or tens of) micro meters, by contrast, resistive type devices can be realized virtually on any type of graphene layers independently of the synthesis methods.

Thanks to its simplicity in fabrication process and possible use of large area graphene, graphene based resistive type sensors can thus be produced at lower cost than any other types of graphene based sensors.

4.1.2 Graphene (interaction) on the substrate

It is well known that the SiO₂ substrate plays important role in the doping of graphene.

Regardless their synthesis methods, most of the graphene layers transferred onto the SiO₂ substrate were reported to be p-doped [1-3]. To the best of our knowledge, this p-doping is related to the interfacial H₂O and O₂ molecules existing in between graphene and the substrate. Before transferring graphene, usually the SiO₂ surface is cleaned either by chemical solutions such as piranha or by dry plasma treatment. However, even after such cleaning process, a layer of Si-OH still exists on the SiO₂ surface [2]. This layer provides hydrogen bonding spots that enable doping molecules such as H₂O and O₂ to be easily settled on the SiO₂ surface (Figure 4.1.). In 2007, Verdaguer et al. have reported that they verified by Kevlin probe microscopy and X-ray spectroscopy the existence of four or five water layers on the SiO₂ surface [3].

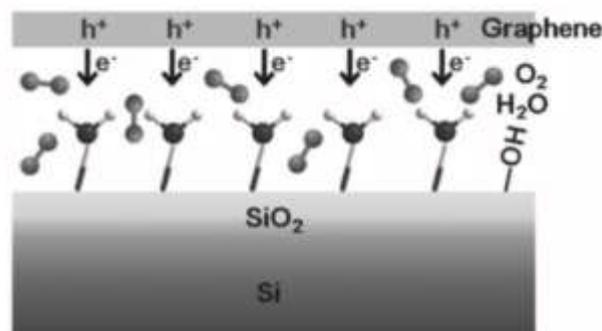


Figure 4.1. Interfacial Si-OH layer forming hydrogen bond with H₂O and O₂ molecules responsible for p-doping

4.1.3 Contact electrode deposition

Contacting electrodes deposition is one of the most important steps in the device fabrication process. Various factors have to be carefully considered such as the shape and the size of the electrodes, the choice of metal and so on. Since generally the graphene films synthesized by CVD process are polycrystalline, the grain boundaries may play a negative role in charge transport. In addition, surface contaminations through the deposition process can also be detrimental to the charge transport of the graphene film. For averaging out such unfavorable limited charge transport, it is preferable to use an electrode configuration with a relatively large gap, well exceeding the average grain size (typically of micrometer-scale). In

what follows, the three different electrode deposition techniques used in this work are briefly introduced.

4.1.3.1 Inkjet printing

Metal electrodes could have been directly deposited onto the graphene surface by ink-jet printing. We used a Dimatix DMP-2800 printer with INKTEC TEC-IJ-010 silver ink for printing 4 identical metal electrodes on the surface. Figure 4.2. is the optical image of the silver electrodes deposited on to the surface of a graphene film synthesized by the interfacial PECVD process. The working temperature of printing nozzle's the cartridge and the substrate was maintained at 40 °C and 45 °C respectively for the two deposited layers of silver electrodes. The sample was annealed at 150 °C for 30 minutes after printing the electrodes in order to effectively evaporate the solvent and to firmly fix the electrodes on the surface.

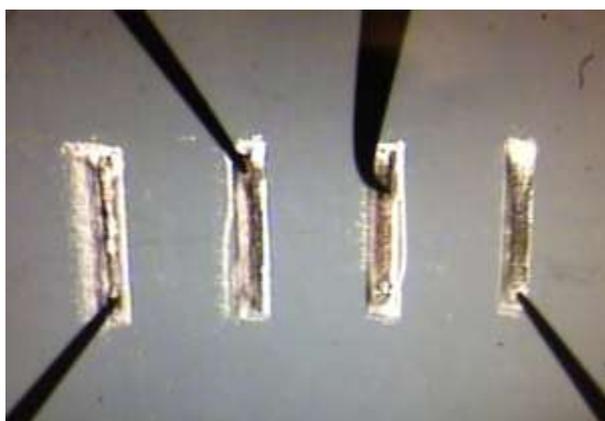


Figure 4.2. Ink-jet printed silver electrodes

Ink-jet printing is a very simple and fast process for depositing electrodes. Besides it does not require other intermediate preparative processes thus preserving the graphene from unexpected contaminations. However, the selection of the solvent and the soluble metal for preparing the ink may limit the possible choice of metals for the electrodes. In addition, the maximum repositioning resolution that we could reach with our experimental set-up was about 50 μm which might not be enough for sophisticated device configurations. Furthermore, ink-jet printing still needs to be further optimized with various experimental conditions such

as substrate and the cartridge temperatures, printing speeds and the patterns dimensions, the number of printed layers and so on. Once all these conditions optimized and well controlled, the ink-jet printing approach would be an excellent way to low cost fabrication of simple devices such as resistive type graphene sensors for the future use.

4.1.3.2 Photo-lithography

The second technique we have developed for the contact electrodes deposition on the graphene is the photo-lithography which is one of the most common and powerful patterning process in modern semiconductor manufacturing techniques. The Figure 4.3. shows the process and an optical view of Ti/Au (5 nm/35 nm) electrodes patterned by the photo-lithography process on the single layer graphene.

Before the process, graphene was chemically cleaned. It was dipped in acetone and propanol for 5 minutes each and dried. Commercial positive photo-resist (PR), SPR 700 is then spin-coated (4000 rpm, 30 sec) on the graphene surface and annealed at 110 °C for 5 minutes. Then it was exposed to UV lamp (10 mW, 5 sec) subsequently commercial developer MF 319 was used for developing the pattern. Metal deposition is performed by e-beam evaporation and finally the lift-off process is carried out for 30 minutes in acetone.

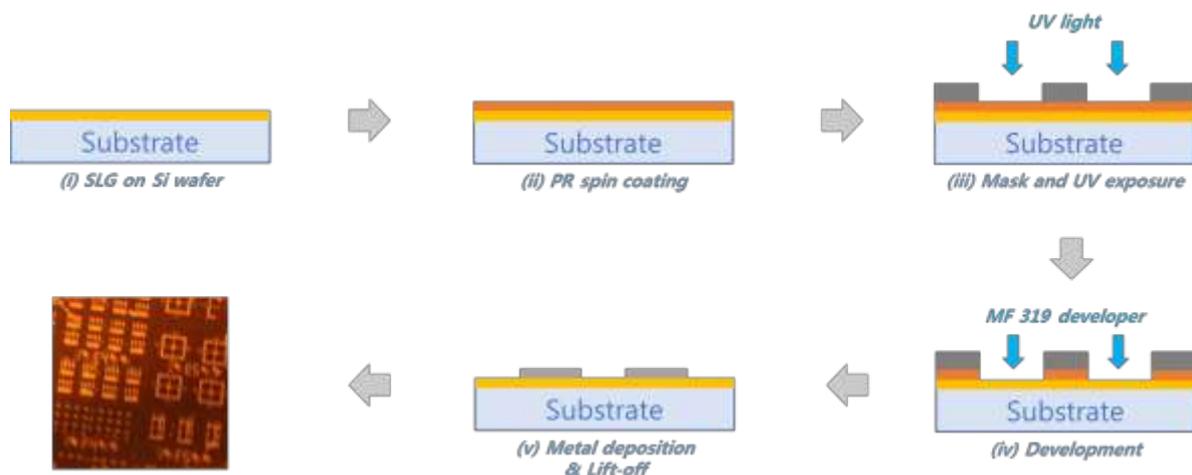


Figure 4.3. Photo-lithography process

Photo-lithography is a typical method for sophisticated patterning of semiconductor

devices. However, because of its relative complexity, residual chemical contamination is inevitable which may affect electrical properties of the final fabricated devices.

4.1.3.3 Shadow-mask metal Evaporation

The metal electrodes can be directly patterned (for pattern's critical dimensions of more than 10 micrometers) and deposited on the graphene surface by thermal/e-beam metal evaporation process through a shadow mask. Figure 4.4. presents the schematic diagram of the mask used for the evaporation (Figure 4.4.(a)) and the optical image of the deposited electrodes on the graphene surface (Figure 4.4.(b)). The gap between the four electrodes and the electrode's width were 100 μm . Several metals were chosen for the evaporation such as Co, Ni and Cr/Au. Most of the devices were realized with the Cr/Au electrodes where the thin Cr layer (~ 10 nm) is to support the adhesion of Au electrodes on the surface. Metal evaporation allows avoiding possible chemical contaminations that can easily take place when the electrodes are patterned by lithography process.

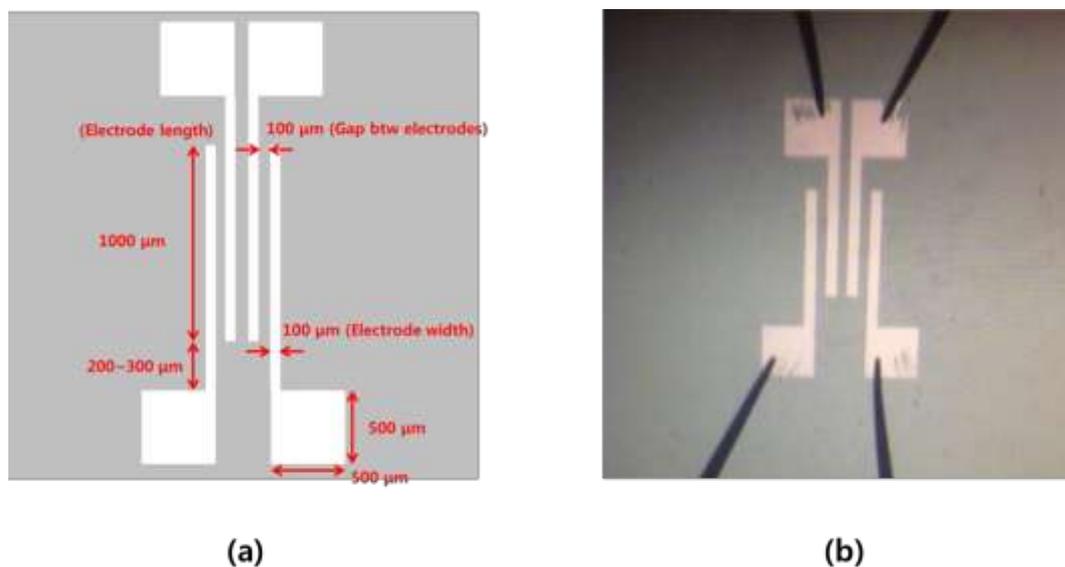


Figure 4.4. (a) Schematic diagram of the mask and (b) the optical image of the metal electrodes on the graphene surface.

4.2 Four-electrode electrical measurements

4.2.1 Four-probe measurement

To begin with, it is useful to start from the definition of two terms that are sometimes easy to be confused: resistivity and sheet resistance. Resistivity is an intrinsic physical property of any material that is independent of the amount or shape of it. Besides, it has an inverse relation with the material conductivity. Resistivity stands for the linear transport coefficient in Ohm's Law:

$$E = \frac{1}{\sigma} j = \rho j \quad (7)$$

where, E is the electric field in V/cm and j is the current density in A/cm^2 . σ is the conductivity and ρ is the resistivity that has an unit Vcm/A or Ωcm .

On the other hand, sheet resistance R_s is a characteristic property of a material with a thin film morphology. The unit for the sheet resistance can either be expressed as Ω/sq or Ω/\square . However this unit does not actually mean ohms per unit area. Here 'per square' means any square unit of film regardless of its size. Thus, the sheet resistance depends on the film thickness rather than the area. We can relate the sheet resistance with the resistivity by

$$R_s = \frac{\rho}{x_f} \quad (8)$$

where, x_f denotes the thickness of the film. Although the material resistivity varies vertically, the sheet resistance remains well-defined so that the measured sheet resistance can be considered as a parallel combination of stacked thin films with their uniform resistivity.

A schematic diagram of the current injection from a single tip probe to a bulk semiconductor substrate is represented in the Figure 4.5.. Here the substrate is assumed to be semi-infinite and we ignore any substrate effects. Then the current diverges from the tip of the probe into the substrate volume through a series of concentric hemispherical shells of equipotential. The current density through each shell can be simply calculated by dividing

total current by the surface area of the hemisphere or $I/2\pi r^2$. Given that the potential drop ΔV and the shell thickness Δr , the electric field across each hemispherical shell can be represented as $-\Delta V/\Delta r$. The negative sign indicates the potential decrease for increasing radius. If we re-write Ohm's law with above parameters:

$$E = -\frac{\Delta V}{\Delta r} = \rho \frac{I}{2\pi r^2} \quad (9)$$

As the shell thickness approaches to zero, we integrate the equation from a certain point 'a' to the origin:

$$\int_a^0 dV = \int_a^0 -\rho \frac{I}{2\pi r^2} dr \quad (10)$$

$$V_0 - V_a = \frac{\rho I}{2\pi} \left(\frac{1}{r_0} - \frac{1}{r_a} \right) \quad (11)$$

If we accept r_a to be infinite and V_a falls to zero for infinite r_a , the equation becomes:

$$V = \frac{\rho I}{2\pi r} \quad (12)$$

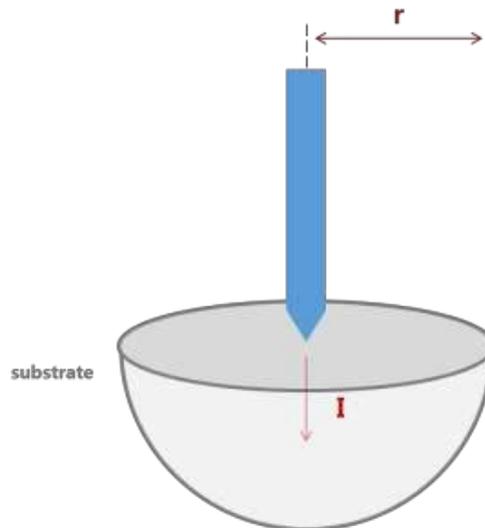


Figure 4.5. Current injection into a bulk substrate from a single probe

Now we apply the same calculation to a thin film semiconductor. We suppose that the thickness of the film is limited to x_f , and a single probe is injecting a current I into the film (Figure 4.6.). The current injected from the probe diverges through a series of cylindrical plates and then the current density in this case is $I/2\pi rx_f$. Ohm's law can then be modified as:

$$E = -\frac{\Delta V}{\Delta r} = \rho \frac{I}{2\pi r x_f} = R_s \left(\frac{I}{2\pi r} \right) \quad (13)$$

We again integrate the equation from a certain point 'a' to the origin:

$$\int_a^0 dV = \int_a^0 -R_s \left(\frac{I}{2\pi r} \right) dr \quad (14)$$

$$V_0 - V_a = \frac{IR_s}{2\pi} \left(\ln \frac{1}{r_0} - \ln \frac{1}{r_a} \right) = \frac{IR_s}{2\pi} (\ln r_a - \ln r_0) \quad (15)$$

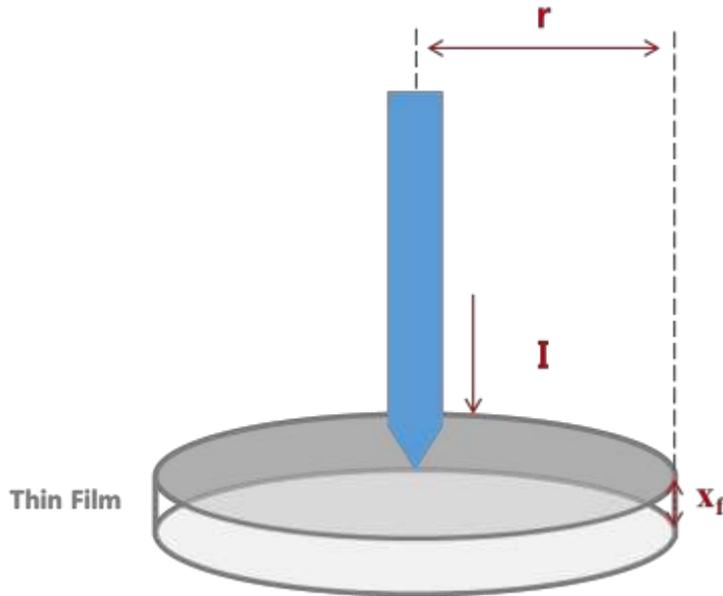


Figure 4.6. Current injection into a thin film semiconductor from a single tip probe

At this point, we expand this current injection calculation to the four-probe measurement configuration. Assume that four identical probes are all aligned in a line,

equally spaced with a certain distance, g (Figure 4.7.). For the measurement, we flow the current through the outer two probes labeled 1 and 4 and measure the potential drop between the inner two probes labeled 2 and 3. Therefore the current injection occurs at the tip of the probe 1 and it leaves the material through probe 4:

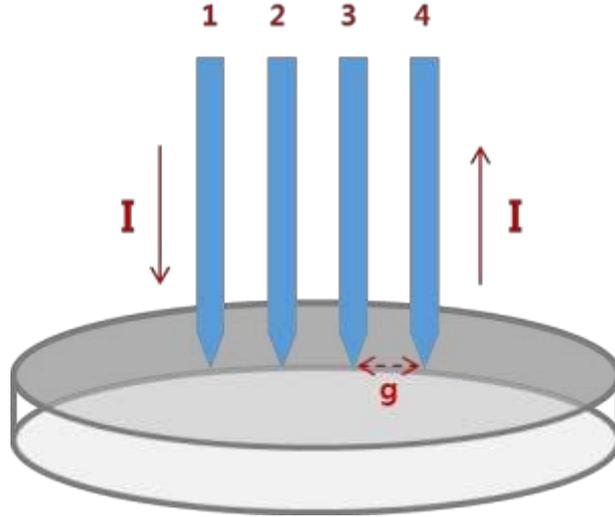


Figure 4.7. Schematic diagram of the four-probe measurement

We recall that the potential at any point within the material can be expressed as a superposition of the contribution from each probe. Thus, using single probe injection to bulk substrate, the measured potential at any point, r can be expressed as a sum of the positive potential from the probe 1 and the negative potential from the probe 4:

$$V_r = \frac{\rho I}{2\pi} \left(\frac{1}{r_1} - \frac{1}{r_4} \right) \quad (16)$$

where, r_1 and r_4 represent the distance from the probe 1 and the probe 4 respectively. From this we can derive the potential drop between the probe 2 and 3:

$$\Delta V = V_2 - V_3 = \frac{\rho I}{2\pi} \left(\frac{1}{g} - \frac{1}{2g} \right) - \frac{\rho I}{2\pi} \left(\frac{1}{2g} - \frac{1}{g} \right) = \frac{\rho I}{2\pi g} \quad (17)$$

In practice, this can be rearranged in terms of resistivity as follows:

$$\rho = 2\pi g \left(\frac{\Delta V}{I} \right) \quad (18)$$

Applying the same calculation steps to the thin film case, the measured potential at any point, r can be expressed as:

$$V_r = \frac{IR_s}{2\pi} (\ln r_4 - \ln r_1) \quad (19)$$

here, r_1 and r_4 represent the distance from the probe 1 and the probe 4 respectively and the potential drop between the probe 2 and 3 is then:

$$\Delta V = V_2 - V_3 = \frac{IR_s}{2\pi} (\ln 2g - \ln g) - \frac{IR_s}{2\pi} (\ln g - \ln 2g) = \frac{IR_s}{\pi} \ln 2 \quad (20)$$

By rearranging the equation in respect to the sheet resistance R_s , we obtain:

$$R_s = \frac{\pi}{\ln 2} \left(\frac{\Delta V}{I} \right) \approx 4.53 \cdot \left(\frac{\Delta V}{I} \right) \quad (21)$$

The result equation is often used as an expression of the sheet resistance for a four-probe measurement of the thin film semiconductor. Here the spacing between each probe, g is canceled out through the calculation. Hence, the sheet resistance remains the same irrespective of the spacing g , as long as the four probes are equally spaced and the spacing, g is larger enough than the film thickness.

4.2.2 Four-electrode measurement

In our device the electrodes are deposited with a certain configuration. However, the sheet resistance presented in the previous paragraph is based on the four-probe measurement

that does not effectively concern the geometry of the electrodes. For obtaining more accurate sheet resistance taking account of the geometry of the electrodes, we first simplified the electrodes to four identical rectangles (Figure 4.8.).

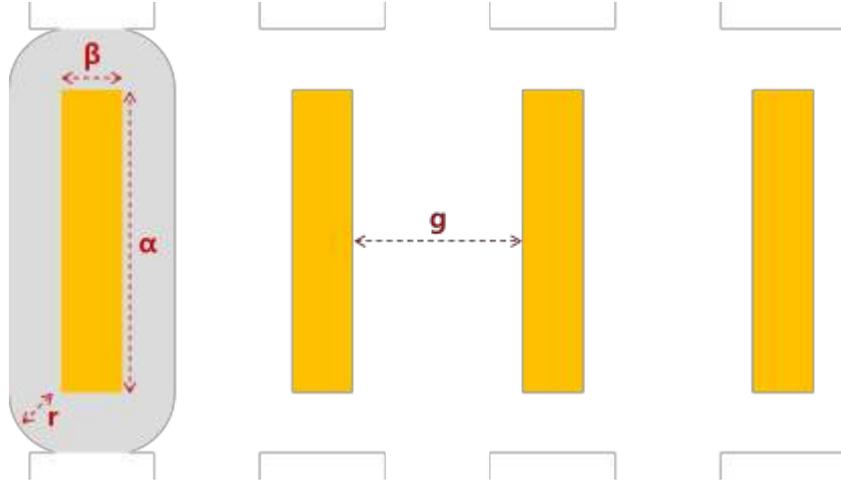


Figure 4.8. Simplified four identical electrodes

The height and the width of the electrodes are α and β respectively and the thickness of the material is x_f . Then the current density can be expressed as:

$$j = \frac{I}{(2\pi r + 2\alpha + 2\beta)x_f} \quad (22)$$

By rearranging Ohm's law with this current density, j , we obtain:

$$E = -\frac{\Delta V}{\Delta r} = \rho \frac{I}{(2\pi r + 2\alpha + 2\beta)x_f} = R_s \left(\frac{I}{2\pi r + 2\alpha + 2\beta} \right) \quad (23)$$

with all the same calculations including the integration and the superposition of the potential contributions, the result equation is then:

$$R_s = \frac{\pi}{\ln \left(\frac{\alpha + \beta + 2g\pi}{\alpha + \beta + g\pi} \right)} \cdot \left(\frac{\Delta V}{I} \right) \quad (24)$$

From this equation we can simply obtain the sheet resistance by putting the slope of $V-I$ curve recorded from four-probe measurement. For example, the Figure 4.9. shows a $V-I$ curve for the one of our devices with the Co electrodes deposited by metal evaporation on the commercial SLG on the silicon wafer. α , β and g are 1,500 μm , 400 μm and 150 μm respectively while the slope($\Delta V/I$) is about 78 ohms. Hence the equation eventually gives:

$$R_s = 17.36 \cdot \left(\frac{\Delta V}{I}\right) = 17.36 \cdot (78) = 1,354 \Omega/\square \quad (25)$$

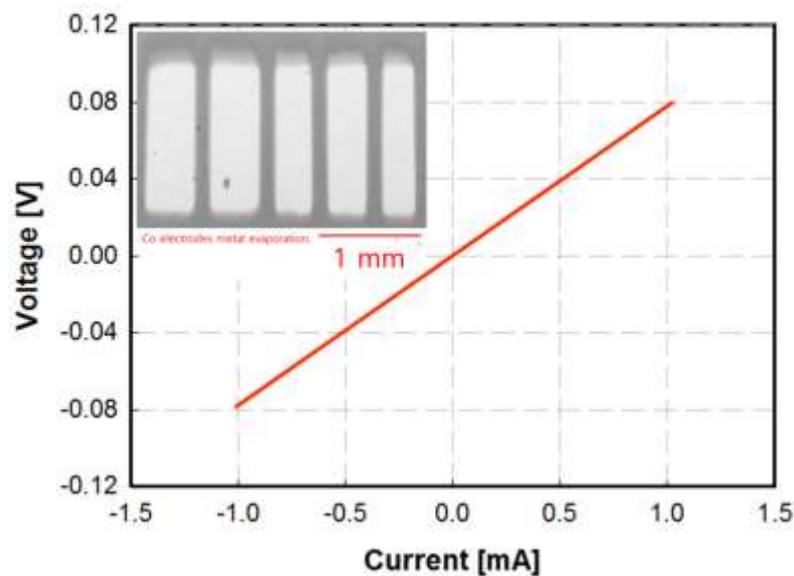


Figure 4.9. $V-I$ curve of SLG on Si wafer with Co electrodes evaporated on it

The calculated sheet resistance, 1,354 ohms is within the range of the sheet resistance stated in the provided specifications (660~1,500 Ω/\square) [4].

In most of our experiments, for the devices to be working as a sensor, the device resistance is monitored as a function of time in order that any external condition changes could be directly detected and interpreted on the plot. The response of the device is simply expressed as the changes in device resistance, $\Delta R/R_0$.

4.3 O₂, H₂O desorption

The hysteresis electrical behavior of graphene based transistor has been widely studied by many groups up to now [2,5-7]. Major reason for this is known to be the adsorption/desorption of water and oxygen molecules [6,8,9]. Most of their experimental results suggest that the hysteresis is suppressed or vanishes when graphene is placed under vacuum and pumped-out for extended time but graphene rapidly comes to its initial state when it is re-exposed to ambient air condition even for relatively short time [6,10]. Similar result could be observed with our resistive devices. The devices with four identical Cr/Au (10 nm/70 nm) electrodes were used in this measurement. The electrodes were deposited by shadow-mask thermal evaporation with a 100 μm gap on top of single layer graphene. Figure 4.10. shows the device response and the rate of response variation as a function of time under vacuum. Here, the response is defined as the ratio of measured resistance, R to the initial resistance, R_0 :

$$\mathbf{Response} = \frac{\Delta R}{R_0} \times 100 \text{ [\%]} \quad (26)$$

The rate of response, on the other hand, describes the changes in response per hour:

$$\mathbf{Rate\ of\ Response} = \frac{\mathbf{Response}}{\mathbf{hour}} \text{ [\%/hour]} \quad (27)$$

Our device was placed in a home-made stainless-steel and high-vacuum (10^{-6} mbar) capable chamber, and the measurement was started from the beginning of pumping out the chamber and lasted for more than 8 hours. The recorded response was almost saturated at 2 % in about 30 minutes at the pressure of 3×10^{-3} mbar with a primary pump. Then it restarts to increase as we switched from the primary pump to a secondary turbo pump and saturates again at around 6 % after 5 hours at an residual chamber pressure of 1.3×10^{-5} mbar. The rate of response becomes less than 0.5 %/h after 5 hours.

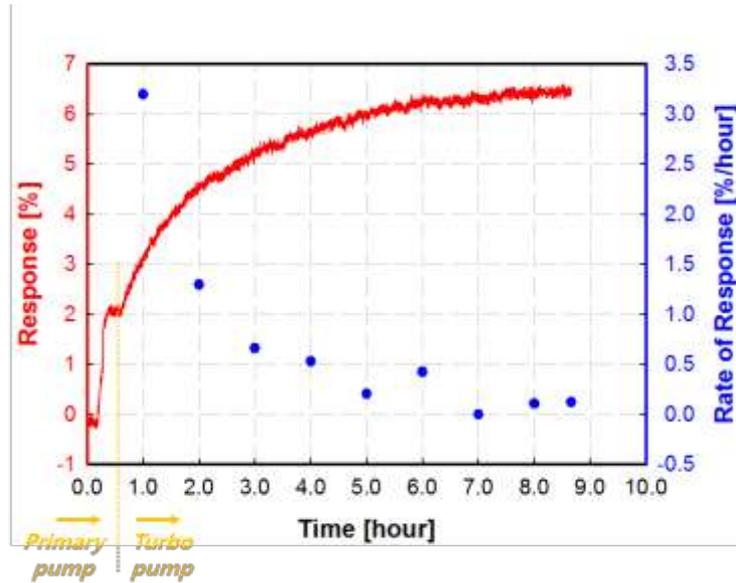


Figure 4.10. Time evolution of device resistance changes under vacuum

This change in the device response can be explained if we account for the energy band diagram of graphene (Figure 4.11.). As stated earlier, graphene on the SiO_2 substrate is commonly behaving as p-doped due to the oxygen and water molecules. Thus the hole conduction is responsible for the current flowing through graphene layer. The Fermi level is then below Dirac point where conduction and valence band touches each other. However, when the device is placed under vacuum for extended time, the oxygen and water molecules adsorbed on to the graphene surface would be desorbed so that graphene is effectively de-doped. This de-doping effect translate into the measured increase in device resistance.

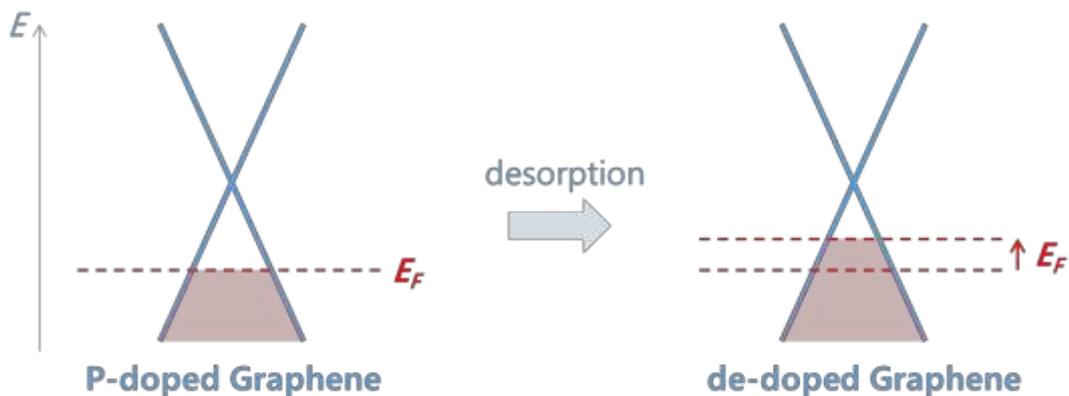


Figure 4.11 Energy diagram of graphene before and after the desorption of oxygen and water molecules

4.4 Light exposure response

Desorption of oxygen and water molecules can be further accelerated upon light exposure above certain wavelength threshold. Figure 4.12 shows how the device response changes with two different light sources: blue and red diodes with the wavelength of 455 nm and 633nm respectively. We can distinguish four different stages/scenarios for this experiment:

- (i) First, the device was placed in the chamber and the chamber was being pumped for the whole measurement. The pressure was lowered to 2×10^{-5} mbar in first few hours and stayed the same until the chamber was opened. Here, again, the device response becomes stable with the rate of response less than 0.5 %/h after about 5 hours as we expected. For more extended time, the response saturates at around 10 % before we turn on the light sources.
- (ii) Then the light was turned on and the device was exposed to the light with its intensity of 4 mW/cm^2 . The intensity was set to be the same for both blue and red light. The measurement has been carried out at room temperature (20°C). The results show that the device response increases with the blue light but not with the red light. The rate of response shows this result more clearly. When the blue light is on, the rate of response suddenly increases up to 4.5 %/h and slowly decreases. On the other hand, when the red light is on, the rate of response stays the same under 0.5 %/h which can be interpreted as no effective changes in the device response.
- (iii) When the light is turned off, the device response didn't come down to the values measured before the light illumination but it rather tends to slightly decrease for the blue light case, and exhibit no changes for the red light case.
- (iv) Finally, the chamber was opened so that the device is exposed to the air. Then the device response abruptly comes down to the initial value.

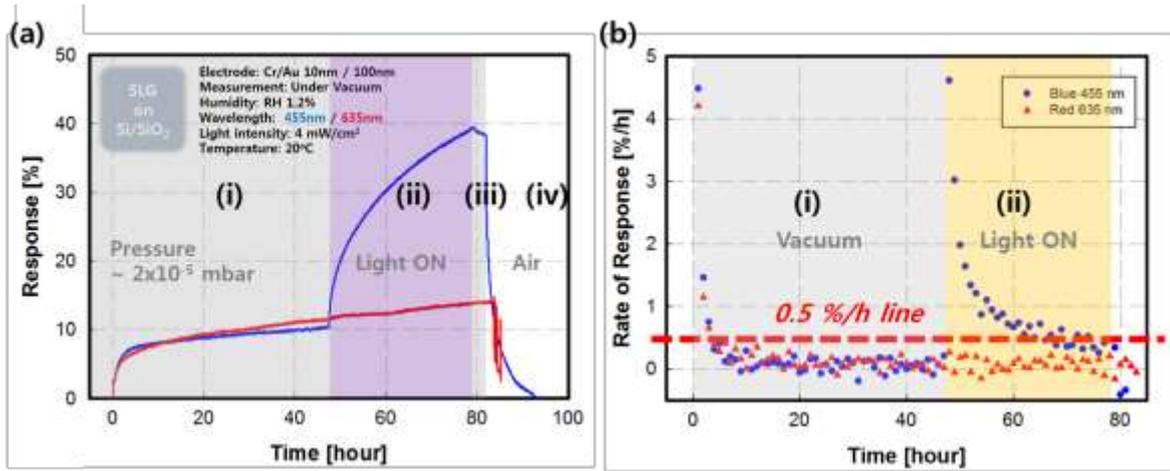


Figure 4.12. (a) the device response under blue (455 nm) and red (633 nm) light with its intensity of 4 mW/cm^2 . (b) The rate of response for the desorption under vacuum and the desorption under the light.

For the first stage, increased response of the device is well consistent with what we have found from the previous section. The desorption of oxygen and water molecules from graphene surface induces de-doping of graphene layer and the less p-doped graphene exhibits lower hole conductance which translates into the response increase.

On the other hand, for the second stage, when the surface of the graphene is exposed to the light, unexpected increase in response is observed only for the blue light but not for the red light exposure. This can be well explained by assuming further stimulated desorption of the oxygen and water molecules remained on graphene layer. Similar results have been already reported by several groups[10-14]. For example, in 2009, Y.Shi et al [10] reported the drain current (I_d) decrease in SLG transistor under light illumination (Figure 4.13.(a)). The gate voltage V_g was fixed at 100 V and 400 nm light with intensity of 20 W/cm^2 (w-lamp filtered by $\pm 10 \text{ nm}$ accuracy bandpass filter) was used as a light source. In the Figure 4.13.(b) the same measurements have been carried out under the light with various wavelengths. The light intensity for all wavelengths was maintained at 20 W/cm^2 . Their results prove that the current decrease due to the light illumination was almost negligible when the wavelength becomes larger than 632 nm. And this is well consistent with our result that red (633nm) light

couldn't effectively change the device resistance.

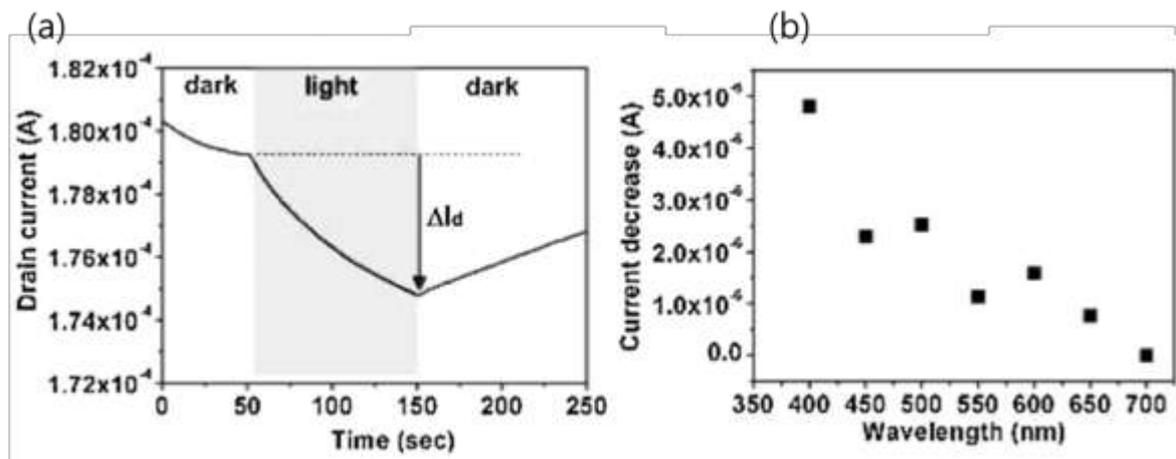


Figure 4.13. Photoelectrical measurement of the graphene transistor under light illumination: (a) Drain current change (ΔI_d) as a function of time for a SLG transistor under an illumination cycle with 400 nm light (20 W/cm^2) at gate voltage $V_g = 100 \text{ V}$. (b) Decrease in I_d (at $V_g = 100 \text{ V}$) for a SLG transistor upon illumination at various wavelengths [10].

Figure 4.14. simply describes the changes in graphene doping by the energy diagram with Fermi level. Step1 explains the oxygen and water molecules desorption process under vacuum condition. Graphene as deposited on the SiO_2 substrate is p-doped due to the oxygen and water molecules that can be represented as shifting the Fermi level below Dirac point. When the device is placed under vacuum for extended time, the oxygen and water molecules adsorbed on to the graphene surface would be desorbed so that graphene is effectively de-doped. Resultant de-doped graphene shows increase in device resistance. Step2 is elucidating further stimulated desorption of the oxygen and water molecules due to the light exposure of the device. When the surface of the graphene is exposed to the light, further desorption of the oxygen and water molecules remained on graphene layer will de-dope it. Eventually, less hole conduction translates into an increase in device resistance.

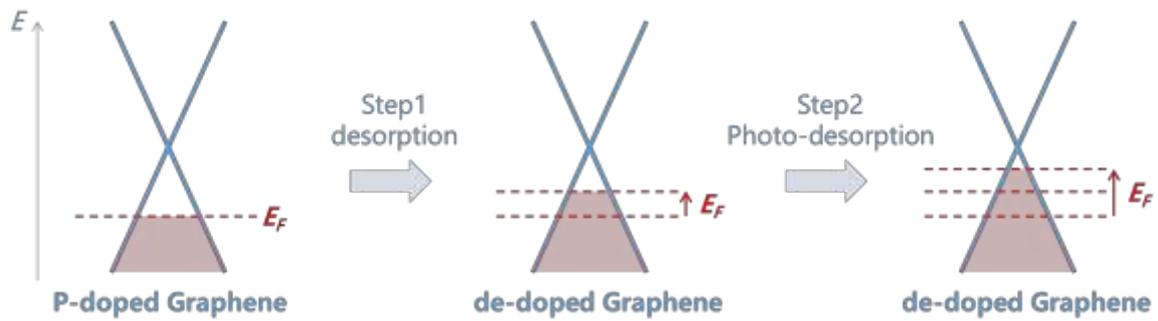


Figure 4.14. Energy diagram of graphene before and after the desorption of oxygen and water molecules under vacuum and under the light illumination

Furthermore, when the light was tuned off, on the third stage, the device responses decreased slowly for a few hours in case of the blue light, while it stayed the same level in case of the red light. Slow decrease in device response is considered to be related to the possible re-adsorption of desorbed oxygen and water molecules remained in the chamber even under high-vacuum condition. For the red light, since there was no significative stimulated desorption, the response stayed the same. Finally, on the last stage, when the chamber is opened and the device is re-exposed to ambient air condition, the device response abruptly comes down to the initial value for both blue and red light cases.

4.5 Humidity response

4.5.1 Humidity response of the device

Since the device is sensitive to ambient gas molecules such that its response changes under vacuum or under the light illumination due to desorption of water and oxygen molecules, it is worth understanding how the device reacts to the relative environmental humidity. The experiments are carried out with an homemade set-up (Figure 4.15.). The devices were placed on a peltier supported substrate holder in the closed chamber and a heated bottle of water is installed for supplying water vapor through heated line directly connected to the chamber. To prevent water vapor from being condensed to water droplets inside the chamber, the heating temperature of water bottle and the pipe was controlled. The humidity of the chamber is monitored via a humidity sensor (HC1000-400) while the device surface temperature was monitored by a the thermocouple. Device response is recorded as a function of time by four-electrode measurement using Keithley 4200-SCS.

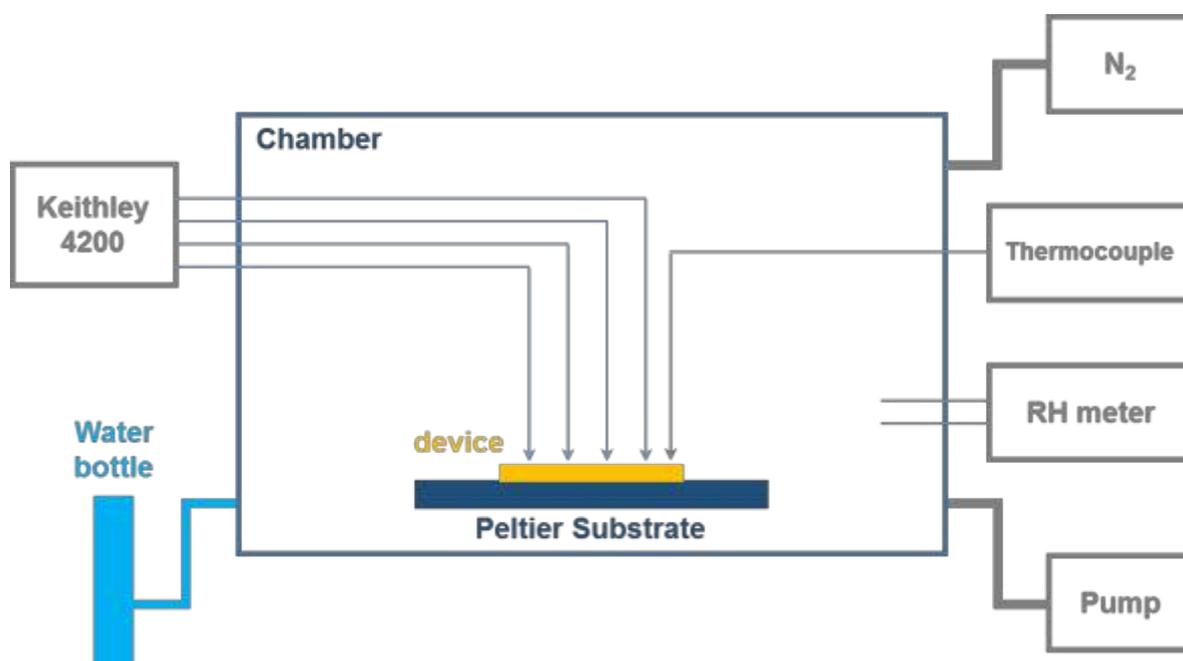
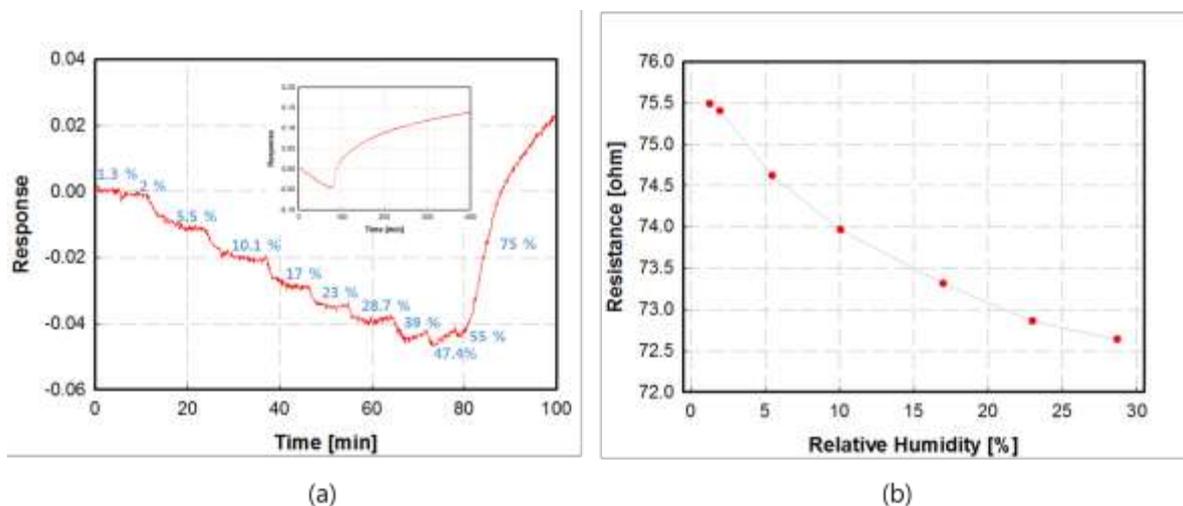


Figure 4.15. Schematic view of the humidity measurement set-up

Before the measurement, our device was first kept under vacuum ($\sim 5 \times 10^{-5}$ mbar) for about 3 hours. Then the chamber was filled with N_2 and the device response becomes stable with the humidity of RH 1.3 % within 20 minutes. In order to avoid possible formation of water droplet, the water bottle and the pipe line were heated to 90 °C and 60 °C respectively. Figure 4.16. displays the relative humidity (RH) responses of the device. As shown in the Figure 4.16.(a), the device response decreases about 4 % as we increase the humidity from RH 1.3 % to 28.7%. For this range of humidity changes, the device response has been stabilized for each step of the discrete humidity level. However, as we increase the humidity to more than RH 30 %, the device response was not stable anymore. When we increased the humidity to RH 39 % and RH47.4 % the response instantly decreased but not stabilized and rather continued to increase after a few minutes. When the relative humidity reached 55 %, after a small decrease, the response started to increase abruptly. This increase in response doesn't stop even with higher humidity (RH 75 %) and has continued for following 5 hours (Figure 4.16.(a).inset).



The decrease in device response for increase in relative humidity up to around RH 30 % can be interpreted as p-doping caused by adsorption of water molecules on the surface of graphene [6-10]. However abrupt increase in device response for higher humidity range cannot be explained by this way.

4.5.2 Vacuum annealing effect

To understand more the results, the device was vacuum annealed at 150 °C for 90 minutes and the same experiment has been subsequently carried out (Figure 4.17.). In this measurement, however, the device responded totally opposite way to the relative humidity increase. The response increases about 36% as the humidity increases from RH 1.1 % to RH 54.3 %. After vacuum annealing process, the device response reached about 36 % changes at RH 54.3 %, while it was only about 4 % at RH 55 % before. The response becomes roughly about 9 times larger than that from the previous measurement. On the other hand, the device response saturated at certain humidity level. As shown in the Figure 4.17.(a) the response saturated and stayed the same as the humidity increased from RH 54.3 % to RH 71 %. However, it started to decrease again after the saturation level as the humidity increased from RH 71 % to RH 76.8 %. And this behavior persisted for repeated increase and decrease in humidity. When we introduced dry N₂ into the chamber, the response increased for the first 5 seconds and started to decrease. The first increase is due to the sudden flow of N₂ that temporarily drops the local surface humidity level (Figure 4.17.(d)).

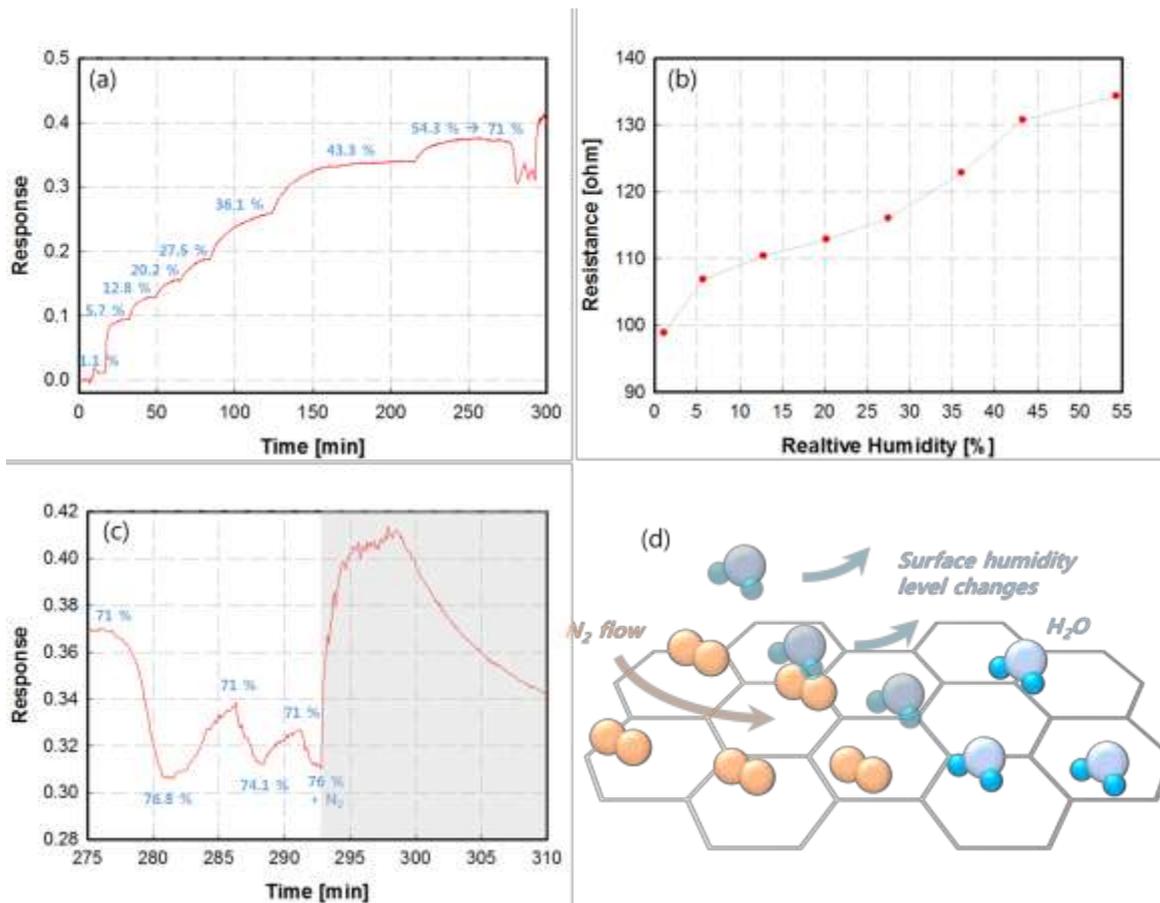


Figure 4.17 (a) Humidity response of vacuum annealed device as a function of time and (b) the device resistance as a function of the relative humidity. (c) Enlarged image for the humidity response after RH 71% and the N₂ flow region. (d) Schematic diagram of the graphene surface flow by N₂.

4.5.3 Surface analysis

To understand what happens under vacuum annealing process, several techniques for the surface characterization have been applied. Figure 4.18.(a) shows Auger electron spectroscopy (AES) spectra of our single layer graphene on the glass substrate sample during vacuum annealing process. RT denotes room temperature while P_C and P_O indicates the peak intensity of O_{KLL} and C_{KLL} respectively. The sample was placed in the ultra high vacuum chamber with the base pressure of about 9×10^{-10} mbar and the substrate temperature was raised from room temperature to 500 °C with 100°C step increase. AES spectra were recorded

for each step and every spectrum clearly shows C_{KLL} and O_{KLL} peak at around 273 eV and 510 eV respectively. The intensity is represented in differentiated form ($dN(E)/dE$) and normalized with respect to C_{KLL} peak. The primary electron beam energy used in our measurement was 2 keV and the over-all set-up energy resolution was 0.3 eV.

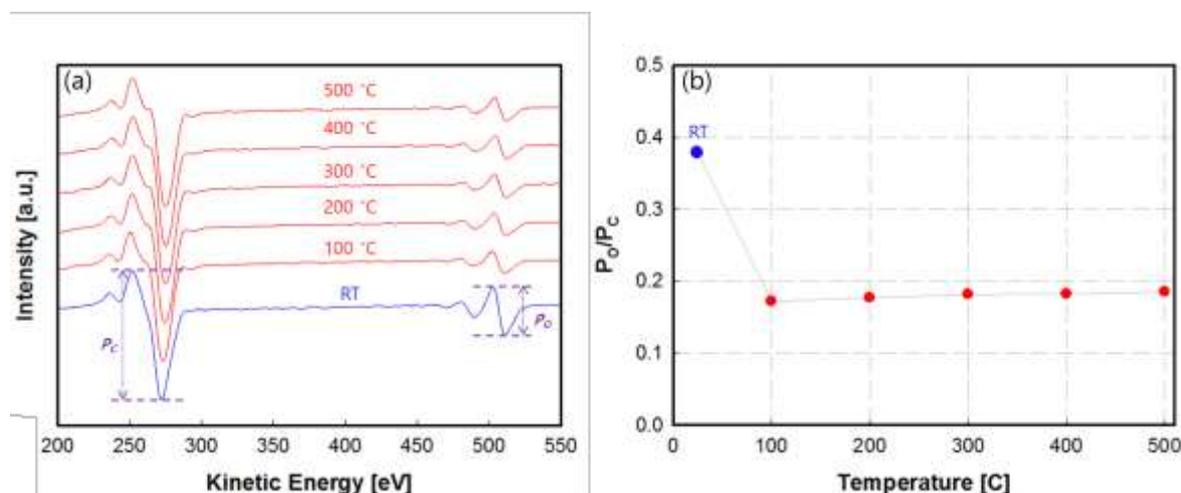


Figure 4.18 (a) Differential AES survey spectra evolution of single layer graphene on the glass substrate during vacuum annealing process from room temperature to 500°C at the base pressure of 9×10^{-10} mbar. (b) Peak-to-peak intensity ratio between C_{KLL} and O_{KLL} .

Quantitative analysis of AES spectra usually relies on either the peak area of as-measured curve or the peak-to-peak height of the derivative of the curve. Therefore, the peak intensity ratio can tell us relative concentrations of the elements on the surface. Figure 4.18.(b) shows the O_{KLL} to C_{KLL} peak intensity ratio (P_O/P_C) as a function of the temperature. It clearly depicts decrease in the oxygen concentrations in graphene layer as we annealed the sample under vacuum condition. This decrease in oxygen concentration might be due to the desorption of water molecules and labile oxygen containing functional groups (*e.g.* epoxide, carboxylic acid, alcohol, etc.). In addition, since our graphene is synthesized by CVD process and transferred to the substrate, some chemical contaminations containing oxygen species are inevitable through the whole synthesis process. Meanwhile, the peak intensity ratio after annealing (~ 0.18) is less than half the initial value (~ 0.38). Based on the fact that our graphene is not graphene oxide, such a large decrease in oxygen concentration is considered

to be more likely related to the desorption of the surface contaminants and adsorbed water molecules. On the other hand, once the oxygen concentration was decreased at the 100 °C annealing step, it became stable even at higher annealing temperature. Two remarks can be made on this result. Firstly, the surface contaminations and adsorbed water molecules are not effectively removed even under UHV condition ($\sim 9 \times 10^{-10}$ mbar). Secondly, even with less than 100 °C annealing, such contaminations and water molecules can be significantly reduced under vacuum.

Figure 4.19.(a) shows the electron energy loss spectrum (EELS) of our graphene sample comparing before and after vacuum annealing process. The energy loss peak around 6 eV is known to be attributed to the π -valence band plasmon ($\pi \rightarrow \pi^*$) [15]. In 2012, Politano et al. reported that the water exposed graphene layer shows less pronounced peak at 6 eV than the pristine graphene (Fig 4.19.(b)) [16]. The presence of C-H and C-OH functional groups influences the optical absorption of the π plasmon energy range and thereby strongly affect low-energy plasmon modes [16-18].

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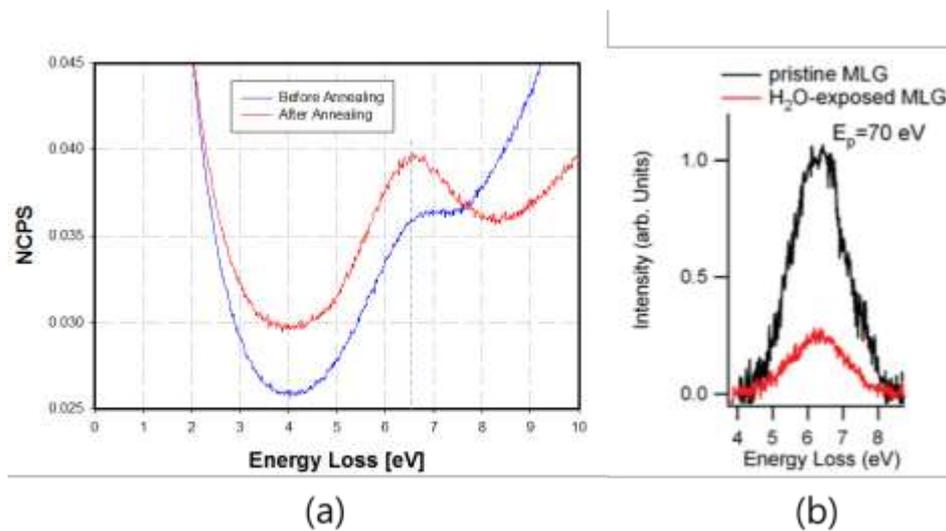


Figure 4.19. (a) EELS of single layer graphene on the glass substrate before and after vacuum annealing process from room temperature to 500°C. (b) EELS for the pristine and water-exposed single layer graphene/Pt(111) from the literature [16].

XPS was also employed for analyzing the effect of vacuum annealing process. Figure 4.20. shows the C1s core-level spectra of the graphene on the glass substrate before (Figure 4.20.(a)) and after vacuum annealing process (Figure 4.20.(b)). A Shirley background correction was first performed and a Gaussian-Lorentzian peak shape was used for the curve fitting. The peak corresponding to the sample before vacuum annealing process consists of two components, one at 284.5 eV binding energy representing the C-C bond of sp^2 carbon [15,19] while the other at 286.6 eV indicating the carbon in C-OH bond [15,19,20]. The percentage of C-C bond and C-OH bond is 81.5% and 18.5 % respectively. After vacuum annealing process (Fig 4.20.(b)), the C-OH bonds are removed by the break of labile functional groups on the graphene surface and the peak fits only with a single C-C bond peak at 284.5 eV.

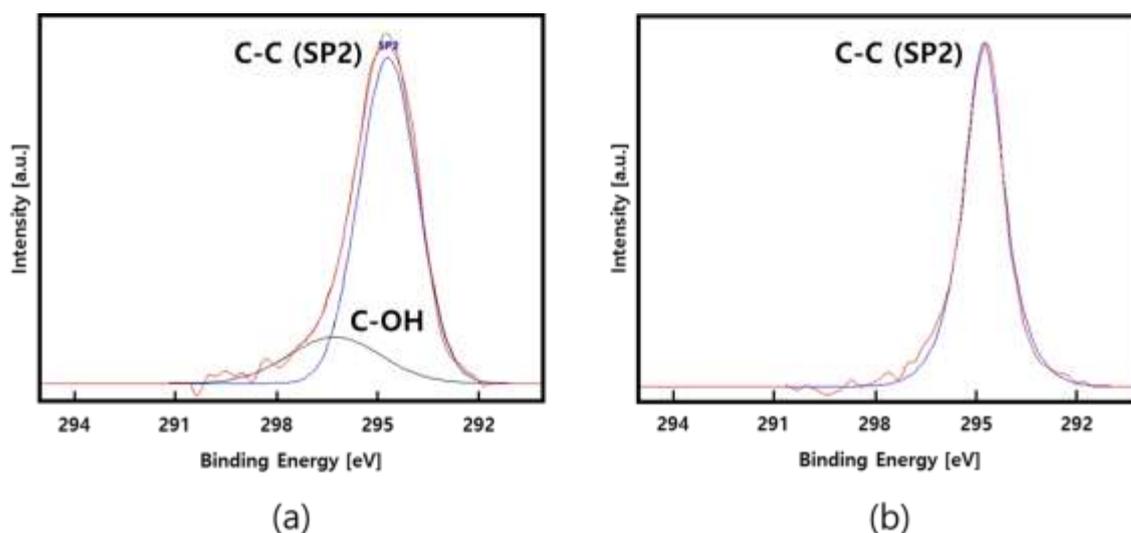


Figure 4.20. C1s core-level XPS spectra of single layer graphene on the glass substrate (a) before and (b) after vacuum annealing process.

4.5.4 Mechanisms of humidity response

Based on the results shown above, we would like to propose a mechanism

responsible for the humidity response of our device. Figure 4.21. shows a three-stage mechanism for the humidity response of the device before vacuum annealing.

First stage describes the initial state of the device before the measurement. The device was exposed to ambient air conditions for more than 4 weeks before the measurement and therefore the surface of the graphene is already covered with some water molecules adsorbed on it. Besides, remaining functional groups through the graphene synthesis and the device fabrication steps were already forming hydrogen bonds with such water molecules as well. In 2012, Guo et al. reported the theoretical calculations of the binding energies of water molecules on graphene materials using a model 32-carbon atom sheet. The calculated binding energy between pristine graphene and a single water molecule is only about 0.044 eV by weak Van der Waals, while it is 0.259 eV between hydroxyl groups and a water molecule by hydrogen bonds [21]. This tells us that the strong hydrogen bonds between water molecules and the functional groups are relatively stable compared to the weak Van der Waals force for surface adsorbed water molecules. Therefore, in this state, the humidity response of the device must be through the surface adsorption rather than hydrogen bonds between functional groups and the water molecules.

Second stage explains the decrease in device response as the humidity increases. Functional groups forming hydrogen bonds with water molecules are already almost saturated and stable compared to the surface adsorption of the water molecules by Van der Waals interaction. This means that the water molecules prefer to fill uncovered surface of the device through the surface adsorption. The water molecules adsorbed on the graphene surface will form a thin water layer with a dipole moment where oxygen atoms pointing toward graphene induces effective p-doping of the graphene surface [9,22]. Therefore, increased humidity level from RH 1.3 % to RH 28.7 % results in the decrease in device response.

The last stage is the response inversion where the response increases as the humidity increases. When the humidity reached RH 28.7 %, the device response tends to not saturate anymore but to increase. This tendency became stronger as we further increased humidity level. At this stage, surface adsorption of water molecules is saturated and forms a thin water layer covering all possible adsorption sites of the graphene surface. Therefore, the effective p-doping of the graphene surface by a dipole moment saturates as well. The excess of water

molecules due to the increased humidity will now form hydrogen bonds with already adsorbed water molecules covering the surface of the device. These additional hydrogen bonds are responsible for the observed increase in device response, because it reduces the effective p-doping of the graphene layer.

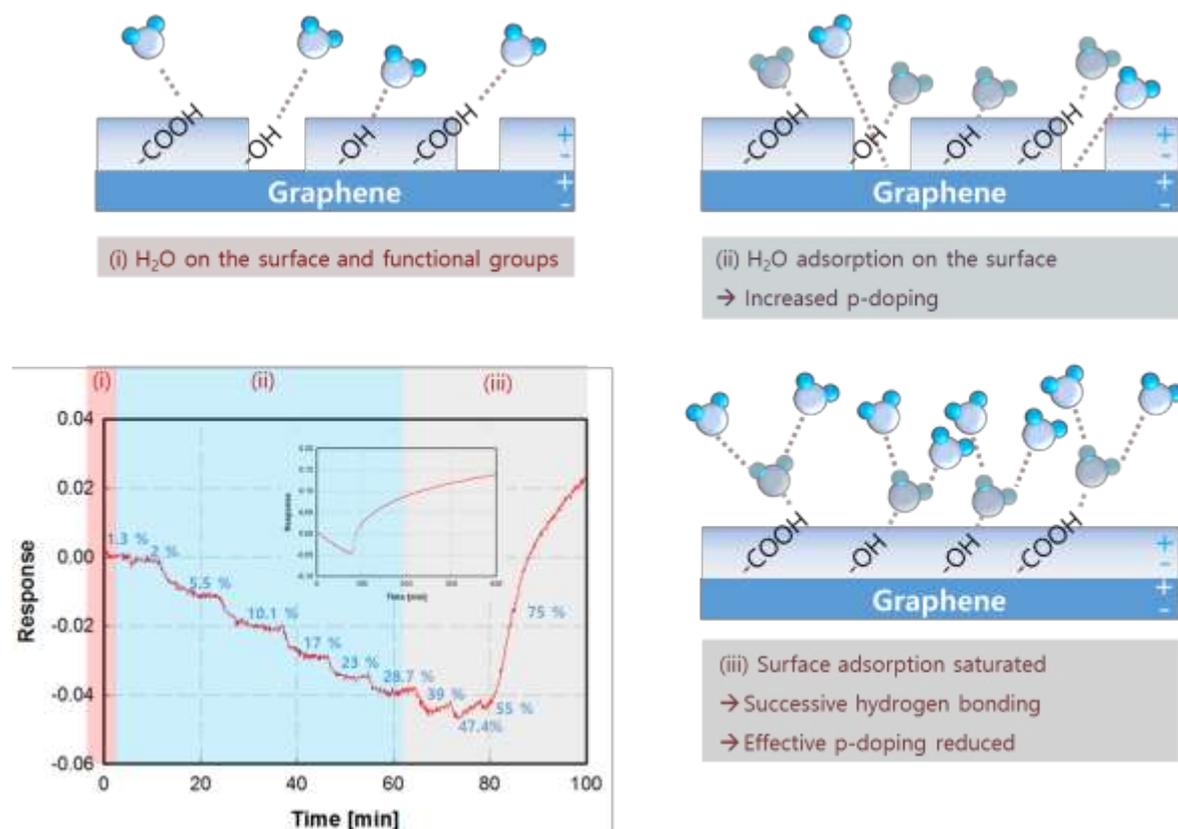


Figure 4.21. Schematic diagram of the mechanism for the humidity response of the device before vacuum annealing.

Figure 4.22. shows another three-stage mechanism for the humidity response of the device after vacuum annealing. First stage describes again the initial state of the device before the measurement. The device was annealed at 150 °C for 90 minutes under vacuum. Several groups have already reported that this vacuum annealing process effectively clean the graphene based device surface [23,24] so that the amount of p-doping is reduced. By such a process, water molecules adsorbed on the surface of graphene and forming hydrogen bonds

with functional groups are effectively removed through the annealing process. In addition, some labile functional groups are also removed and the surface became cleaner than before.

In the second stage, two different reactions compete each other. First one is the adsorption of water molecules on the graphene surface which makes graphene be more p-doped. The other one is the hydrogen bond between water molecules and the functional groups that reduces the effective p-doping of the graphene layer. Since the latter causes higher changes in device response, the overall device response increased as we increased the humidity from RH 1.1 % to RH 54.3 %. After the humidity reached RH 54.3 %, the device response tends to saturate and not change until we increased it up to RH 71%. This response saturation can be attributed to the saturated hydrogen bonds between functional groups and the water molecules.

The last stage is the response inversion. The device is now working like before vacuum annealing process where the response decreases as the humidity increases. This inversed response can be attributed to the adsorption of water molecules on the surface of graphene layer which corresponds to the second stage of the previous results from the device before vacuum annealing process. Functional groups forming hydrogen bonds with water molecules are already almost saturated due to the prolonged exposure to humid condition with continued measurement. Hence the increased relative humidity promotes excessive water molecules to fill uncovered surface of the device through the surface adsorption thereby forming a thin water layer that induces effective p-doping of the graphene surface [9,22].

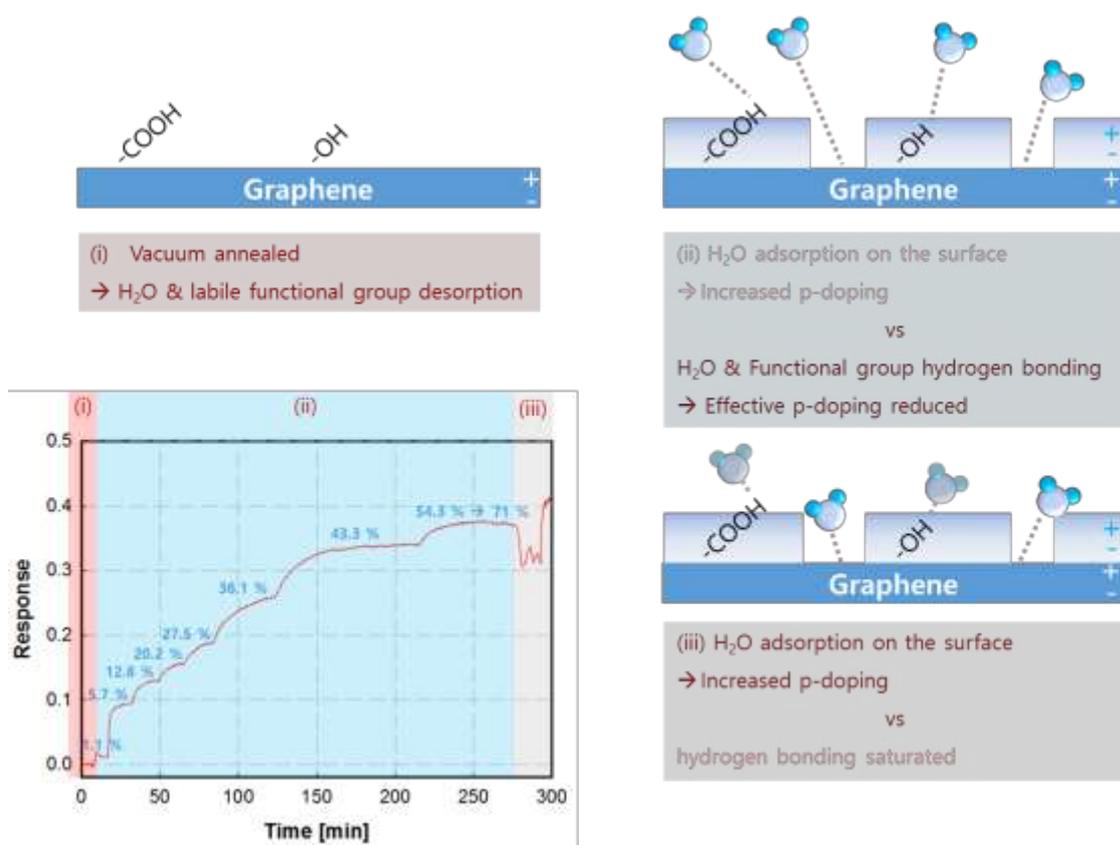


Figure 4.22. Schematic diagram of the mechanism for the humidity response of the device after vacuum annealing.

4.6 Conclusions

The test devices were fabricated by simply depositing four identical metal electrodes on the graphene surface. Three different methods including ink-jet printing, photolithography and shadow-mask evaporation have been studied and the shadow-mask evaporation was mainly used for the most of our devices because of its simplicity and, most of all, this method enabled us to avoid possible additional surface contaminations.

On the other hand, the electrical characterization method based on the four-probe measurement approach has been proposed. Basic four-probe measurement is modified in order to reflect our electrode configurations in the sheet resistance calculation.

Desorption of the oxygen and water molecules has been investigated to understand the intrinsic device response. The device response changes under vacuum because of the desorption of ambient water and oxygen molecules already adsorbed on to the graphene surface. This behavior could be further increased as we shine the device with the blue light (455 nm). The humidity response of the device has been also studied with the effect of vacuum annealing process. Electron spectroscopy such as XPS, AES and EELS have been employed to understand the mechanism of the vacuum annealing process. We proposed three-stage mechanism that is responsible for the humidity response of the device before and after the vacuum annealing process.

The presented studies on the desorption of water and oxygen molecules provide a preliminary understanding of the intrinsic response of the graphene based gas sensing device. When the graphene is directly exposed to the ambient air, the effects from the adsorption of such molecules are appreciable such that the device response is inversed in our case. Therefore, it is worth noting that the effects of ambient air needs to be taken into account before characterizing the gas sensing behavior of the device. Alternatively, one can develop the passivation methods to prevent graphene from ambient air. But this might be very tricky because the active area should still be exposed to the target gas molecules while the rest is passivated.

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Chapter V

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Chapter V. Functionalization

5.1 Generalities

Graphene is often functionalized with various elements for many purposes such as improvement of sensitivity, specificity, solubility, loading capacity, etc [1-8]. For our device, especially for sensing applications, improved sensitivity and specificity is the main purpose of the functionalization. We functionalized graphene surface by non-covalent way in order to avoid altering the native electronic structures and to preserve the intrinsic properties of the graphene. Pyrene moiety has been employed as a linker between the functional molecules and the graphene surface. It has been reported to have a strong affinity toward graphene surface via strong π - π interaction [9,10].

5.2 Ruthenium Complex(Blue)

Recently, the Ru(II) complexes have received a wide attention due to their excellent properties such as good electrochemical stability, high sensitivity, and high electrogenerated chemiluminescence (ECL) efficiency under moderate conditions [11,12]. It is also employed in donor-acceptor assemblies thanks to its photostability and high metal ligand conductor transfer (MLCT) excited-state energy [13,14]. Benefiting from all these exceptional properties, some studies on the functionalization of graphene materials with the Ru(II) complexes have been reported. Li et al. have reported the studies on the immobilization of $[\text{Ru}(\text{bpy})_3]^{2+}$ and the $[\text{Ru}(\text{bpy})_3]^{2+}$ -graphene-Nafion modified electrode which result in good sensitivity and stability for the ECL applications [15]. Zhang et al. have also reported that the Ru(II) complexes were well assembled onto the graphene oxide (GO) surface by forming amide bond. The charge transfer from the excited ruthenium to GO was explained by fluorescence spectra and photocurrent response measurements [16]. While these works were mainly based on the covalent bond functionalization method, an investigation of graphene non-covalently functionalized with Ru(II) complexes has been also reported by Li et al [17]. In their work, the Ru(II) complexes have been successfully anchored on graphene sheets utilizing a simple π - π stacking self-assembly noncovalent strategy for the use of ECL materials and photosensors.

In this thesis, we report the non-covalent assembly of the Ru(II) complexes ($[\text{Ru}(\text{bpy})_3]^{2+}$) functionalized with a pyrene unit as anchoring module (Figure 5.1.). Thanks to the anchoring module, $[\text{Ru}(\text{bpy})_3]^{2+}$ could be spatially separated from the graphene surface. This spatial separation prevents the direct charge recombination pathways between the complexes and the graphene layer, and thereby increases the lifetime of the light induced state of the complexes [18].

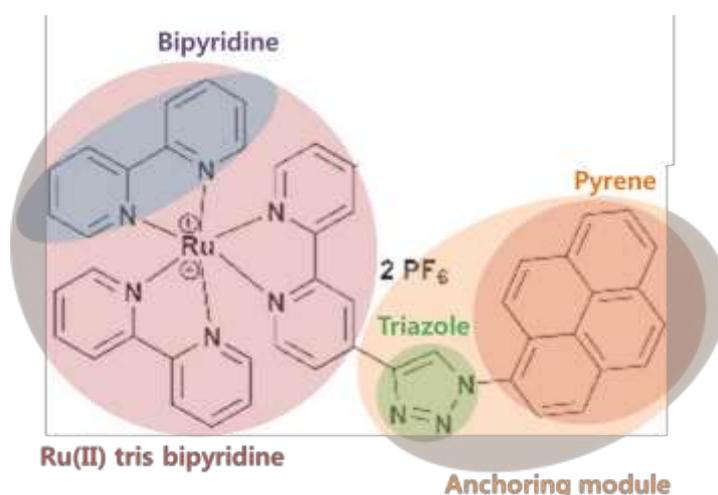


Figure 5.1. Schematic view of Ru(II) tris bipyridine complex. $[\text{Ru}^{\text{II}}\text{-Pyr}]^{2+}$

The synthesis of the complex has been carried out at Institut de Chimie Moléculaire et des Matériaux d'Orsay (ICMMO). The complexes are characterized and the UV-visible spectrum of the complex has shown an absorption maximum at 455nm, corresponding to the Metal to Ligand Charge Transfer (MLCT) of the $[\text{Ru}(\text{bpy})_3]^{2+}$ chromophore [18]. Excitation of this complex in acetonitrile at 455 nm with a nanosecond laser flash leads to formation of an excited state, which is detected by emission spectra with a maximum at 618 nm, typical for Ru(II)-polypyridine complexes. However, the emission lifetime is significantly longer (1.0 $\mu\text{s}/20\%$ and 4.7 $\mu\text{s}/80\%$) than observed in $[\text{Ru}(\text{bpy})_3]^{2+}$ (0.8 μs). This is attributed to the fast establishment of an equilibrium between $[\text{Ru}(\text{bpy})_3]^{2+*}$ and pyrene* triplet excited states [19]. The lifetime of the emission is independent of the detection wavelength. The excited

state-ground state absorption difference spectrum shows bleaching at 350 nm and a maximum at about 417 nm attributed to the formation of the excited state of the pyrene. While the decrease in the absorption at about 455 nm is expected due to the bleaching of the Ru(II) to bipyridine MLCT state due to the formation of some Ru(II) in the triplet excited state.

5.3 Functionalization of the device

5.3.1 Functionalization of the device

The prepared Ru(II) complex with pyrene anchoring module, $[\text{Ru}^{\text{II}}\text{-Pyr}]^{2+}$ was dissolved in acetonitrile solvent for making 5 mmol/l of solution. A 5 μL drop of the solution was deposited on the device. Once the solvent is evaporated, device was rinsed with an excess of acetonitrile in order to remove the non-grafted complex on the graphene surface. This grafting/washing cycle was repeated several times to reach the maximum number of grafted molecules (Ru(II) complexes) on the graphene surface. Figure 5.2. shows Raman spectra of graphene before and after the functionalization. The observed Peaks after the functionalization process at around 1140 cm^{-1} , 1185 cm^{-1} , 1340 cm^{-1} , 1410 cm^{-1} , 1450 cm^{-1} , and 1620 cm^{-1} must be from the Ru(II) complex that are found from the literatures [20-24].

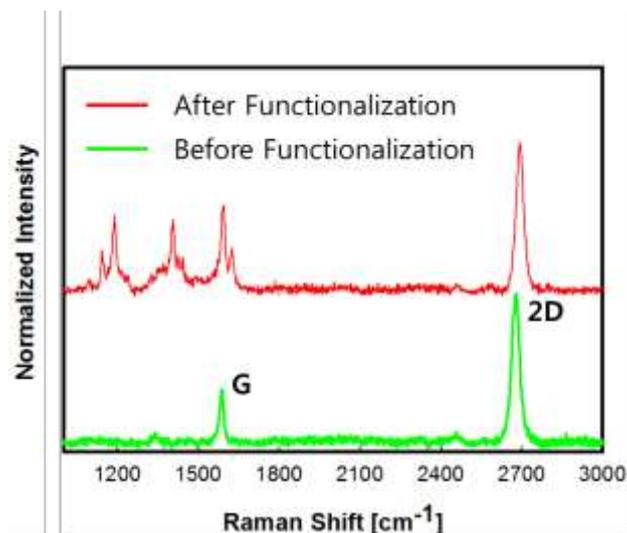


Figure 5.2. Raman spectra of graphene before and after the functionalization using the excitation laser wavelength of 532 nm

5.3.2 Photoresponse of the functionalized device

The device was exposed to the blue light (455nm) before and after the functionalization in order to verify how the complex affects the device. Figure 5.3. describes experimental steps for the functionalization of our device. First, SLG on glass substrate is prepared. Cr/Au electrode was then deposited by thermal evaporation process. The thickness of the electrode was 12 nm and 70 nm for Cr and Au respectively. After the thermal evaporation process, the

device was annealed at 150 °C for 90 minutes under vacuum conditions to improve electrode contact and to remove residual contaminations on the graphene surface. Then this device is exposed to the blue light (455nm) to see its intrinsic photoresponse. The device is then functionalized with ruthenium complex as stated above. The functionalized device is exposed again to the blue light to see the effect of the functionalization with the Ru(II) complexes.

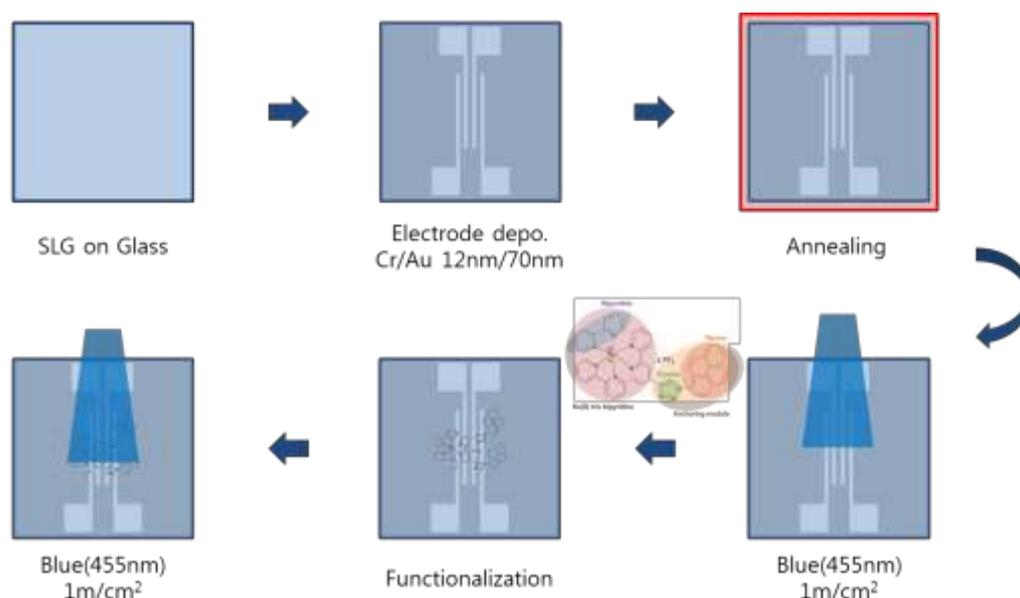


Figure 5.3. Experimental steps for the functionalization of the graphene based resistive sensor and its light response

The device was functionalized 6 times in this way and the Figure 5.4.(a) presents the blue light response of the device measured right after each functionalization process. First, the light was turned on after 500 sec and it was repeatedly turned on and off for each 5 minute. Up to 3 times of repeated functionalization process, the device response generally increased up to 160 %. However, additional steps of functionalization process made device response to decrease again. After the fifth functionalization, the response becomes comparable to that of after the first functionalization step.

Figure 5.4.(d) shows the changes in initial device resistances after each functionalization process. The initial device resistance was about 15 ohms before the

functionalization, but it increased to about 45 ohms after the first functionalization process. This increased resistance stayed in the similar values range (43~51 ohms) after following additional functionalization processes. The increase in the device resistance implies that the complexes are interacting with the current flow by acting as scattering centers [25]. However, the fact that there was no appreciable increase for the successive measurements after the first functionalization step implies that the graphene surface is effectively functionalized with the complexes starting from the first functionalization process.

On the other hand, after graphene is well functionalized with the complexes, the device started to show different behaviors under the light illumination. Figure 5.4.(b) shows detailed device response after 3 times of functionalization in the Figure 5.4.(a). The signal shape exhibit a first abrupt increase in the device response followed by the slower increase in device response due to the photo induced desorption of water and oxygen molecules [26-30].

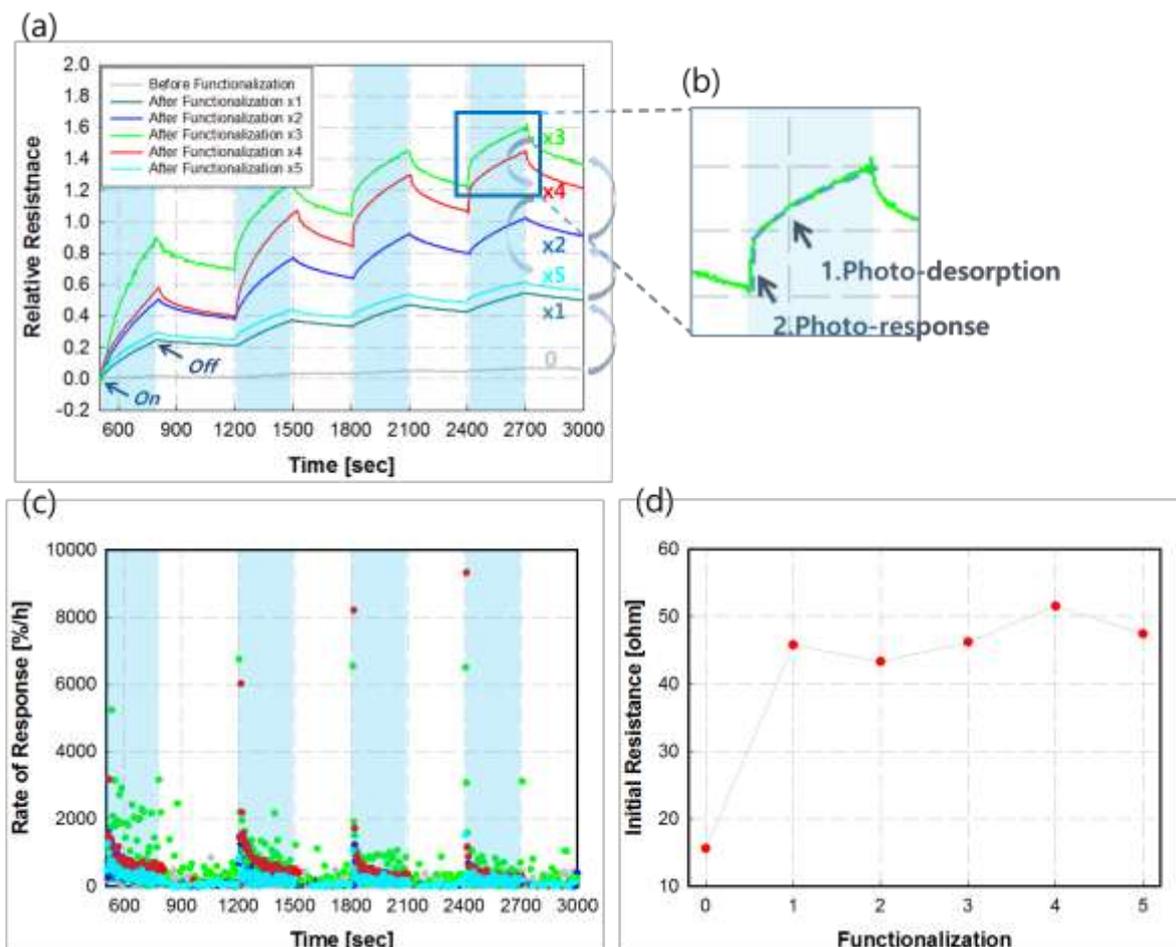


Figure 5.4. (a) Light response of the graphene resistive sensor functionalized with the ruthenium complex. (b) Two different mechanism responsible for the light response of the device. (c) Rate of response. (d) Initial device resistances after each functionalization process. The light source with the wavelength of 455nm and the intensity of 1.1mW/cm^2 is used.

To further understand the photo-response and photo-desorption effects separately we performed two different measurements by varying the intensity and the frequency of the incident light source. Figure 5.5. shows the device response with varying the intensity of the light source. The blue light (455 nm) source was controlled with a function generator HM 8130. The light pulse with the frequency of 0.05 Hz and the 50 % of duty cycle was applied while the electrical measurement speed was about 1 measuring point every 85 ms. Three different light intensities were tested: 0.57mW/cm^2 , 1.1mW/cm^2 , and 12.3mW/cm^2 . It is clearly shown that the global device response increases as we increase the light intensity.

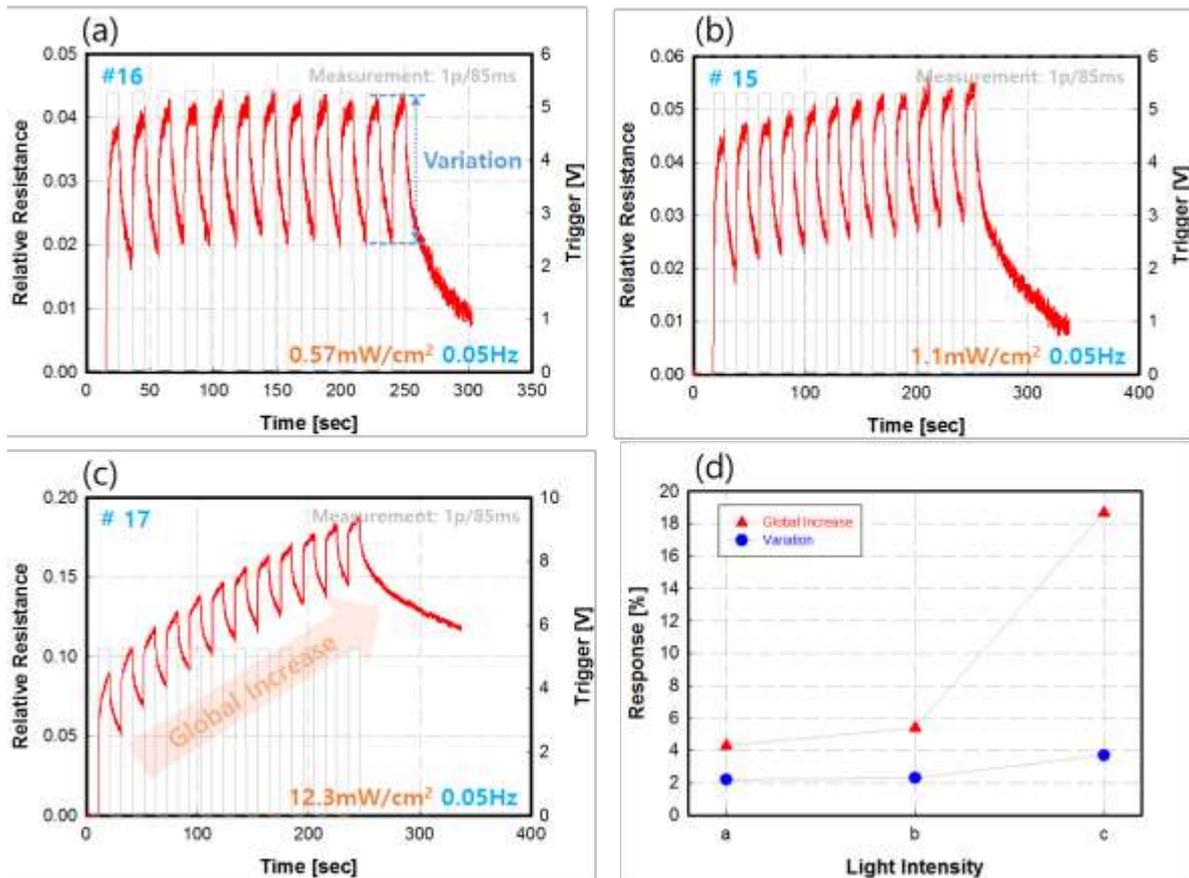


Figure 5.5. Light response of the device with different light intensities: (a) 0.57 mW/cm², (b) 1.1 mW/cm², (c) 12.3 mW/cm². (d) The global increase in response and the variation with different light intensities. The wavelength of the light source was 455nm.

For the light intensity of 0.57 mW/cm², the device response increased about up to 4.3 % and showed about 2.2 % variation upon the repeated light exposures (Figure 5.5.(a)). For the light intensity of 1.1 mW/cm², the response increased to 4.3 % for the first light pulse, and then continuous and slight increase in response up to about 5.4 % upon 12 times of repeated exposures was observable (Fig 5.5.(b)). The variations in the response for one pulse was about 2.3 % which is the same as that for the intensity of 0.57 mW/cm². However, for the higher light intensity of 12.3 mW/cm², the device showed much stronger increase in response up to about 18.7 % upon 12 times of repeated exposures (Figure 5.5.(c)). For the first light pulse, the response increased about 7 % and the variations for each light pulse was about 3.7 %. Figure 5.5.(d) compares the global response increases and the variations of the device upon 12 times of repeated exposures to the light with three different intensities. They are all affected by the increased light intensity. However, it is clear that the global increase in the device response is much more dependent on the light intensity than the variation which is considered to be attributed to the photo-desorption of the water and oxygen molecules adsorbed on the graphene surface [26-30].

Figure 5.6. shows the light response of the device with different pulse frequencies. The light intensity and the duty cycle of the pulse were fixed at 1.1 mW/cm² and 50 % respectively. The measurement speed was about 1 point per 85 ms which is the fastest limit of the set-up.

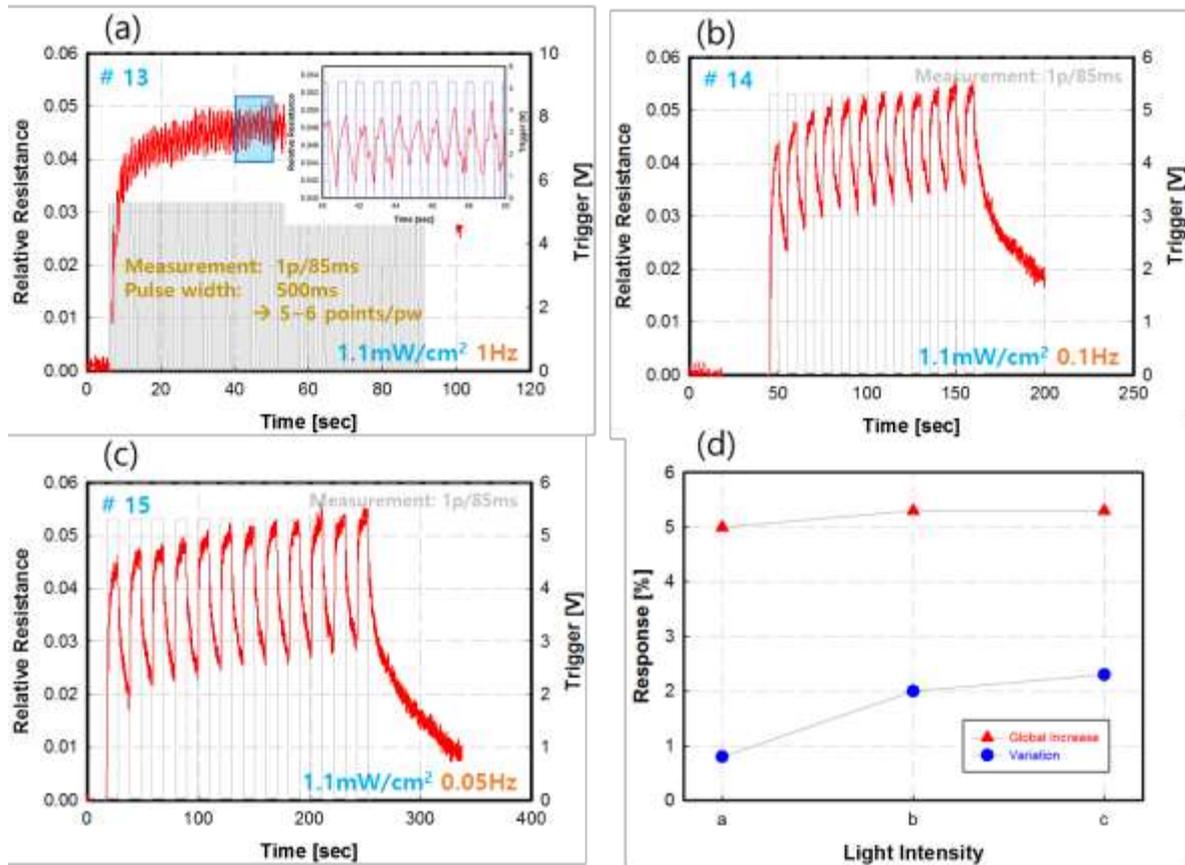


Figure 5.6. Light response of the device with different light pulse frequencies: (a) 1 Hz with inset showing zoomed region, (b) 0.1 Hz, (c) 0.05 Hz. (d) The global increase in response and the variation with different pulse frequencies. The wavelength of the light source was 455nm.

Figure 5.6.(a) shows that the response is fast enough to follow the 1 Hz pulse of light which cannot be explained by the photo-desorption response of the intrinsic graphene because of its low adsorption/desorption rate. However, the response for each light pulse does not saturate with this fast measurement while it saturates with 0.1 Hz pulse of the light (Figure 5.6.(b)). This means that it requires at least 5 sec to have saturated response for a pulse of the light. Meanwhile, the global response increase and the variation of the response also changes as the pulse frequency changes. Unlike intensity dependency result, the variation of the response was affected stronger than the global increase in the response by the frequency changes (Figure 5.6.(d)).

As the device response upon the light exposure clearly shows difference in the rate of response, there must be, at least, two different mechanisms responsible for the device response. One can be related to the desorption of water and oxygen molecules that happens both for intrinsic and functionalized device. The device shows persistent response increase with relatively low rate of response after the first few seconds as the light was illuminated on the surface of the graphene. This is attributed to the global increase in device response. Higher intensity of the light promotes more desorption of the water and oxygen molecules so that the appreciable global increase in device response appears.

Another mechanism which can be responsible for the abrupt increase in device response for the first few seconds of light illumination might be explained by the charge transfer from the complexes to the graphene [16,17,31]. The Figure 5.7. shows the schematic view of this charge transfer. Under the light illumination, the $[\text{Ru}(\text{bpy})_3]^{2+}$ triplet excited states are formed. Charges from this excited states travel to the pyrene anchoring groups and trigger the excited state of the pyrene units. The secondary charge transfer from the excited pyrene units to the graphene follows. As mentioned earlier, graphene on the SiO_2 is p-type material where the hole conduction is responsible for the current flow in the device [32-34]. The photo-excited electrons flow coming from the anchored complexes recombine with holes in graphene and thereby induce de-doping of the material. This reaction happens much faster than the desorption process and therefore the device response increases abruptly in the first few seconds as the light is turned on.

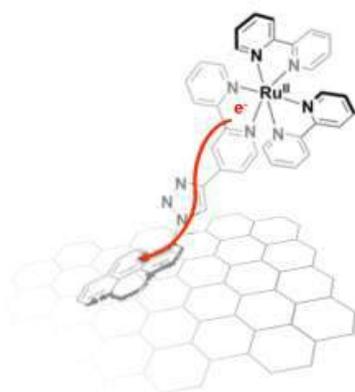


Figure 5.7. Schematic view of the mechanism of electron transfer from the excited complexes to the graphene via pyrene units.

5.4 Double interfaces responses

In the previous paragraphs, we showed that graphene can be well functionalized with Ru(II) complexes and the charge transfer from the complex to the graphene under illumination has been studied. In this paragraph, another device has been fabricated utilizing the functionalized graphene. The Figure 5.8. shows the fabrication of a double-interface device based on the functionalized graphene and its light response experiment. First, SLG on glass substrate is prepared. It is annealed at 150 °C for 90 minutes under vacuum. Then the device is functionalized with ruthenium complexes following the same method used before. Cr/Au electrodes are subsequently deposited by shadow-mask thermal evaporation process. The thickness of the electrode was 10 nm and 70 nm for Cr and Au respectively. After the thermal evaporation process, the device was annealed again at 150 °C for 90 minutes under vacuum conditions to improve electrode contact and to remove residual contaminations on the graphene surface. The device now has two different interfaces: graphene-to-pyrene, Ru(II) complex-to-metal. We named it double-interface device. Then this device is exposed to the blue light (455nm) to see the effect of the interactions at two different interfaces.

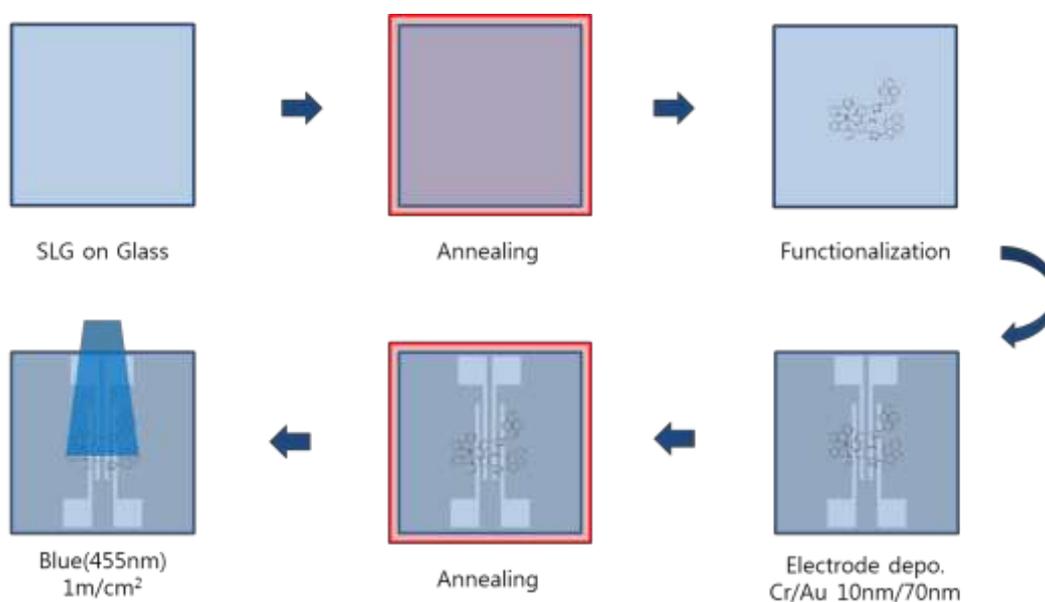


Figure 5.8. Experimental steps for fabrication of the double-interface device based on the functionalized graphene and its light response

Figure 5.9. shows the schematic view of the double-interface device. The first interface is between chromium and the Ru(II) complex while the second interface is between the Ru(II) complex and the graphene layer. Since the Ru(II) complexes are spatially separated from the graphene surface due to the pyrene units, what is actually touching the graphene for the second interface is the pyrene units via non-covalent π - π stacking.

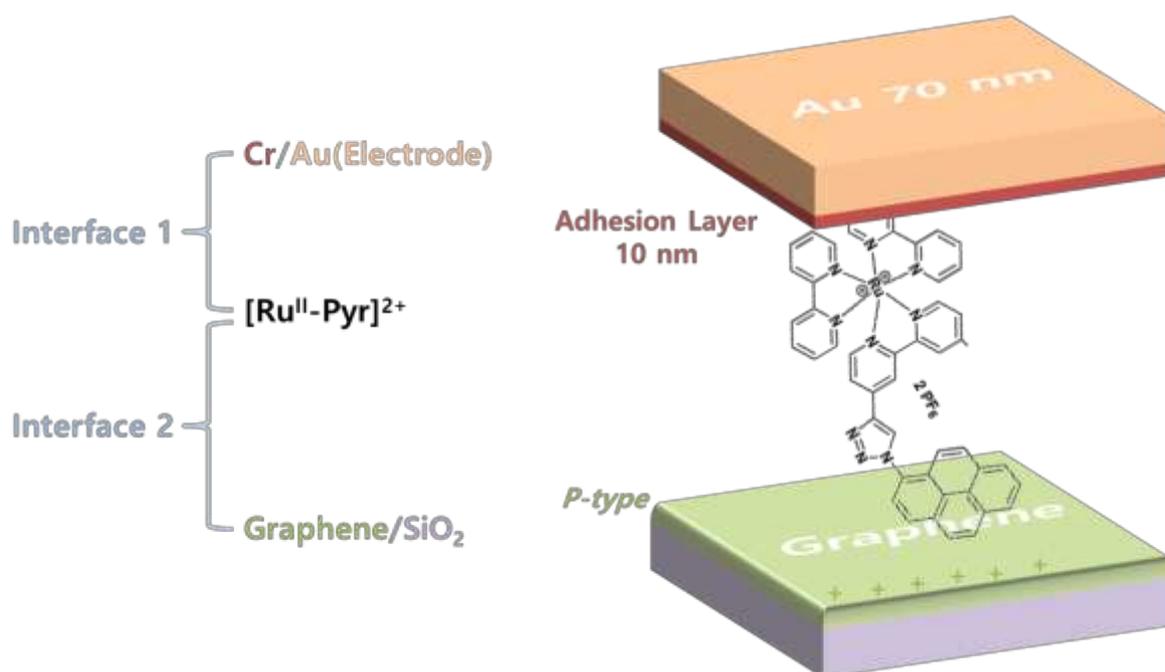


Figure 5.9. Schematic view of the double-interface device

Figure 5.10. shows the double-interface device response at varying intensity of the light source. The blue light (455 nm) source was controlled by the function generator HM 8130. The light pulse with the frequency of 0.1 Hz and the 50 % of duty cycle was applied while the measurement speed was about 1 measuring point per 85 ms. The measurements were carried out at room temperature under N₂ condition. Four different light intensities were tested: 0.05 mW/cm², 0.57 mW/cm², 1.1 mW/cm², and 5 mW/cm². Starting with the light intensity of 0.05 mW/cm² Figure 5.10.(a), device shows similar behavior to that of single interface device as we increased the light intensity to 0.57 mW/cm² (Figure 5.10.(b)). Both

the global device response and the fast variation increase was observed. However, as we further increase the light intensity to 1.1 mW/cm^2 (Figure 5.10.(c)), the tendency of this increase started to saturate. When the higher light intensity of 5 mW/cm^2 was used, during one measurement, the device response inverted (Figure 5.10.(d)).

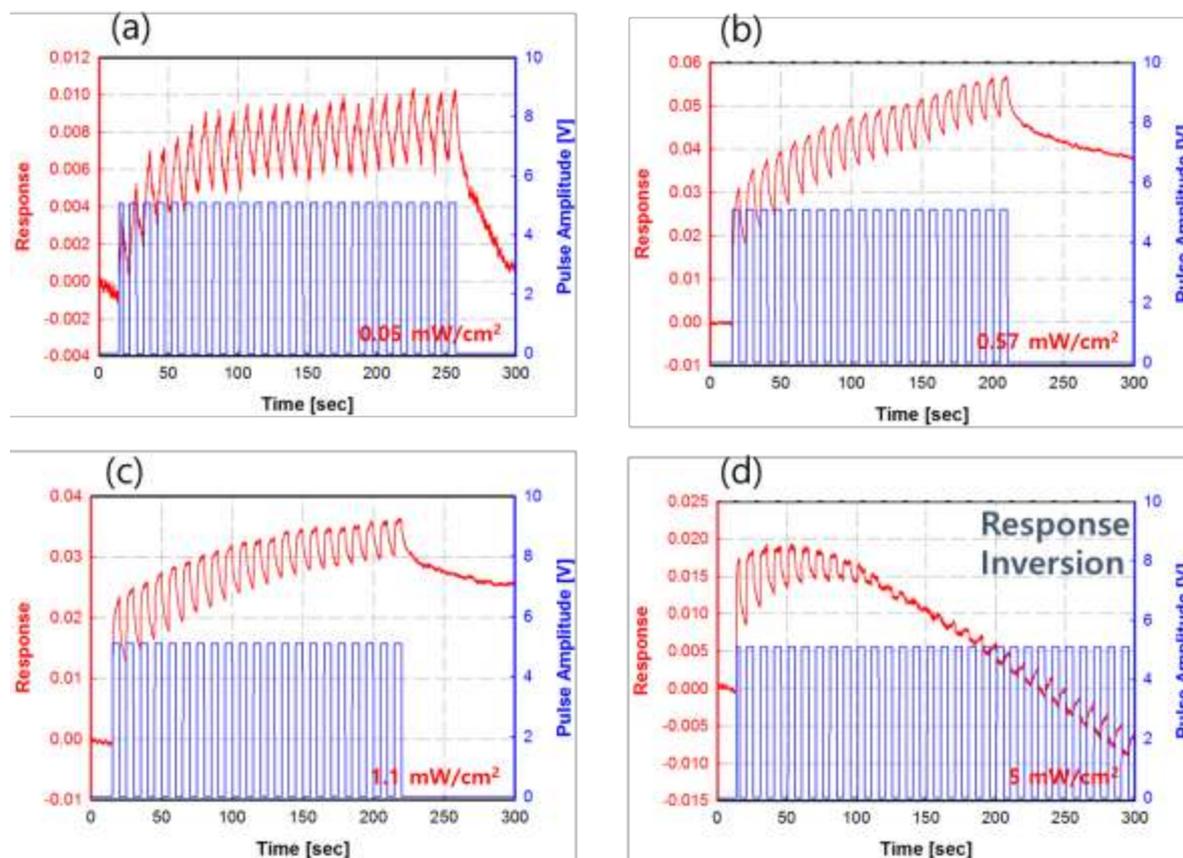


Figure 5.10. Light response of the double-interface device with different light intensities: (a) 0.05 mW/cm^2 , (b) 0.57 mW/cm^2 , (c) 1.1 mW/cm^2 , (d) 5 mW/cm^2 . The wavelength of the light source was 455 nm .

Figure 5.11. shows the enlarged view of the Figure 5.10.(d) to show the transition of the device response. For the beginning of the measurement, the device shows normal response. The device response increases as the light is turned on. However, the fast variation tends to decrease and the global device response also tends to saturate (Fig 5.11.(b)). After a while the device enters in a transition region. In this region, the global device response only

decreases upon the light illumination and almost no fast variation is observed (Figure 5.11. (c)). As the measurement continues, the fast response started to be inversed and showed exactly the opposite behavior compared with beginning. The device fast response decreases as the light is turned on. Also the fast variation tends to increase while the global device response continues to decrease (Figure 5.11.(d)). However, as soon as the device is exposed to ambient air condition, the responses come back to normal response. This is remarkable as the device response inversed within 5 minutes of measurement without any experimental condition changes.

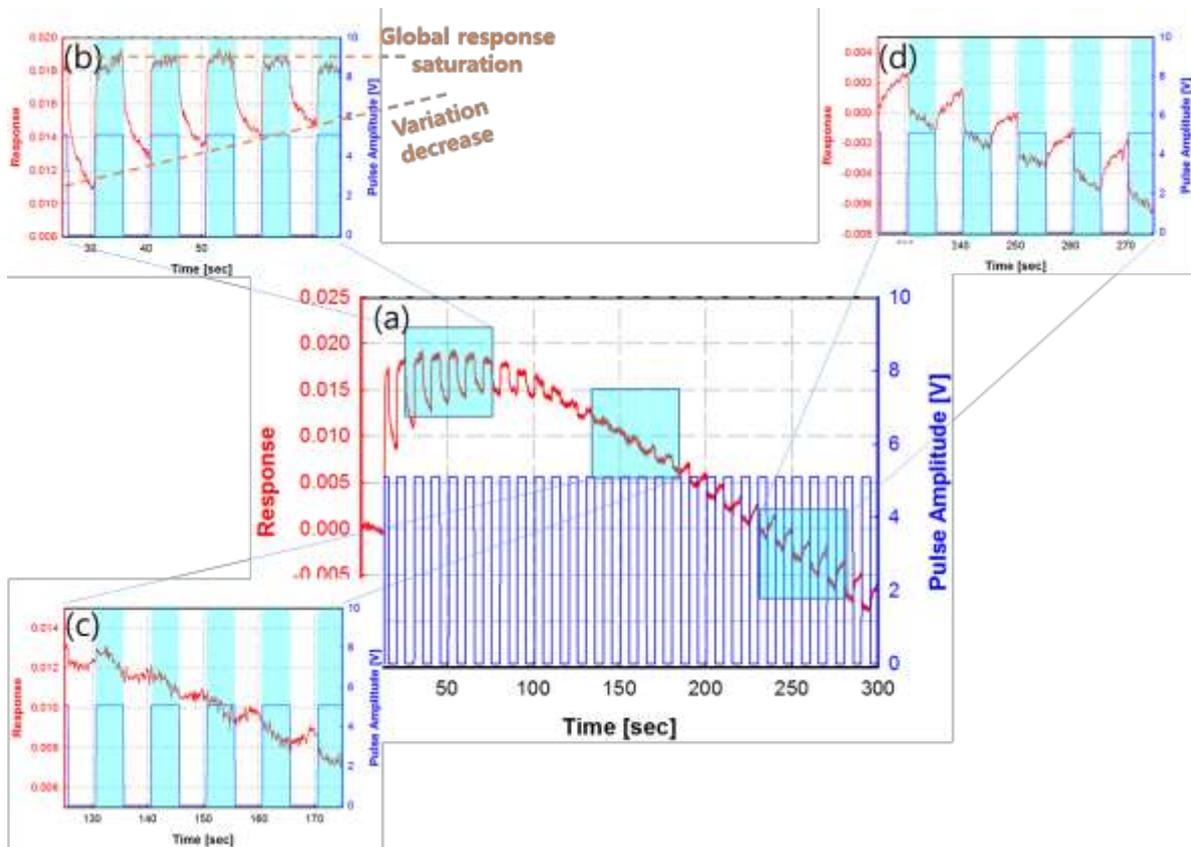


Figure 5.11. (a) Response of the double-interface device illuminated with the 455 nm and 5mW/cm² light. (b) Normal response region. (c) Transition region. (d) Inversed response region.

The device response inversion was reproducible. Repeated measurement under N₂ (Figure 5.12.(a)) shows the same result. The same measurement has been also carried out

under vacuum condition (Figure 5.12.(b)). The device was placed in the chamber filled with N₂ and the chamber was pumped out until the pressure reached to 3.7 x 10⁻⁵ mbar. At this pressure, the device response inverted again.

To facilitate the response inversion, the light with higher intensity (12.3 mW/cm²) and longer period (0.01 Hz, 50 % duty cycle) was illuminated on the device (Figure 5.12.(c)) under N₂ condition. In this case, the device response inverted with only three pulses of the light. The same measurement has been carried out under ambient air condition Figure 5.12.(d). But in this case, the response did not invert but showed step increase followed by the global device response decrease under the light illumination.

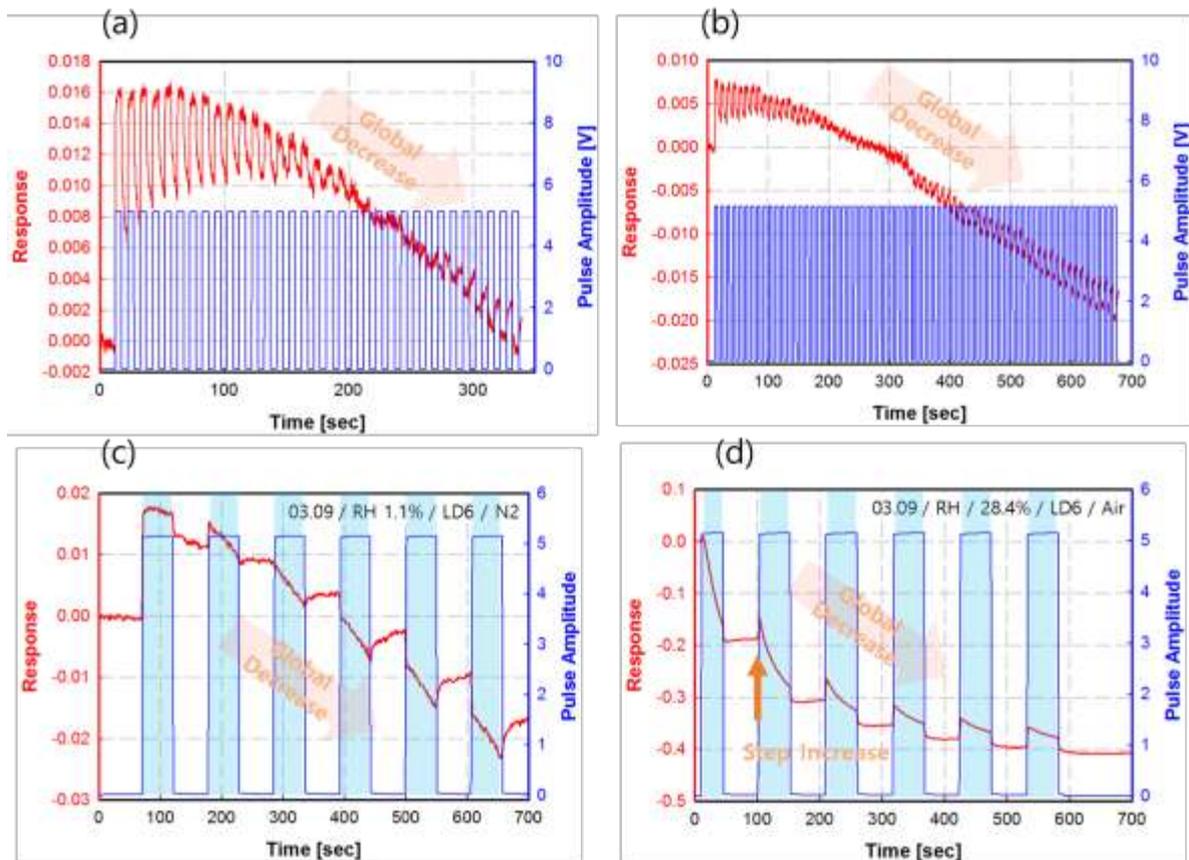


Figure 5.12. Response inversion test (a) under N₂ and (b) under vacuum (3.7 x 10⁻⁵ mbar) condition with 0.1 Hz pulse of the 455 nm and 5 mW/cm² light. Response inversion test (c) under N₂ and (d) under ambient air condition with 0.01 Hz of the 455 nm and 12.3 mW/cm² light.

The results from this series of measurements are suggesting us two important issues on the device response inversion:

- ✓ Response inversion occurs when the water and oxygen molecules are desorbed
- ✓ Electron transfer from Ru(II) complexes to the metal electrode

First, the fact that the response inversion occurs only under N₂ and vacuum condition but not under ambient air condition suggest that the water and oxygen molecules have to be desorbed before the response inversion. In addition, the response inversion happens only when the global response increase reaches saturated regime and started decreasing which must be because of the effective desorption of water and oxygen molecules.

Second, the device response decreases under the light illumination after it reaches inversion. This indicates that the graphene is more p-doped. For this to happen, electrons from the excited state of the Ru(II) complexes have to transfer to the metal electrode that is the opposite charge flows compared to that of the one interface device. This suggests that the electronic states of the first interface between Ru(II) complexes and adhesion layer might have been positively charged during the measurement, so that the excited electrons are attracted more to the the first interface. One hypothesis can be set up based on the possible oxidation of the adhesion layer. It is well-known that Cr is relatively easily oxidized at room temperature [35-38]. If the Cr layer is oxidized to form positive chromium oxide layer, electrons will travel to this layer than to the graphene film, resulting in more p-doping of the graphene film. Detailed investigation on this hypothesis is discussed in 5.4.2 Charge transfer.

5.4.1 Inversed response.

5.4.1.1 Intensity dependency of the inversed response under vacuum

Once the device response is inversed, before the device is exposed to ambient air condition, this inversed response was persistent. Figure 5.13. shows the light intensity dependency of the inversed response of the device. Like the previous experiments, the 455 nm light source was controlled by the function generator HM 8130 and the light pulse with

the frequency of 0.1 Hz and the 50 % of duty cycle was applied. The measurement speed was about 1 point per 85 ms. Six different light intensities were tested: 0.05 mW/cm², 0.57 mW/cm², 1.1 mW/cm², 5 mW/cm², 11 mW/cm², and 12.3 mW/cm².

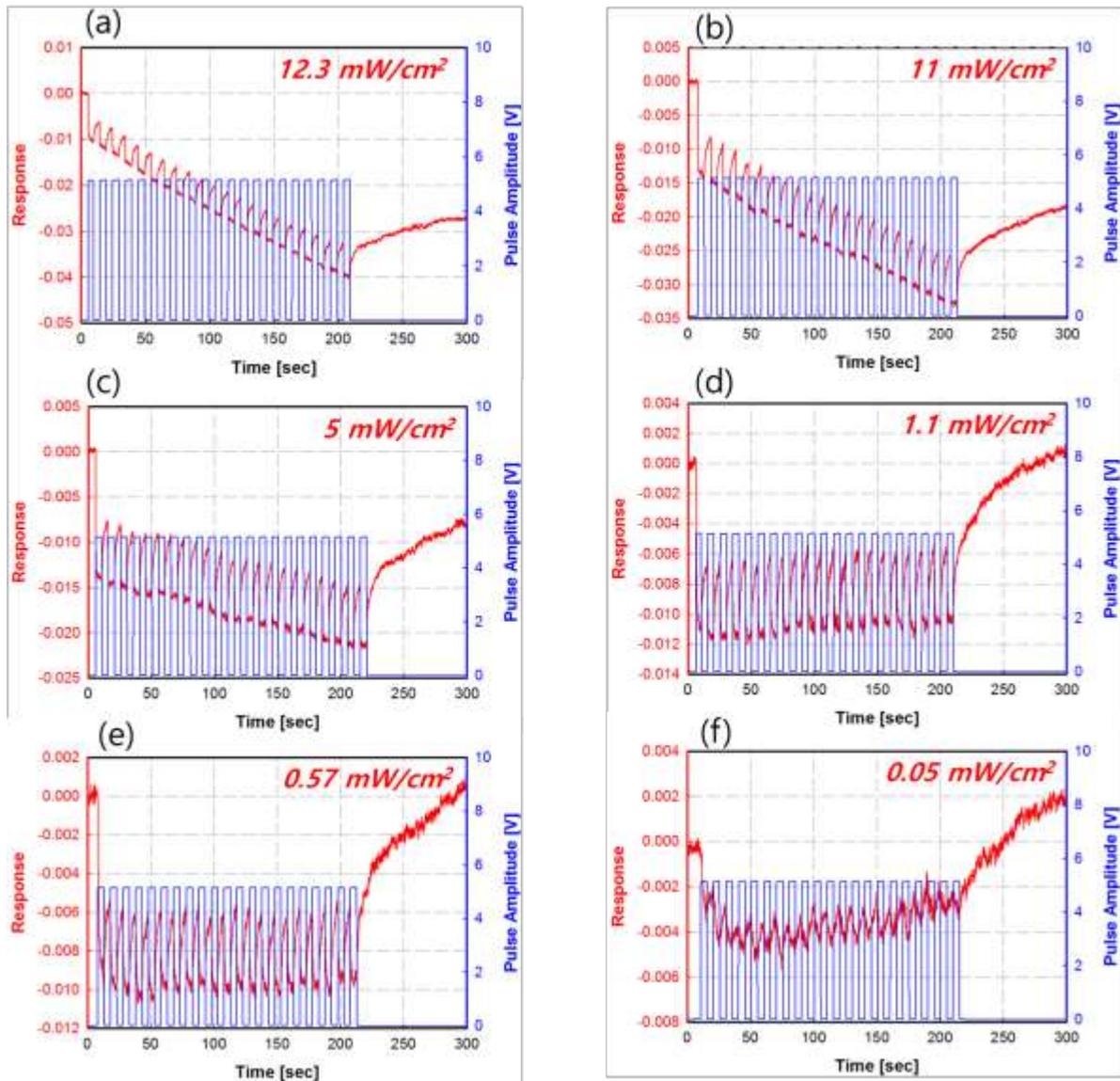


Figure 5.13 Intensity dependency of the inversed response under vacuum (3×10^{-5} mbar). Light intensities vary: (a) 12.3 mW/cm², (b) 11 mW/cm², 5 mW/cm², 1.1 mW/cm², 0.57 mW/cm², 0.05 mW/cm² with 0.1 Hz pulse of the 455 nm.

For the higher light intensities, it is clearly shown that the global device response decrease tends to increase from 0.8 % to 3.2 % as we increase the light intensity from 5 mW/cm² to 12.3 mW/cm² while it doesn't change for the lower light intensities under 1.1 mW/cm² (Figure 5.14.). However, the variation of the response shows exactly the opposite behavior. It saturates at 0.6 % higher light intensities, and decreases for lower light intensities to 0.1 % with 0.05 mW/cm² (Figure 5.14.).

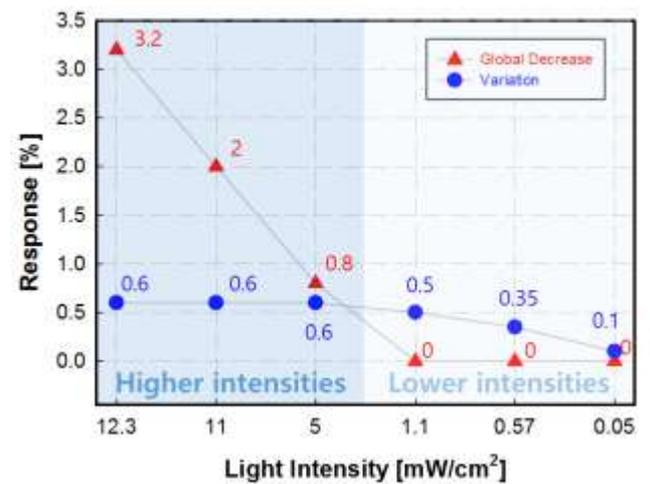


Figure 5.14. Intensity dependency of the double-interface device

5.4.1.2 Duty cycle dependency of the inversed response under vacuum

Figure 5.15. shows the duty cycle dependency of the inversed response of the device. The 455 nm light source with the intensity of 12.3 mW/cm² was controlled by the function generator HM 8130. The light pulse frequency was 0.1 Hz. The duty cycle of the pulse was changed from 2 % to 50 % and the measurement speed was about 1 point per 85 ms.

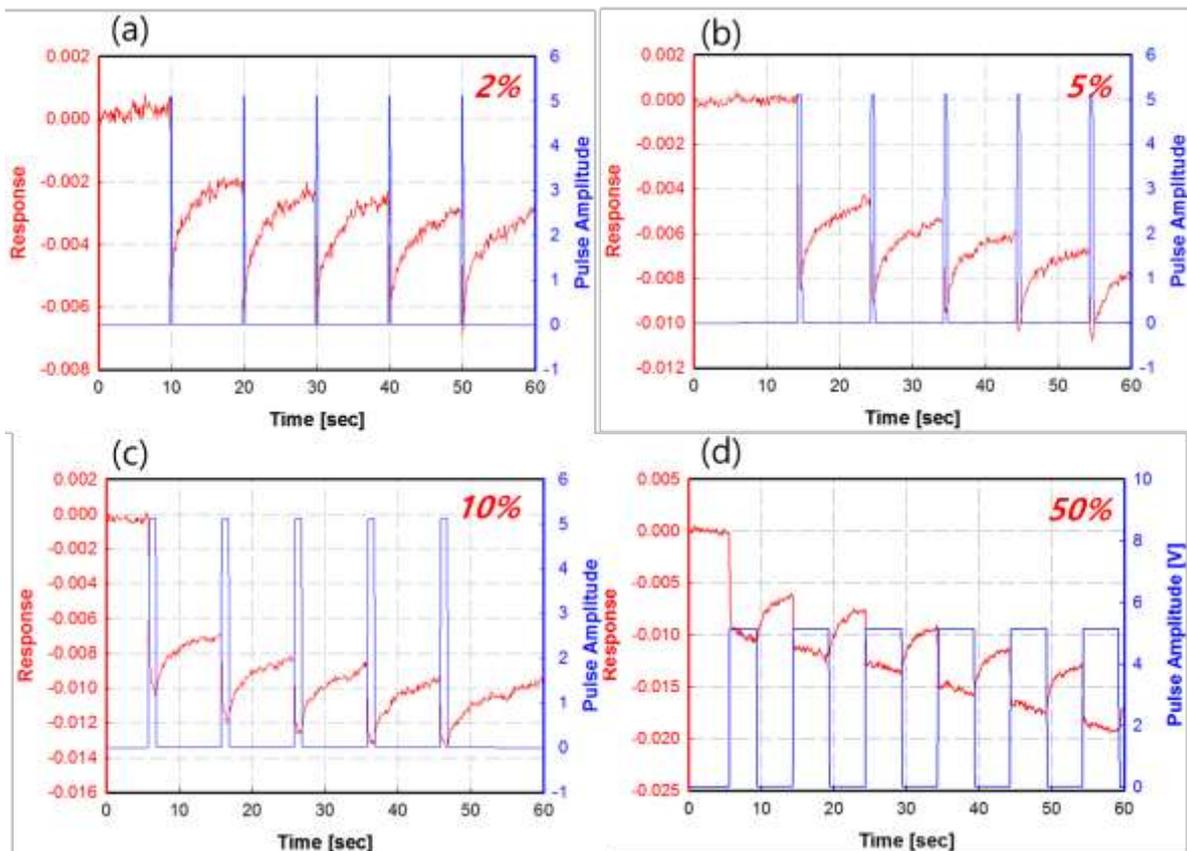


Figure 5.15 Duty cycle dependency of the inversed response under vacuum with the 0.1 Hz, 12.3 mW/cm^2 of the 455 nm light source: (a) 2 %, (b) 5 %, (c) 10 %, (d) 50 %.

Figure 5.16. shows the dependency of the global device decrease and the fast variation. As the results describe, short duty cycle prevents global device response from decreasing while the variation doesn't change by the duty cycle changes. This result is telling us that the prolonged exposure to the light is responsible for the global device response decrease.

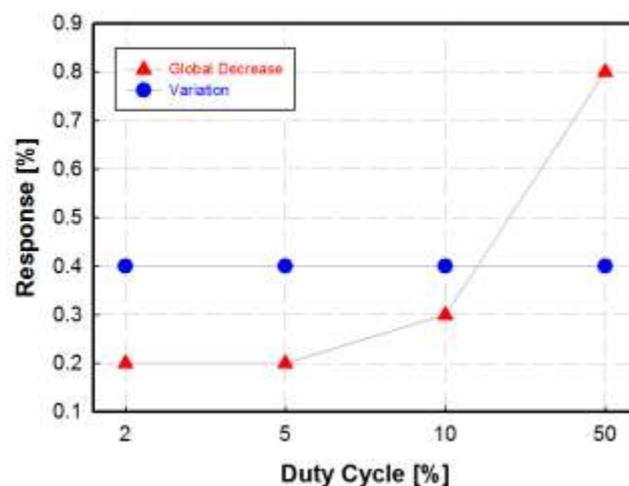


Figure 5.16 Duty cycle dependency of the inversed response under vacuum with the 0.1 Hz, 12.3 mW/cm² of the 455 nm light source.

5.4.2 Charge transfer

To understand the mechanism behind the inversed response of the double-interface device, we tried two more different interfaces by changing the Cr adhesion layer used : Ni and Ti. 10 nm of Ni and Ti layers are deposited onto the functionalized graphene by e-beam evaporation followed by 70 nm of Au metal electrode deposition. After the electrode deposition, the devices were annealed at 150 °C for 90 minutes under vacuum.

Figure 5.17.(a) shows the as-fabricated device response with Ni as an adhesion layer under N₂ condition. The 455 nm light source with the intensity of 12.3 mW/cm² was controlled by the function generator HM 8130. The frequency of 0.1 Hz with the duty cycle of 50 % was applied. The measurement speed was about 1 measuring point per 85 ms. The device response shows both the global device response increase and the step increase as the light is illuminated. The light illumination continued for several hours but no inversion has been observed. The device was exposed to ambient air condition for 3 days and measured again (Figure 5.17.(b)). In the beginning of the measurement, the global device response increases as the light is illuminated and the response stayed the same when the light was turned off (Figure 5.17.(c)). However, no step increase was observed which resembles to the

result observed for the photo-desorption of the water and oxygen molecules. After a while device started to show step decrease upon the light illumination while the global device response increase continues (Figure 5.17.(d)). This result indicates that the adsorbed water and oxygen molecules are playing important role for the device response inversion.

The Figure 5.17.(e,f) shows the response of the device with Ti layer measured under N₂ as-fabricated and 3 days later respectively. The global device response increases for both as-fabricated and 3 days later measurements and the step increase of the response upon the light illumination is also observed. However, even with prolonged measurement, the device with Ti layer didn't show response inversion.

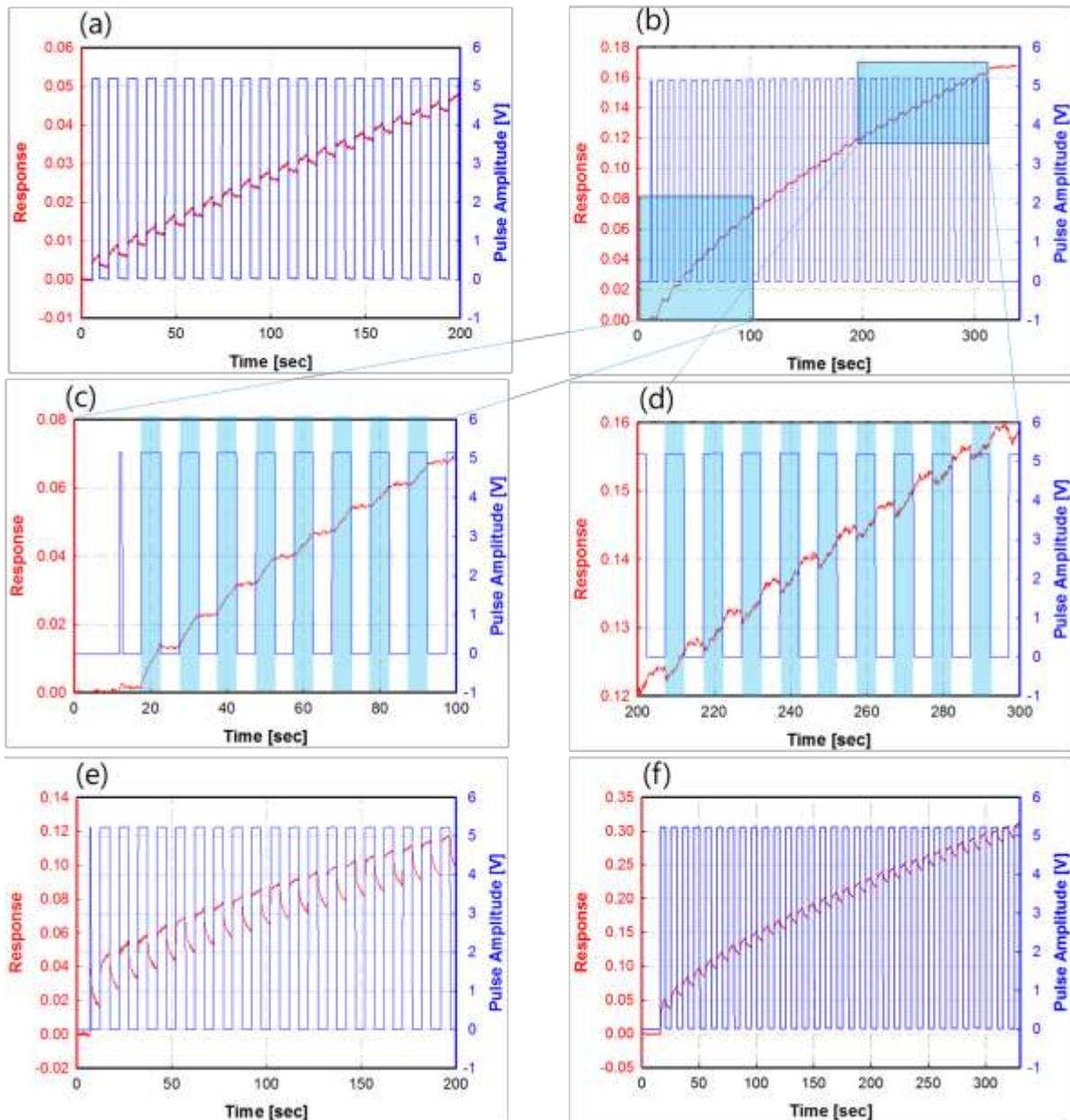


Figure 5.17. Response of the double-interface device with Ni as an adhesion layer for (a) as-fabricated and (b) after 3 days of exposure to an ambient air condition. Zoomed region of (b) for (c) the normal response in the beginning and (d) the inversed response. Response of the double-interface device with Ti as an adhesion layer for (e) as-fabricated and (f) after 3 days. Measurements are carried out under N_2 condition with 0.1 Hz pulse of the 455 nm and 12.3 mW/cm^2 light.

Based on the results shown above, we propose two mechanisms responsible for the response of the double-interface device. One is for explaining the “normal” response and the other is related to the inversed response. Figure 5.18. shows a schematic diagram explaining the normal response of the device under the light before the response inversion regime. For the normal response, the response increases because of two reasons:

- (i) Desorption of water and oxygen molecules
- (ii) Charge transfer from the excited Ru(II) complexes to the graphene

Since the graphene on the SiO₂ substrate is p-doped in ambient conditions, the hole conduction is responsible for the current flowing through the layer. As the water and oxygen molecules desorb from the graphene surface, graphene becomes less p-doped and this translates into the device response increase. This desorption is mainly responsible for the global device response increase which saturates before the response inversion occurs. The second reason relates to the charge transfer from the excited Ru(II) complexes to the graphene. As the electrons traveled to the graphene layer and recombine with the holes, the conductance of the device decreases which in turn increases the device response.

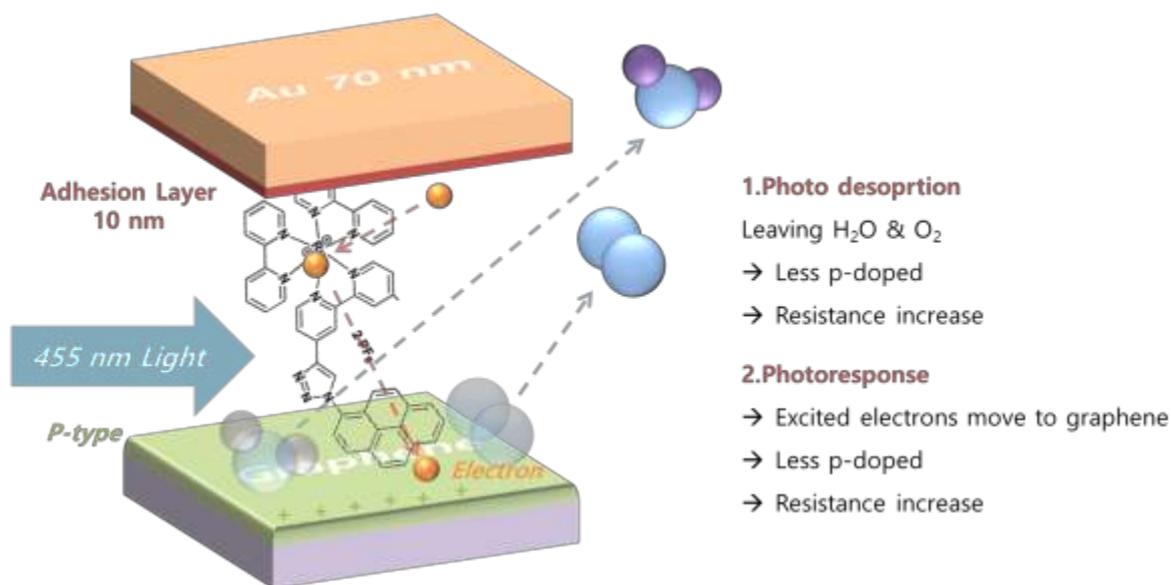


Figure 5.18. Schematic diagram for the normal response of the double-interface device

The schematic diagram for the second mechanism explaining the inversed response of the device is represented in the Figure 5.19.. In this case, the charge transfer is the main reason for the decrease in device response. However, the flow of excited electrons from the Ru(II) complexes travel to the metal electrode rather than to the graphene layer. For this to be happened the adhesion layer must be oxidized. Chromium and Nickel are relatively easy to be oxidized at room temperature in ambient air condition than Titanium [35-38]. Therefore, the response inversion was observable only for the device with Cr and Ni as an adhesion layer but not with Ti. Furthermore, the fact that the response inversion didn't happen for pristine as-fabricated device explains that the adsorbed water and oxygen molecules are necessary for the oxidation of the adhesion layer.

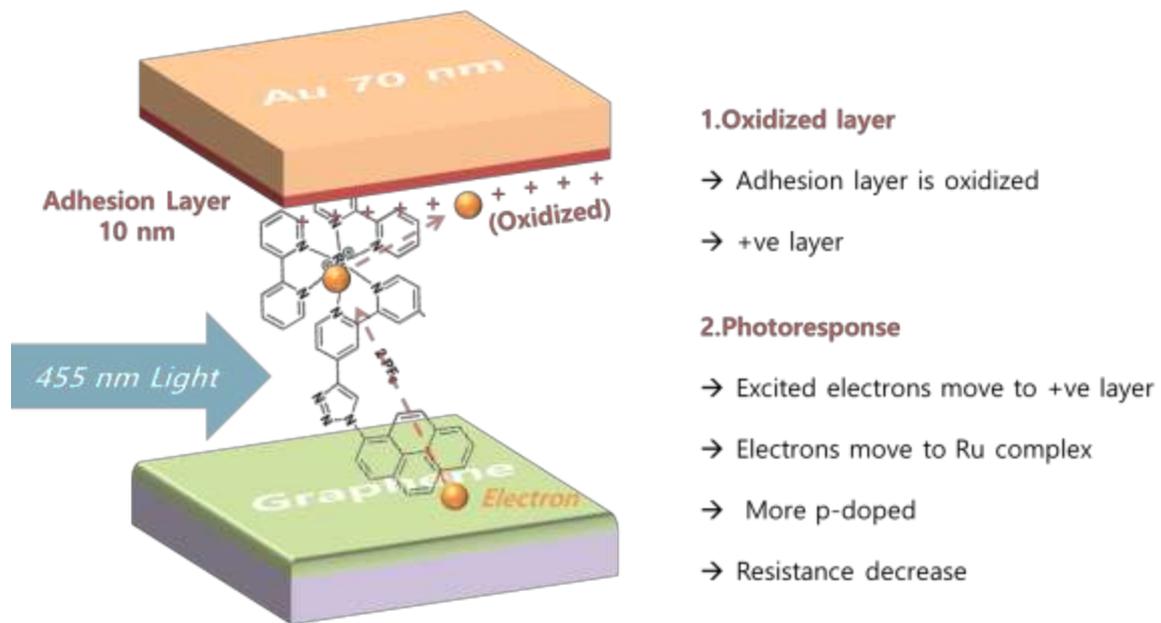


Figure 5.19. Schematic diagram for the normal response of the double-interface device

5.5 Conclusions

In this study, graphene was functionalized with $[\text{Ru}^{\text{II}}\text{-Pyr}]^{2+}$ complex by non-covalent way in order to avoid altering the native electronic structures and preserve the intrinsic properties of graphene. Pyrene moiety has been employed as a linker between the functional molecules and the graphene surface.

Functionalized graphene based resistive sensor was fabricated by functionalizing the device with pre-deposited contact electrodes. The light response of the device has been investigated with the 455 nm blue light. The light response of the functionalized device shows instant increase under the light illumination due to the charge transfer between the complexes and the graphene film that is not observable with non-functionalized device. Electrons transferred from the excited Ru(II) complexes to the graphene film under the light illumination enhanced the response of the device. A slow and global increase in the device response under the light illumination is attributed to the photo-desorption of water and oxygen molecules adsorbed onto the surface.

Double-interface device was fabricated by depositing four identical electrodes on the pre-functionalized graphene surface. The first interface is between the adhesion layer of the metal electrode and the Ru(II) complex while the second interface is between the Ru(II) complex and the graphene layer. The response of the device under the 455 nm blue light illumination is inversed due to the changes in charge transfer flow orientation. In the beginning, the electrons transferred from the excited Ru(II) complexes to the graphene film under the light illumination enhanced the response of the device. However, as the measurement continues, the adhesion layer of the metal electrode is oxidized under the light illumination, and act as an electron acceptor thus the electrons from the excited Ru(II) complexes travel to the oxidized adhesion layer resulting in the inversed response of the device.

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VI. Conclusions & Perspectives

In the present work, functionalized graphene based resistive sensor has been fabricated. The device is based on the single layer graphene on SiO₂ substrate functionalized with Ru(II) complexes. To understand the intrinsic response of the graphene film, non-functionalized device is first investigated. The device response is sensible to the measurement environment such as pressure, relative humidity and light. Once the intrinsic response of the device has been studied, the devices based on the functionalized graphene have been fabricated to further understand the effect of the functionalization. Two different configurations have been used; the device functionalized with complexes after contact electrodes deposition and the device fabricated using the pre-functionalized graphene surface. The device responses under the light illumination have been enhanced or inversed depending on the device configurations. The mechanisms for elucidating these responses have been proposed accounting for the charge transfer between the complexes and the device.

Several type of graphene films have been prepared and characterized. In LPICM, by using home-made triode type PECVD system, graphene is directly synthesized on the insulating substrates. Graphene films synthesized by CVD and transferred to SiO₂ are provided from Thales R&T while epitaxial graphene on SiC is provided from LPN. Commercial graphene samples synthesized by conventional CVD process are also prepared. Most of the performances of graphene based devices rely strongly on its surface conditions. After all the film characterizations, to minimize any unexpected characteristics originating from different surface conditions, the simplest film or single layer graphene on SiO₂ substrate is eventually chosen as a main material used in the fabrication of the device.

Deposition of the electrodes on the graphene surface is the second step of the device fabrication process. Three different approaches have been explored; inkjet-printing, photo-lithography and shadow-mask evaporation. Because of its complexity and possible contaminations through the process, photo-lithography is ruled out. Ink-jet printing promises a simple low-cost process, but the restricted choice in metals is not favorable for the device fabrication. Hence the shadow-mask metal evaporation is mainly used as an electrodes deposition method in this work. With a simple shadow mask, Ni, Co, Cr/Au, Ni/Au and Ti/Au electrodes have been successfully deposited on the prepared graphene surface. The

optimization of electrodes deposition may be an interesting issue in terms of device fabrication. For example, the shape and the size of the electrodes and the choice of metal are possible options to be optimized. Although CVD graphene promises the large surface area for the mass production of devices, it is polycrystalline in nature and thus grain boundaries disturb the charge transport. In addition, surface contaminations through the process are also detrimental to the charge transport of the graphene film. In the present work, for averaging out such unfavorable limited charge transport, the electrodes with 100 μm gap which exceeds general grain size of few micrometers are realized. Further optimization of the device electrodes have to be extensively investigated.

The response of the device is characterized by measuring the device resistance. The concept of the conventional four-probe measurement is extended to account for the shape of the device electrodes and to characterize the device more precisely. The device resistance is monitored as a function of time in order that any external condition changes can be directly detected and interpreted on the plot. The response of the device is simply expressed as the changes in device resistance, $\Delta R/R_0$.

Intrinsic response of the device is studied. The device response changes upon the adsorption/desorption of water and oxygen molecules. Desorption of these molecules under the pressure of 10^{-5} mbar vacuum condition caused more than 6 % increase in response. This is due to the de-doping of the graphene film resulting in the device resistance increase. Desorption of water and oxygen molecules can be further accelerated under the illumination of the 455 nm blue light with intensity of 4 mW/cm^2 . In this case the device response increases up to 40 %. As the results show that the adsorption/desorption of water and oxygen molecules cause appreciable changes in device response, one can easily expect that the device response changes upon the relative humidity level changes. As expected, the device response decreases as the humidity level increases because of the enhanced p-doping via adsorption of water molecules. However, the humidity response inversed after the vacuum annealing of the device at 150 $^{\circ}\text{C}$ for 90 minutes. Based on the results from various PES techniques a mechanisms responsible for two different humidity responses is proposed. Adsorption of water molecules on the graphene surface and the hydrogen bonds between the water molecules and the remaining functional groups on the graphene film are two competing

factors responsible for elucidating the mechanism. The studies on the intrinsic response of the device provide a preliminary understanding of the graphene based gas sensing device. It is worth noting that the effects of ambient air have to be taken into account before characterizing the gas sensing behavior of the device.

The resistive sensor based on the graphene film functionalized with $[\text{Ru}^{\text{II}}\text{-Pyr}]^{2+}$ complex by non-covalent way has been fabricated. Non-covalent functionalization process is developed in order to avoid altering the native electronic structures and preserve the intrinsic properties of graphene. The enhanced and fast light response of the device that is not observable with non-functionalized device has been obtained with the 455 nm blue light. Electrons flow transferred from the excited Ru(II) complexes to the graphene film under the light illumination enhanced the response of the device while the photo-desorption of water and oxygen molecules adsorbed onto the surface is responsible for a slow and global increase in the device response.

The inversion of the photoresponse was observed with a double-interface device which is fabricated by depositing four identical electrodes on the pre-functionalized graphene surface. The first interface is between the adhesion layer of the metal electrode and the Ru(II) complex while the second interface is between the Ru(II) complex and the graphene layer. The proposed mechanism responsible for the response inversion is based on the changes in the charge transfer flow orientation. In the beginning, the electrons are transferred from the excited Ru(II) complexes to the graphene film whilst they traveled to towards the oxidized adhesion layer after continued measurement under the light illumination.

The main goal of this thesis is to fabricate a low-cost selective gas sensor based on the functionalized graphene. Although it was not possible to validated all the steps required to realize such low-cost selective gas sensor using functionalized graphene. The presented work has demonstrated that the graphene based device can be well functionalized with Ru(II) complex in non-covalent way. Remaining works will be dedicated to fabricate a functionalized graphene based gas sensor which enables specific type of gas molecules to interact in a specific way with each functionalizing complex, changing in a specific way the graphene resistivity thus acting as fingerprinting for identifying the targeted gases.

To conclude, the theoretical and experimental approaches and the results obtained during this thesis are opening up a way to understand and fabricate future gas sensing devices based on the non-covalently functionalized graphene.

Titre : Un capteur de gaz sélectif et bas coût par l'emploi de graphène fonctionnalisé

Mots clés : nanotechnologie, graphène, capteur de gaz

Résumé : Les progrès récents dans les nanomatériaux présentent un fort potentiel pour la réalisation de capteurs de gaz avec de nombreux avantages tels que : la grande sensibilité de détection de molécule unique, le faible coût et la faible consommation d'énergie. Le graphène, isolé en 2004, est l'un des meilleurs candidats prometteurs pour le développement de futurs nanocapteurs en raison de sa structure à deux dimensions, sa conductivité élevée et sa grande surface spécifique. Chaque atome de la monocouche de graphène peut être considéré comme un atome de surface, capable d'interagir même avec une seule molécule de l'espèce gazeuse ou de vapeur cible, ce qui conduit finalement à un capteur ultrasensible. Dans cette thèse, des composants à base de graphène ont été fabriqués et caractérisés. Les films de graphène ont été synthétisés par dépôt chimique à phase vapeur (CVD) sur des substrats de verre. La spectroscopie Raman a été utilisée pour analyser la qualité et le nombre de couches de graphène. La microscopie à force atomique (AFM) et la microscopie électronique à balayage (MEB) ont été également réalisées pour analyser la qualité du graphène.

Après la caractérisation de couches de graphène, des dispositifs résistifs à base de graphène ont été fabriqués : quatre électrodes identiques ont été évaporées thermiquement et directement sur le film de graphène comme des électrodes métalliques. La caractérisation électrique a été réalisée à l'aide de Keithley-4200. La réponse de dispositif Intrinsèque a été étudiée sous différents conditions (pression, humidité, exposition à la lumière). Le dispositif a été fonctionnalisé de manière non covalente avec le complexe organométallique (Ru (II) trisbipyridine) et son effet sous exposition à la lumière a été étudié. La réponse de dispositif était reproductible même après de nombreux cycles en présence et en absence de la lumière. Les approches théoriques et expérimentales ainsi que les résultats obtenus au cours de cette thèse ouvrent un moyen de comprendre et de fabriquer des futurs dispositifs de détection de gaz à base du graphène fonctionnalisé de manière non covalente.

Title : A selective and low cost gas sensor based on functionalized graphene

Keywords : nanotechnology, graphene, gas sensor

Abstract : Recent advances in nanomaterials provided a strong potential to create gas sensors with many advantages such as high sensitivity to single molecule detection, low cost, and low power consumption. Graphene, isolated in 2004, is one of the best promising candidate for the future development of nanosensors applications because of its atom-thick, two-dimensional structures, high conductivity, and large specific surface areas. Every atom of a monolayer graphene can be considered as a surface atom, capable of interacting even with a single molecule of the target gas or vapor species, which eventually results in the ultrasensitive sensor response. In this thesis work, graphene devices have been made and characterized. Graphene films were synthesized by Chemical Vapor Deposition (CVD) on a glass substrate. Raman spectroscopy was used to analyze the quality and number of layers of graphene. Atomic Force Microscope (AFM) and Scanning Electron Microscopy (SEM) were also performed to analyze the quality of the graphene.

After the characterization of the graphene films, graphene based resistive devices were fabricated: four identical electrodes are thermally evaporated directly onto the graphene film as metal electrodes. The electrical characterization has been carried out by using Keithley-4200. Intrinsic response of the graphene devices was studied under different external conditions (pressure, humidity, light illumination). The device was non-covalently functionalized with organometallic complex (Ru(II) trisbipyridine) and its light exposure response was studied. The observed device response was reproducible and similar after many cycles of on and off operations. The theoretical and experimental approaches and the results obtained during the thesis are opening up a way to understand and fabricate future gas sensing devices based on the non-covalently functionalized graphene.